Microsemi®

ZL30244, ZL30245

Dual-Channel Any-to-Any Clock Multiplier and Frequency Synthesizer ICs

Data Sheet

April 2016

Features

- **Two Independent APLL Channels**

- **Four Input Clocks Per Channel**

  - One crystal/CMOS input

  - Two differential/CMOS inputs

  - One single-ended/CMOS input

  - Any input frequency from 9.72MHz to 1250MHz (9.72MHz to 300MHz for CMOS)

  - Clock selection by pin or register control

- **Low-Jitter Fractional-N APLL and 3 Outputs Per Channel**

  - Any output frequency from <1Hz to 1035MHz

  - High-resolution fractional frequency conversion with 0ppm error

  - Easy-to-configure, encapsulated design requires no external VCXO or loop filter components

  - Each output has independent dividers

  - Output jitter as low as 0.16ps RMS (12kHz-20MHz integration band)

  - Outputs are CML or 2xCMOS, can interface to LVDS, LVPECL, HSTL, SSTL and HCSL

  - In 2xCMOS mode, the P and N pins can be different frequencies (e.g. 125MHz and 25MHz)

  - Per-output supply pin with CMOS output voltages from 1.5V to 3.3V

- Precise output alignment circuitry and per-output phase adjustment

- Per-output enable/disable and glitchless start/stop (stop high or low)

- **General Features**

  - Automatic self-configuration at power-up from external (ZL30244) or internal (ZL30245) EEPROM; up to four configs, pin-selectable

  - SPI or I^{2}C processor Interface

  - Numerically controlled oscillator mode

  - Spread-spectrum modulation mode

  - Space-saving 5x10mm LGA package

  - Easy-to-use evaluation software

Applications

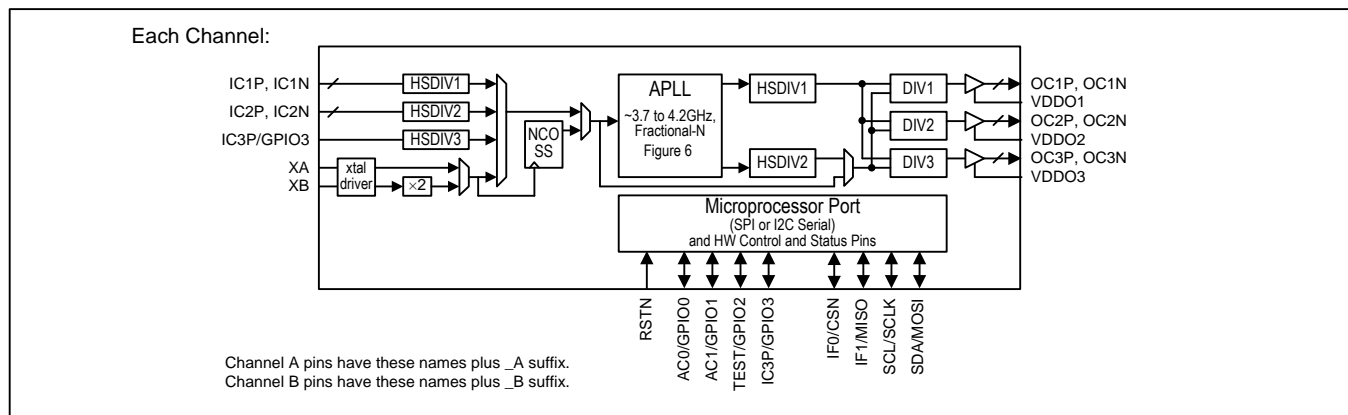- Frequency conversion and frequency synthesis in a wide variety of equipment types

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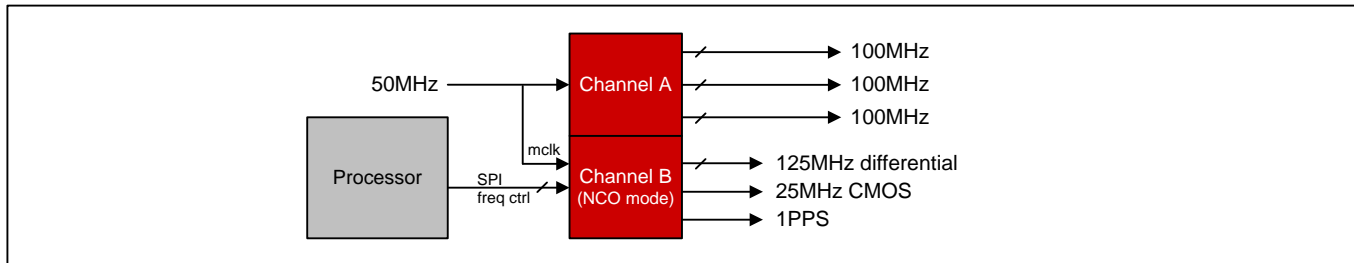
Figure 3 - PCI Express Clock Synthesis and NCO for IEEE1588 Slave Clock

2. Detailed Features

2.1 Input Clock Features
- Four input clocks per channel: one crystal/CMOS, two differential/CMOS, one single-ended/CMOS
- Input clocks can be any frequency from 9.72MHz up to 1250MHz (differential) or 300MHz (CMOS)

2.2 APLL Features
- APLL with very high-resolution fractional (i.e. non-integer) multiplication per channel
- Any-to-any frequency conversion with 0ppm error
- Two high-speed dividers per channel (integers 4 to 15, half divides 4.5 to 7.5)
- Easy-to-configure, completely encapsulated design requires no external VCXO or loop filter components
- Bypass mode supports system testing

2.3 Output Clock Features
- Three low-jitter output clocks per channel
- Each output can be one differential output or two CMOS outputs
- Output clocks can be any frequency from 1Hz to 1035MHz (250MHz max for CMOS and HSTL outputs)
- Output jitter as low as 0.16ps RMS (12kHz to 20MHz integration band)
- In CMOS mode, an additional divider allows the OCxN pin to be an integer divisor of the OCxP pin (example: OC3P 125MHz, OC3N 25MHz)
- Outputs easily interface with CML, LVDS, LVPECL, HSTL, SSTL, HCSL and CMOS components
- Supported telecom frequencies include PDH, SDH, Synchronous Ethernet, OTN
- Can produce clock frequencies for microprocessors, ASICs, FPGAs and other components
- Can produce PCIe clocks (PCIe gen. 1, 2 and 3)
- Sophisticated output-to-output phase alignment (among outputs in the same channel)
- Per-output phase adjustment with high resolution and unlimited range
- Per-output enable/disable
- Per-output glitchless start/stop (stop high or low)

2.4 General Features
- SPI or I²C serial microprocessor interface per channel

- Automatic self-configuration at power-up from external (ZL30244) or internal (ZL30245) EEPROM memory; pin control to specify one of four stored configurations
- Each channel can be configured for numerically controlled oscillator (NCO) mode, which allows system software to steer frequency with resolution better than 0.01ppb
- Each channel can be configured for pread-spectrum modulation mode (meets PCI Express requirements)
- Four general-purpose I/O pins per channel, each with many possible status and control options
- Each channel's reference clock can be fundamental-mode crystal, low-cost XO or clock signal from elsewhere in the system

2.5 Evaluation Software

- Simple, intuitive Windows-based graphical user interface
- Supports all device features and register fields
- Makes lab evaluation of the ZL30244 or ZL30245 quick and easy
- Generates configuration scripts to be stored in external (ZL30244) or internal (ZL30245) EEPROM
- Generates full or partial configuration scripts to be run on a system processor
- Works with or without a ZL30244 or ZL30245 evaluation board

3. Pin Diagram

The device is packaged in a 5x10mm 64-pin LGA package.
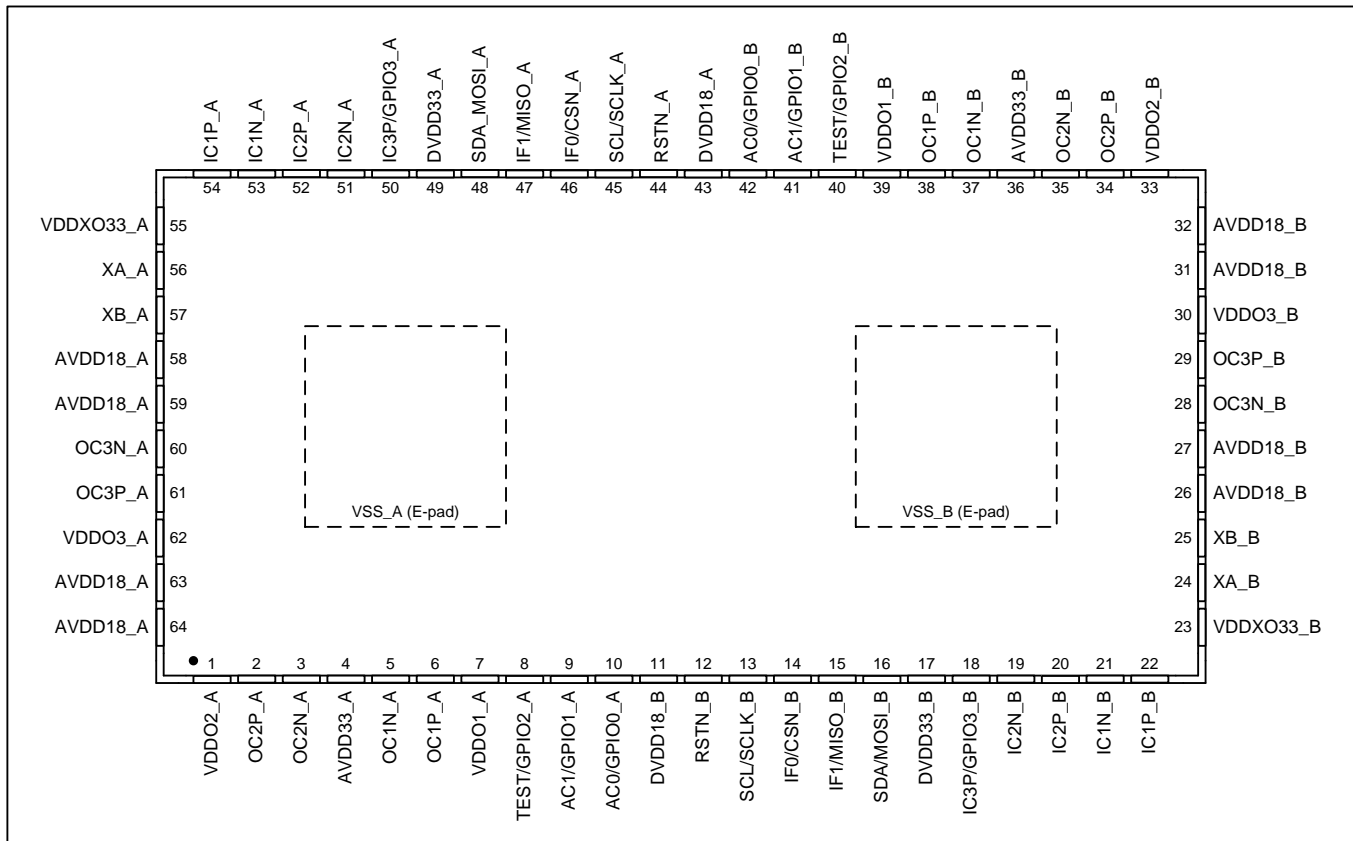
Figure 4 - Pin Diagram

4. Pin Descriptions

Channel A pins names have "_A" suffix. Channel B pin names have "_B" suffix. All inputs and outputs are LVCMOS unless described otherwise. The Type column uses the following symbols: I – input, I_{PU} – input with 50kΩ internal pullup resistor, O – output, A – analog, P – power supply pin. All GPIO and SPI/I^{2}C interface pins have Schmitt-trigger inputs and have output drivers that can be disabled (high impedance).

Table 1 - Pin Descriptions

Pin #	Name	Type	Description
54 53 52 51 50 22 21 20 19 18	IC1P_A IC1N_A IC2P_A IC2N_A IC3P/GPIO3_A IC1P_B IC1N_B IC2P_B IC2N_B IC3P/GPIO3_B	I I I I I/O I I I I I/O	**Input Clock Pins** Differential or Single-ended signal format. Programmable frequency. *Differential:* See Table 9 for electrical specifications, and see Figure 16 for recommended external circuitry for interfacing these differential inputs to LVDS, LVPECL, CML or HSCL output pins on neighboring devices. *Single-ended:* For input signal amplitude >2.5V, connect the signal directly to ICxP pin. For input signal amplitude ≤2.5V, AC-coupling the signal to ICxP is recommended. Connect the N pin to a capacitor (0.1μF or 0.01μF) to VSS. As shown in Figure 16, the ICxP and ICxN pins are internally biased to approximately 1.3V. Treat the ICxN pin as a sensitive node; minimize stubs; do not connect to anything else including other ICxN pins. *Unused:* Set ICEN.ICxEN=0. The ICxP and ICxN pins can be left floating. Note that the IC3N pin is not bonded out. A differential signal can be connected to IC3P by AC-coupling the POS trace to IC3P and terminating the signal on the driver side of the coupling cap. If not needed as an input clock pin, IC3P can behave as general-purpose I/O pin GPIO3, which is configured by GPIOCR2. Its state is indicated in GPIOSR.
56 57 24 25	XA_A XB_A XA_B XB_B	A / I	**Crystal or Input Clock Pins** *Crystal:* MCR1.XAB=01. An on-chip crystal driver circuit is designed to work with an external crystal connected to the XA and XB pins. See section 5.4.2 for crystal characteristics and recommended external components. *Input Clock:* MCR1.XAB=10. An external local oscillator or clock signal can be connected to the XA pin. The XB pin must be left unconnected.
6 5 2 3 61 60 38 37 34 35 29 28	OC1P_A OC1N_A OC2P_A OC2N_A OC3P_A OC3N_A OC1P_B OC1N_B OC2P_B OC2N_B OC3P_B OC3N_B	O	**Output Clock Pins** CML, HSTL or 1 or 2 CMOS. Programmable frequency and drive strength. See Table 10 and Figure 18 for electrical specifications and recommended external circuitry for interfacing to LVDS, LVPECL or CML input pins on neighboring devices. See Table 11 for electrical specifications for interfacing to CMOS and HSTL inputs on neighboring devices. See Figure 19 for recommended external circuitry for interfacing to HCSL inputs on neighboring devices.
44 12	RSTN_A RSTN_B	I_{PU}	**Reset (Active Low)** When this global asynchronous reset is pulled low, all of the channel's internal circuitry is reset to default values. The channel is held in reset as long as RSTN is low. See section 5.11.

Table 1 - Pin Descriptions (continued)

Pin #	Name	Type	Description
10 9 42 41	AC0/GPIO0_A AC1/GPIO1_A AC0/GPIO0_B AC1/GPIO1_B	I/O	**Auto-Configure [1:0] / General Purpose I/O 0 and 1** *Auto Configure:* On the rising edge of RSTN these pins behave as AC[1:0] and specify one of the configurations stored in EEPROM. See section 5.3. *General-Purpose I/O:* After reset these pins are GPIO0 and GPIO1. GPIOCR1 configures the pins. Their states are indicated in GPIOSR.
8 40	TEST/GPIO2_ A TEST/GPIO2_ B	I/O	**Factory Test / General Purpose I/O 2** *Factory Test:* On the rising edge of RSTN the pin behaves as TEST. Factory test mode is enabled when TEST is high. For normal operation TEST must be low on the rising edge of RSTN. *General-Purpose I/O:* After reset this pin is GPIO2. GPIOCR2 configures the pin. It state is indicated in GPIOSR.
46 14	IF0/CSN_A IF0/CSN_B	I/O	**Interface Mode 0 / SPI Chip Select (Active Low)** *Interface Mode:* On the rising edge of RSTN the pin behaves as IF0 and, together with IF1, specifies the interface mode for the channel. See section 5.3. *SPI Chip Select:* After reset this pin is CSN. When the channel is configured as a SPI slave, an external SPI master must assert (low) CSN to access channel registers. When the channel is configured as a SPI master (ZL30244 only), the channel asserts CSN to access an external SPI EEPROM during auto-configuration.
45 13	SCL/SCLK_A SCL/SCLK_B	I/O	**I²C Clock / SPI Clock** *I²C Clock:* When the channel is configured as an I²C slave, an external I²C master must provide the I²C clock signal on the SCL pin. *SPI Clock:* When the channel is configured as a SPI slave, an external SPI master must provide the SPI clock signal on SCLK. When the channel is configured as a SPI master(ZL30244 only), the channel drives SCLK as an output to clock accesses to an external SPI EEPROM during auto-configuration.
47 15	IF1/MISO_A IF1/MISO_B	I/O	**Interface Mode 1 / SPI Master-In-Slave-Out** *Interface Mode:* On the rising edge of RSTN the pin behaves as IF1 and, together with IF0, specifies the interface mode for the channel. See section 5.3. *SPI MISO:* After reset this pin is MISO. When the channel is configured as a SPI slave, the channel outputs data to an external SPI master on MISO during SPI read transactions. When the channel is configured as a SPI master (ZL30244 only), the channel receives data on MISO from an external SPI EEPROM during auto-configuration.

Table 1 - Pin Descriptions (continued)

Pin #	Name	Type	Description
48 16	SDA/MOSI_A SDA/MOSI_B	I/O	**I²C Data / SPI Master-Out-Slave-In** *I²C Data:* When the channel is configured as an I²C slave, SDA is the bidirectional data line between the channel and an external I²C master. *SPI MOSI:* When the channel is configured as a SPI slave, an external SPI master sends commands, addresses and data to the channel on MOSI. When the channel is configured as a SPI master (ZL30244 only), the channel sends commands, addresses and data on MOSI to an external SPI EEPROM during auto-configuration.
58, 59, 63, 64 26, 27, 31, 32	AVDD18_A AVDD18_B	P	**Analog Power Supply.** 1.8V ±5%.
4 36	AVDD33_A AVDD33_B	P	**Analog Power Supply.** 3.3V ±5%.
43 11	DVDD18_A DVDD18_B	P	**Digital Power Supply.** 1.8V ±5%.
49 17	DVDD33_A DVDD33_B	P	**Digital Power Supply.** 3.3V ±5%.
7	VDDO1_A	P	**Output OC1_A Power Supply.** 1.5V to 3.3V ±5%.
1	VDDO2_A	P	**Output OC2_A Power Supply.** 1.5V to 3.3V ±5%.
62	VDDO3_A	P	**Output OC3_A Power Supply.** 1.5V to 3.3V ±5%.
39	VDDO1_B	P	**Output OC1_B Power Supply.** 1.5V to 3.3V ±5%.
33	VDDO2_B	P	**Output OC2_B Power Supply.** 1.5V to 3.3V ±5%.
30	VDDO3_B	P	**Output OC3_B Power Supply.** 1.5V to 3.3V ±5%.
55	VDDXO33_A	P	**Analog Power Supply for channel A Crystal Driver Circuitry.** 3.3V ±5%.
23	VDDXO33_B	P	**Analog Power Supply for channel B Crystal Driver Circuitry.** 3.3V ±5%.
E-pad	VSS_A	P	**Ground.** 0 Volts. For channel A.
E-pad	VSS_B	P	**Ground.** 0 Volts. For channel B.

5. Functional Description

5.1 Overview: Two Completely Independent Channels

The device is composed of two identical but completely independent *channels*, A and B. Each channel has its own independent set of pins: input clocks, output clocks, SPI/I²C interface, GPIO, reset and power supply pins. The two channels have identical pin lists except channel A pin names end with "_A" while channel B pins names end with "_B". Most of this data sheet uses pin names without these "_A" and "_B" endings, for example mentioning the TEST/GPIO2 pin rather than channel A's TEST/GPIO2_A pin or channel B's TEST/GPIO2_B pin. In this document any mention of a pin name without a channel suffix should be understood to apply to that pin in both channels.

The two channels also have identical register maps (shown in section 6.2). Channel A's registers are only accessible through channel A's SPI/I²C interface, and channel B's registers are only accessible through channel B's SPI/I²C interface. Each channel's register map starts at address 0.

Since the two channels are completely independent, they can be reset independently and configured independently. For example channel A can be configured for regular APLL-only operation with the APLL locked to channel A's IC1 input while channel B is configured for NCO mode where its output frequency is dynamically controlled by system software (see Figure 3).

5.2 Device Identification

The 12-bit read-only ID field and the 4-bit revision field are found in each channel's ID1 and ID2 registers. Contact the factory to interpret the revision value and determine the latest revision.

5.3 Pin-Controlled Automatic Configuration at Reset

The channel configuration is determined at reset (i.e. on the rising edge of RSTN) by the signal levels on five channel pins: TEST/GPIO2, AC1/GPIO1, AC0/GPIO0, IF1/MISO and IF0/CSN. For these pins, the first name (TEST, AC1, AC0, IF1, IF0) indicates their function when they are sampled by the rising edge of the RSTN pin. The second name refers to their function after reset. The values of these pins are latched into the CFGSR register when RSTN goes high. To ensure the device properly samples the reset values of these pins, the following guidelines should be followed:

1. Any pullup or pulldown resistors used to set the value of these pins at reset should be 1kΩ.
2. RSTN must be asserted at least as long as specified in section 5.11.

The hardware configuration pins are grouped into three sets:

1. TEST - Manufacturing test mode
2. IF[1:0] – Microprocessor interface mode and I^2C address
3. AC[1:0] – Auto-configuration from EEPROM

The TEST pin selects manufacturing test modes when TEST=1 (the AC[1:0] pins specify the test mode). For ZL30245, TEST=1 and AC[1:0]=00 configures the channel so that production SPI EEPROM programmers can program the internal EEPROM (see section 5.13.2). For more information about auto-configuration from EEPROM see section 5.13.

5.3.1 ZL30244—External EEPROM or No EEPROM

For the ZL30244 each channel's IF[1:0] pins specify the processor interface mode and the I^2C slave address. When IF[1:0]=11 (SPI) two options are available:

If AC[1:0]=00 the channel sets up its processor interface as SPI slave through which it can be configured by software running on the SPI master. In this option the channel cannot auto-configure from an external EEPROM, but the channels can have their SCLK, MISO and MOSI pins connected to the same SPI bus wires (CSN pins must be separate wires).

If AC[1:0]=01, 10, or 11 the channel first sets up its processor interface as a SPI master. It then auto-configures itself by reading the configuration number specified by AC[1:0] from an external SPI EEPROM connected to its SPI pins. After auto-configuration is complete, the channel reconfigures its processor interface to be SPI slave. Note that a separate SPI EEPROM is needed for each channel if both channels auto-configure this way.

These options are summarized in the following table:

IF1	IF0	AC1	AC0	Processor Interface	External EEPROM	Auto Configuration
0	0	0	0	I^2C, channel A slave address 10010 00 channel B slave address 10011 00	No	n/a
0	1	0	0	I^2C, channel A slave address 10010 01 channel B slave address 10011 01	No	n/a
1	0	0	0	I^2C, channel A slave address 10010 10 channel B slave address 10011 10	No	n/a
1	1	0	0	SPI Slave	No	n/a
1	1	0	1	SPI Master to external EEPROM for auto-configuration then SPI Slave	Yes	Configuration 1
1	1	1	0		Yes	Configuration 2
1	1	1	1		Yes	Configuration 3

Notes about auto-configuring from external EEPROM:

1. The channel's CSN pin must have a pull-up resistor to VDD to ensure its processor interface is inactive after auto-configuration is complete. The SCLK, MISO and MOSI pins should also have pull-up resistors to VDD to keep them from floating.

2. If a processor or similar device will access channel registers after the channel has auto-configured from external EEPROM, the SPI SCLK, MOSI and MISO wires can be connected directly to the processor, the channel and the external EEPROM. The processor and channel CSN pins can be wired together also. The EEPROM CSN signal must be controlled by the channel's CSN pin during channel auto-configuration and then held inactive when the processor accesses channel registers.

5.3.2 ZL30245—Internal EEPROM

For the ZL30245 each channel's IF[1:0] pins specify the processor interface mode and the I^2C slave address. The AC[1:0] pins specify which of four configurations in the EEPROM to execute after reset.

IF1	IF0	Processor Interface
0	0	I^2C, channel A slave address 10010 00 channel B slave address 10011 00
0	1	I^2C, channel A slave address 10010 01 channel B slave address 10011 01
1	0	I^2C, channel A slave address 10010 10 channel B slave address 10011 10
1	1	SPI Slave

AC1	AC0	Auto Configuration
0	0	Configuration 0
0	1	Configuration 1
1	0	Configuration 2
1	1	Configuration 3

5.4 Local Oscillator or Crystal

Section 5.4.1 describes how to connect an external oscillator to a channel and the required characteristics of the oscillator. Section 5.4.2 describes how to connect an external crystal to a channel's on-chip crystal driver circuit and the required characteristics of the crystal. The channels can both be provided with the same oscillator signal, but the channels cannot share a crystal.

5.4.1 External Oscillator

A signal from an external oscillator can be connected to a channel's XA pin (XB must be left unconnected). Table 8 specifies the range of possible frequencies for the XA input. To minimize jitter, the signal must be properly terminated and must have very short trace length. A poorly terminated single-ended signal can greatly increase output jitter, and long single-ended trace lengths are more susceptible to noise. To connect one oscillator to both channels' XA pins, Microsemi recommends two identical, equal-length routes with identical source-series resistors of 20-30Ω. When MCR1.XAB=10, XA is enabled as a single-ended input.

While the stability of the external oscillator can be important, its absolute frequency accuracy is less important because any known frequency inaccuracy of the oscillator can be compensated. When a channel is configured for NCO or spread-spectrum operation, the DFREQZ parameter can be used to compensate for oscillator frequency error. When a channel is configured for APLL-only mode, the APLL's fractional feedback divider value (AFBDIV) can be adjusted by ppb or ppm to compensate for oscillator frequency error.

The jitter on output clock signals depends on the phase noise and frequency of the external oscillator. For a channel to operate with the lowest possible output jitter, its external oscillator should have the following characteristics:

- Phase Jitter: less than 0.1ps RMS over the 12kHz to 5MHz integration band

- Frequency: The higher the better, all else being equal

5.4.2 External Crystal and On-Chip Driver Circuit

Each channel's on-chip crystal driver circuit is designed to work with a <u>fundamental mode, AT-cut</u> crystal resonator. See Table 2 for recommended crystal specifications. To enable the crystal driver, set MCR1.XAB=01.

See Figure 5 for the crystal equivalent circuit and the recommended external capacitor connections. To achieve a crystal load (C_L) of 10pF, an external 16pF is placed in parallel with the 4pF internal capacitance of the XA pin, and an external 16pF is placed in parallel with the 4pF internal capacitance of the XB pin. The crystal then sees a load of 20pF in series with 20pF, which is 10pF total load. Note that the 16pF capacitance values in Figure 5 include all capacitance on those nodes. If, for example, PCB trace capacitance between crystal pin and IC pin is 2pF then 14pF capacitors should be used to make 16pF total.

The crystal, traces, and two external capacitors should be placed on the board as close as possible to the XA and XB pins to reduce crosstalk of active signals into the oscillator. Also no active signals should be routed under the crystal circuitry.

Note: Crystals have temperature sensitivies that can cause frequency changes in response to ambient temperature changes. In applications where significant temperature changes are expected near the crystal, it is recommended that the crystal be covered with a thermal cap, or an external XO or TCXO should be used instead.
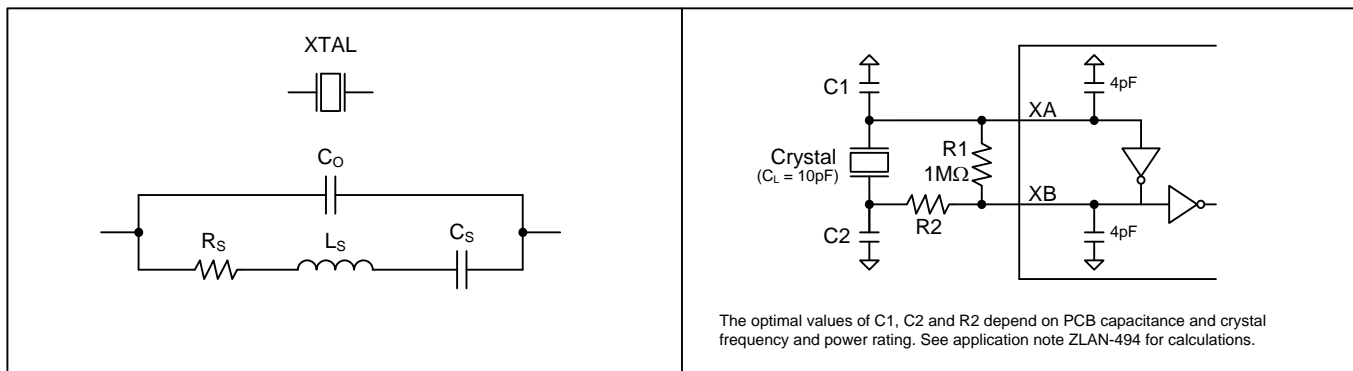
Figure 5 - Crystal Equivalent Circuit / Recommended Crystal Circuit

Table 2 - Crystal Selection Parameters

Parameter		Symbol	Min.	Typ.	Max.	Units
Crystal oscillation frequency[1]		f_{OSC}	25		60	MHz
Shunt capacitance		C_O		2	5	pF
Load capacitance		C_L		10		pF
Equivalent series resistance (ESR)[2]	f_{OSC} < 40MHz	R_S			60	Ω
	f_{OSC} > 40MHz	R_S			50	Ω
Maximum crystal drive level			100			μW

Note 1: Higher frequencies give lower output jitter, all else being equal.
Note 2: These ESR limits are chosen to constrain crystal drive level to less than 100μW. If the crystal can tolerate a drive level greater than 100μW then proportionally higher ESR is acceptable.

Parameter	Symbol	Min.	Typ.	Max.	Units
Crystal Frequency Stability vs. Power Supply	f_{FVD}		0.2	0.5	ppm per 10% Δ in VDD

Any known frequency inaccuracy of the crystal can be compensated in the APLL by adjusting the APLL's fractional feedback divider value (AFBDIV) by ppb or ppm to compensate for crystal frequency error.

5.4.3 Clock Doubler

Figure 1 shows an optional clock doubler ("x2" block) following the crystal driver block. The doubler, which is enabled by setting MCR1.DBL=1, can be used to double the frequency of the internal crystal driver circuit or a clock signal on the channel's XA pin. The following table shows scenarios when the clock doubler can be used.

Channel Mode	With Crystal	With XO or Clock Signal
APLL, Integer Multiply	Maybe[1]	Maybe[1]
APLL, Fractional Multiply	Yes	Yes
NCO	Yes	Yes
Spread-Spectrum	Yes	Yes

Note 1: For APLL integer multiplication, use of the doubler is application-dependent. On the positive side, use of the doubler reduces random jitter. On the negative side, the doubler causes a large spur at the XA frequency (but this spur may be outside the band of interest for the application).

5.4.4 Ring Oscillator (for System Start-Up)

To ensure that registers can be written immediately after system start-up, in its power-on reset state each channel operates its registers and processor interface from an internal ring oscillator.

When operating a channel in NCO mode or spread spectrum mode, as soon as the external oscillator connected to the XA pin has stabilized and is ready to use, the MCR1.MCSEL bit must be set to source the NCO/SS master clock from XA. If the ring oscillator causes undesirable spurs it can be disabled (powered down) by setting MCR1.ROSCD=1.

When operating the part in APLL-only mode, a master clock signal on the XA pin is not required, and the ring oscillator is left enabled to provide a clock for the processor interface logic and registers.

5.5 Input Signal Format Configuration

Each channel's input clocks IC1, IC2 and IC3 are enabled by setting the enable bits in the ICEN register. The power consumed by a differential receiver is shown in Table 6. The electrical specifications for these inputs are listed in Table 9. Each input clock can be configured to accept nearly any differential signal format by using the proper set of external components (see Figure 16). To configure these differential inputs to accept single-ended CMOS signals, connect the single-ended signal to the ICxP pin, and connect the ICxN pin to a capacitor (0.1µF or 0.01µF) to VSS. Each ICxP and ICxN pin is internally biased to approximately 1.3V. If an input is not used, both ICxP and ICxN pins can be left floating. Note that the IC3N pin is not present. A differential signal can be connected to IC3P by AC-coupling the POS trace to IC3P and terminating the signal on the driver side of the coupling cap. If not needed as an input clock pin, IC3P can behave as general-purpose I/O pin GPIO3.

5.6 Numerically Controlled Oscillator / Spread Spectrum Block (NCO/SS)

The NCO/SS block allows a channel to behave as a numerically controlled oscillator and optionally perform spread-spectrum frequency modulation. This block is enabled by setting PLLEN.NCSSEN=1 and is the input reference for the APLL when APLLCR3.APLLMUX=11x. The NCO/SS block requires a clock signal from an external oscillator connected to the XA pin (see section 5.4.1). Table 8 shows the allowable frequency range for the XA signal. Note that output jitter increases as XA frequency decreases.

5.6.1 Numerically Controlled Oscillator (NCO) Mode

The NCO/SS block operates in NCO mode when NCSSCR1.MODE=0001. In this mode system software controls the NCO/SS block by controlling the value of the 40-bit FREQZ field in the DFREQZ registers. The resolution of frequency control is better than 0.01ppb.

The nominal FREQZ value, hereafter referred to as FREQZ0, is computed by the evaluation software for the desired channel configuration. When the FREQZ field is set to the FREQZ0 value, the channel's output clock

frequencies have a fractional frequency offset of zero with respect to the NCO master clock signal applied to the XA pin.

(Fractional frequency offset (FFO) is defined as (actual_frequency – nominal_frequency) / nominal_frequency. FFO is a unitless number but is typically expressed in parts per billion (ppb), parts per million (ppm) or percent.)

To control the NCO, system software first reads the FREQZ0 value. FREQZ0 is a 40-bit unsigned integer.

To change the NCO frequency to a specific FFO (in ppm), system software calculates newFREQZ (a 40-bit unsigned integer) as follows:

$$newFREQZ = round(FREQZ0 * (1 + FFO/1e6))$$

System software then writes the newFREQZ value directly to the FREQZ field in the DFREQZ registers.

Note that any subsequent frequency changes are calculated using the same equation from the original FREQZ0 value and are <u>not</u> a function of the previous newFREQZ value. The value of newFREQZ should be kept within ±1000ppm of FREQZ0 and within ±500ppm of the previous newFREQZ value to avoid causing the APLL to lose lock. If spread spectrum modulation is also in use, the total frequency change caused by spread spectrum modulation and NCO control should be kept within ±5000ppm of FREQZ0 to avoid causing the APLL to lose lock.

5.6.2 Spread-Spectrum Modulation Mode

For EMI-sensitive applications such as PCI Express, a channel can perform spread spectrum modulation (SSM). In SSM the frequency of the output clock is continually varied over a narrow frequency range to spread the energy of the signal and thereby reduce EMI. This mode is a special case of NCO mode.

The NCO/SS block operates in spread spectrum mode when NCSSCR1.MODE=0010. In this mode the NCO/SS block performs frequency modulation starting from a base frequency offset specified in the 40-bit FREQZ field in the DFREQZ registers. The frequency modulation is triangle-wave center-spread of up to ±0.5% deviation from the center frequency with modulation rate configurable from 25kHz to 55kHz. The nominal value of FREQZ and the spread configuration register values are determined by the evaluation software.

Down-spread applications can be supported by converting them into center-spread. This is done by setting the NCO/SS block's center frequency to be the center of the modulation range rather than the high end of range. For example, 100MHz with -1% downspread can be converted into ±0.5% center spread with center frequency of 100MHz/1.005=99.502488MHz.

5.7 APLL Configuration

5.7.1 APLL Input Selection and Frequency

The APLL can lock to any of inputs IC1 through IC3, a clock signal on XA (optionally clock-doubled), or the crystal driver circuit (optionally clock-doubled) when a crystal is connected to XA and XB. The APLL can also lock to the output of the NCO/SS block (see section 5.6).

The input to the APLL can be controlled by a GPIO pin or by the APLLCR3.APLLMUX register field. When APLLCR3.EXTSW=0, the APLLCR3.APLLMUX register field controls the APLL input mux.

When APLLCR3.EXTSW=1, a GPIO pin controls the APLL input mux. When the GPIO pin is low, the mux selects the input specified by APLLCR3.APLLMUX. When the GPIO pin is high, the mux selects the input specified by APLLCR3.ALTMUX. MCR2.EXTSS specifies which GPIO pin controls this behavior.

In APLL-only mode, the frequencies of all enabled input clocks (ICx and XA) must divide to a common APLL phase-frequency detector (PFD) frequency from 9.72MHz to 156.25MHz. In this mode the input high-speed dividers (ICxCR1.HSDIV) can be used to divide the ICx frequencies by 1, 2, 4 or 8. The XA pin does not have an

internal divider, and, therefore, if XA is an enabled input clock then the XA frequency sets the APLL common PFD frequency. The polarity of an ICx input signal can be inverted by setting ICxCR1.POL.

5.7.2 APLL Output Frequency
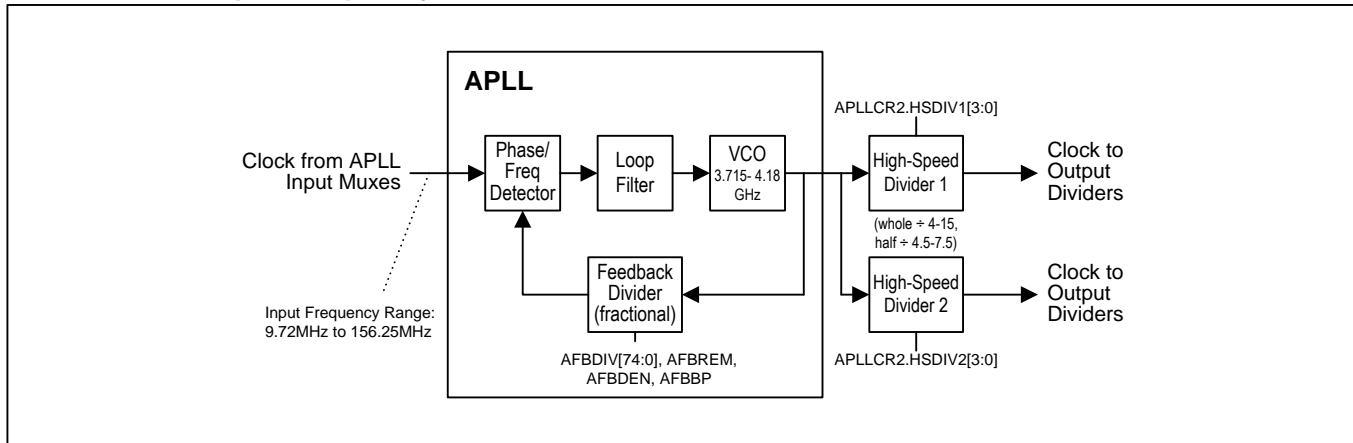
Figure 6 - APLL Block Diagram

The APLL is enabled when PLLEN.APLLEN=1. The APLL has a fractional-N architecture and therefore can produce output frequencies that are either integer or non-integer multiples of the input clock frequency. Figure 6 shows a block diagram of the APLL, which is built around an ultra-low-jitter multi-GHz VCO. Register fields AFBDIV, AFBREM, AFBDEN and AFBBP configure the frequency multiplication ratio of the APLL. The APLLCR2.HSDIV1 and HSDIV2 fields specify how the VCO frequency is divided down by the high-speed dividers. Dividing by six is the typical setting to produce 622.08MHz for SDH/SONET or 625MHz for Ethernet applications.

Internally, the exact APLL feedback divider value is expressed in the form AFBDIV + AFBREM / AFBDEN * $2^{-(33-AFBBP)}$. This feedback divider value must be chosen such that APLL_input_frequency * feedback_divider_value is in the operating range of the VCO (as specified in Table 12). The AFBDIV term is a fixed-point number with 9 integer bits and a configurable number of fractional bits (up to 33, as specified by AFBBP). Typically AFBBP is set to 9 to specify that AFBDIV has 33 – 9 = 24 fractional bits. Using more than 24 fractional bits does not yield a detectable benefit. Using less than 12 fractional bits is not recommended.

The following equations show how to calculate the feedback divider values for the situation where the APLL should multiply the APLL input frequency by integer M and also fractionally scale by the ratio of integers N / D. In other words, VCO_frequency = input_frequency * M * N / D. An example of this is multiplying 77.76MHz by M=48 and scaling by N / D = 255 / 237 for forward error correction applications.

$$\text{AFBDIV} = \text{trunc}(M * N / D * 2^{24}) \qquad\qquad (1)$$

$$\text{lsb\_fraction} = M * N / D * 2^{24} - \text{AFBDIV} \qquad\qquad (2)$$

$$\text{AFBDEN} = D \qquad\qquad (3)$$

$$\text{AFBREM} = \text{round}(\text{lsb\_fraction} * \text{AFBDEN}) \qquad\qquad (4)$$

$$\text{AFBBP} = 33 - 24 = 9 \qquad\qquad (5)$$

The trunc() function returns only the integer portion of the number. The round() function rounds the number to the nearest integer. In Equation (1), AFBDIV is set to the full-precision feedback divider value, M * N / D, truncated after the 24th fractional bit. In Equation (2) the temporary variable 'lsb_fraction' is the fraction that was truncated in Equation (1) and therefore is not represented in the AFBDIV value. In Equation (3), AFBDEN is set to the denominator of the original M * N / D ratio. In Equation (4), AFBREM is calculated as the integer numerator of a

fraction (with denominator AFBDEN) that equals the 'lsb_fraction' temporary variable. Finally, in Equation (5) AFBBP is set to 33 – 24 = 9 to correspond with AFBDIV having 24 fractional bits.

When a fractional scaling scenario involves multiplying an integer M times multiple scaling ratios N_1 / D_1 through N_n / D_n, the equations above can still be used if the numerators are multiplied together to get $N = N_1 \times N_2 \times \ldots \times N_n$ and the denominators are multiplied together to get $D = D_1 \times D_2 \times \ldots \times D_n$.

The easiest way to calculate the exact values to write to the APLL registers is to use the evaluation software, available on the Microsemi website. This software can be used even when no evaluation board is attached to the computer.

Note: After the APLL's feedback divider settings are configured in register fields AFBDIV, AFBREM, AFBDEN and AFBBP, the APLL enable bit PLLEN.APLLEN should be changed from 0 to 1 to cause the APLL to reacquire lock with the new settings. The real-time lock/unlock status of the APLL is indicated by APLLSR.ALK and ALK2.

5.7.3   APLL Phase Adjustment

The phase of the APLL's output clock can be incremented or decremented by 1/8th of a VCO cycle. This phase step size is 30ps at maximum VCO frequency of 4180MHz and 33.7ps at minimum VCO frequency of 3715MHz. The APLLCR4.PDSS field specifies the phase decrement control signal, which can be the APLLCR4.DECPH bit or any of the four GPIOs. The APLLCR4.PISS field specifies the phase increment control signal, which can be the APLLCR4.INCPH bit or any of the four GPIOs. Phase is adjusted on every rising edge and every falling edge of the control signal. This phase adjustment affects the output of both high-speed dividers.

5.8   Output Clock Configuration

Each channel has three output clock signal pairs. Each output has individual divider, enable and signal format controls. In CMOS mode each signal pair can become two CMOS outputs, allowing a channel to have up to six output clock signals. Also in CMOS mode, the OCxN pin can have an additional divider allowing the OCxN frequency to be an integer divisor of the OCxP frequency (example: OC3P 125MHz and OC3N 25MHz). The outputs in each channel can be aligned relative to each other and relative to a channel input signal, and the phases of output signals can be adjusted dynamically with high resolution and infinite range.

5.8.1   Output Enable, Signal Format, Voltage and Interfacing

To use an output, the output driver must be enabled by setting OCxCR2.OCSF≠0, and the per-output dividers must be enabled by setting the appropriate bit in the OCEN register. The per-output dividers include the medium-speed divider, the low-speed divider and the associated phase adjustment/alignment circuitry and start/stop logic.

Using the OCxCR2.OCSF register field, each output pair can be disabled or configured as a CML output, an HSTL output, or one or two CMOS outputs. When an output is disabled it is high impedance, and the output driver is in a low-power state. In CMOS mode, the OCxN pin can be disabled, in phase or inverted vs. the OCxP pin. In CML mode the normal 800mV V_{OD} differential voltage is available as well as a half-swing 400mV V_{OD}. All of these options are specified by OCxCR2.OCSF. The clock to the output driver can inverted by setting OCxCR2.POL=1. The CMOS/HSTL output driver can be set to any of four drive strengths using OCxCR2.DRIVE.

Each output has its own power supply pin to allow CMOS or HSTL signal swing from 1.5V to 3.3V for glueless interfacing to neighboring components. If OCSF is set to HSTL mode then a 1.5V power supply voltage should be used to get a standards-compliant HSTL output. Note that differential (CML) outputs must have a power supply of 3.3V.

The differential outputs can be easily interfaced to LVDS, LVPECL, CML, HCSL, HSTL and other differential inputs on neighboring ICs using a few external passive components. See Figure 18 for examples.

5.8.2 Output Frequency Configuration

The frequency of each output is determined by the configuration of the APLL, the high-speed dividers and the per-output dividers. Each output can be connected to either high-speed divider 1 (HSDIV1) or 2 (HSDIV2) using the OCxCR3.DIVSEL field.

Each output has two output dividers, a 7-bit medium-speed divider (OCxCR1.MSDIV) and a 25-bit low-speed output divider (LSDIV field in the OCxDIV registers). These dividers are in series, medium-speed divider first then output divider. These dividers produce signals with 50% duty cycle for all divider values including odd numbers. The low-speed divider can only be used if the medium-speed divider is used (i.e. OCxCR1.MSDIV>0).

Since each output has its own independent dividers, each channel can output a family of related frequencies that have an APLL HSDIV output frequency as a common multiple. For example, for Ethernet clocks, a 625MHz HSDIV output clock can be divided by four for one output to get 156.25MHz, divided by five for another output to get 125MHz, and divided by 25 for another output to get 25MHz. Similarly, for SDH/SONET clocks, a 622.08MHz HSDIV output clock can be divided by 4 to get 155.52MHz, by 8 to get 77.76MHz, by 16 to get 38.88MHz or by 32 to get 19.44MHz.

Two Different Frequencies in 2xCMOS Mode

When an output is in 2xCMOS mode it can be configured to have the frequency of the OCxN clock be an integer divisor of the frequency of the OCxP clock. Examples of where this can be useful:

- 125MHz on OCxP and 25MHz on OCxN for Ethernet applications

- 77.76MHz on OCxP and 19.44MHz on OCxN for SONET/SDH applications

- 25MHz on OCxP and 1Hz (i.e. 1PPS) on OCxN for telecom applications with Synchronous Ethernet and IEEE1588 timing

An output can be configured to operate like this by setting the LSDIV value in the OCxDIV registers to OCxP_freq / OCxN_freq - 1 and setting OCxCR3.LSSEL=0 and OCxCR3.NEGLSD=1. Here are some notest about this dual-frequency configuration option:

- In this mode only the medium speed divider is used to create the OCxP frequency. The low-speed divider is then used to divide the OCxP frequency down to the OCxN frequency. This means that the lowest OCxP frequency is the high-speed divider output frequency divided by 128.

- An additional constraint is that the medium-speed divider must be configured to divide by 6 or more (i.e. must have OCxCR1.MSDIV$\geq$5).

5.8.3 Output Duty Cycle Adjustment

For output frequencies less than or equal to 141.666MHz, the duty cycle of the output clock can be modified using the OCxDC.OCDC register field. This behavior is only available when MSDIV>0 and LSDIV > 1. When OCDC = 0 the output clock is 50%. Otherwise the clock signal is a pulse with a width of OCDC number of MSDIV output clock periods. The range of OCDC can create pulse widths of 1 to 255 MSDIV output clock periods. When OCxCR2.POL=0, the pulse is high and the signal is low the remainder of the cycle. When POL=1, the pulse is low and the signal is high the remainder of the cycle.

Note that duty cycle adjustment is done in the low-speed divider. Therefore when OCxCR3.LSSEL=0 the duty cycle of the output is not affected. Also, when a CMOS output is configured with OCxCR3.LSSEL=0 and OCxCR3.NEGLSD=1, the OCxN pin has duty cycle adjustment but the OCxP pin does not. This allows a higher-speed 50% duty cycle clock signal to be output on the OCxP pin and a lower-speed frame/phase/time pulse (e.g. 2kHz, 8kHz or 1PPS) to be output on the OCxN pin at the same time.

An output configured for CMOS or HSTL signal format should not be configured to have a duty cycle with high time shorter than 2ns or low time shorter than 2ns.

5.8.4   Output Phase Adjustment and Phase Alignment

Each channel has flexible, high-resolution tools for managing the phases of the output clocks relative to one another. The key register fields for this are found in the PACR1 and PACR2 global configuration registers and the per-output OCxPH register.

Phase alignment and phase adjustment are done in the medium-speed dividers. Resoution is 0.5 periods (also known as unit intervals or UI) of the high-speed divider (HSDIV) output clock. For example, for an HSDIV output frequency of 800MHz, resolution is 625ps.

5.8.4.1 Phase Adjustment

A phase adjustment is a phase change for an output relative to that output's most recent phase. To cause a channel to perform phase adjustment of an output clock, set PACR1.MODE=1, set OCxCR1.PHEN=1 to enable the output for phase adjustment, and write the phase adjustment amount to the output's OCxPH register. Then an arm/trigger methodology is used to cause the phase adjustment to happen.

The arm step tells the channel that it is enabled to perform the phase adjustment when it sees the trigger stimulus. The source of the arm signal is specified by PACR2.ARMSRC. Options include the 0-to-1 transition of the PACR1.ARM bit, APLL transition from unlocked to locked, or a transition on one of the GPIO pins.

The source of the trigger signal is specified by PACR2.TRGSRC. Options include 0-to-1 transition of the PACR1.TRIG bit, APLL transition from unlocked to locked, or a transition on one of the GPIO pins. The trigger signal can be inverted by setting PACR1.TINV. With TINV=1, the same GPIO signal can arm on one edge and trigger on the opposite edge.

Any combination of a channel's outputs can be phase adjusted by the same trigger, and each output can be adjusted by a different amount. Only outputs with OCxCR1.PHEN=1 and OCxPH.PHADJ$\neq$0 have their phases adjusted.

There are a few constraints on the range of possible phase adjustments. These have to do with the output's medium-speed divider value.

1) Phase adjustment is not available unless OCxCR1.MSDIV>0.
2) The largest negative phase adjustment magnitude in HSDIV periods is:
    If OCxCR1.MSDIV is odd: (OCxCR1.MSDIV – 1) / 2
    If OCxCR1.MSDIV is even: (OCxCR1.MSDIV – 2) / 2

3) The largest positive phase adjustment in HSDIV periods is:
    If OCxCR1.MSDIV is odd: (127 – OCxCR1.MSDIV) / 2
    If OCxCR1.MSDIV is even: (128 – OCxCR1.MSDIV) / 2

The implications of constraints 2) and 3) are shown in this table:

OCxCR1.MSDIV	Largest Negative Phase Adjust, HSDIV periods	Largest Positive Phase Adjust, HSDIV periods	Notes
1 or 2	0	63	no negative adjustment
3 or 4	1	62	
5 or 6	2	61	
…	…	…	
123 or 124	61	2	
125 or 126	62	1	
127	63	0	no positive adjustment

During a phase adjustment the MSDIV output period is changed for one period. The MSDIV output signal during that period will have longer high time (unless inverted) during a positive phase adjustment and shorter high time (unless inverted) during a negative phase adjustment. With negative phase adjustments care must be taken to not shorten the high time of the output clock signal to be too short for the components that receive the clock. There are several possible ways to avoid this issue including: (1) using small negative adjustments such as -0.5UI repeatedly instead of one larger negative adjustment, (2) using positive adjustments to "wrap around" to the desired negative adjustment, or (3) holding the components that receive the clock in reset during the phase adjustment.

An armed phase adjustment can be canceled before the trigger occurs by setting the PACR1.RST bit.

The PASR register has real-time status bits indicating whether a phase adjustment is armed and waiting for a trigger (ARMED bit) or in progress (BUSY bit). It also has a latched status bit (ADJL bit) to indicate the adjustment has completed.

Example: +1.0 HSDIV period phase adjustment for output OC1 using ARM and TRIG register bits:

OC1CR1.PHEN=1   (Enable phase adjust on OC1)
OC1PH.PHADJ=00000010 (Specify +1.0 HSDIV period phase adjustment)
PACR1.MODE=1   (Phase adjustment mode)
PACR2.ARMSRC=0001   (arm signal is PACR1.ARM bit)
PACR2.TRGSRC=0000   (trigger signal is PACR1.TRIG bit)
PACR1.RST=1   (reset phase adjust/align state machine after changing ARMSRC)
PACR1.ARM=1   (arm for phase adjust)
PACR1.TRIG=1   (do the phase adjust: add +1.0 UI to output phase)
repeat the next two writes as needed:
PACR1.ARM=1 .TRIG=0   (arm again; clearing the TRIG bit is required when MSDIV period < master clock period because TRIG is not self-clearing in this situation)
PACR1.TRIG=1   (add +1.0 UI to output phase again)

5.8.4.2 Phase Alignment, Output-to-Output

A phase alignment is a special case of phase adjustment where the MSDIV and LSDIV dividers for all participating outputs are reset just before the phase adjustment occurs. For output-to-output alignment the trigger can be the PACR1.TRIG bit or the APLL lock signal.

To avoid glitches (i.e. "runt pulses") on the output clock it is possible to manually stop the output(s), before triggering the phase alignment, and then restart the output(s) after the alignment (See section 5.8.5).

When aligning outputs, it is important to note that, by default, the phase of outputs configured as HSTL format or "two CMOS, OCxP inverted vs. OCxN" format is opposite that of CML outputs. For example, consider the case where OC1 is 100MHz CML format and OC2 is 100MHz HSTL format. When OC1 and OC2 are aligned then OC2N is high when OC1P is high. The polarity bit OCxCR2.POL can be used to change this as needed.

There are several rules when alignment is enabled for multiple outputs:

- All participating outputs must come from the same high-speed divider

- All outputs that use both medium-speed and low-speed divider must have the same MSDIV value, the same LSDIV value and PHADJ=0. Subsequent phase adjustment(s) can be used to move the output(s) to other phase(s).
- All outputs that only use medium-speed divider can have PHADJ values smaller than the period of the highest output frequency among them.
- When some outputs use only medium-speed divider and other outputs use both medium-speed and low-speed divider, all MSDIV values must be the same, and those output using low-speed divider must have PHADJ=0.

Contact Microsemi Timing Applications Support for help with alignment scenarios that don't meet the rules listed above.

Example: OC1-to-OC2 alignment (+3.5 HSDIV UI offset) after the APLL locks:

OC1CR1.PHEN=1   (Enable phase adjust on OC1)
OC2CR1.PHEN=1   (Enable phase adjust on OC2)
OC1PH.PHADJ=00000000 (0.0UI)
OC2PH.PHADJ=00000111 (+3.5UI)
PACR1.MODE=0   (Phase alignment mode)
PACR2.ARMSRC=0001   (arm signal is PACR1.ARM bit)
PACR2.TRGSRC=0001   (trigger signal is APLL transition from unlocked to locked)
PACR1.RST=1   (reset phase adjust/align state machine after changing ARMSRC, TRGSRC)
PACR1.ARM=1   (arm for phase alignment)
 (Aligns/realigns outputs when the APLL locks or relocks)

5.8.4.3 Phase Alignment, Input-to-Output

The phase alignment tool described in section 5.8.4.2 can use a GPIO pin as the alignment trigger. However there is some uncertainty associated with sampling the GPIO signal. Therefore the phase alignment tool *by itself* is is not sufficient to achieve input-to-output phase alignment. The procedure is to first do a phase alignment as described in section 5.8.4.2 but with a GPIO input as the trigger. Then the phase measurement tool described in section 5.8.6 can be used to determine the phase difference between an output signal and the input signal. Then phase adjustment as described in section 5.8.4.1 can be used to change the phase of one or more output signals to align with input signal phase.

It is important to note that, by default, outputs that only use the medium-speed divider have their rising edge aligned with the rising edge of the trigger signal. Meanwhile, outputs that use both the medium-speed and low-speed dividers have their rising edge aligned with the falling edge of the trigger signal. Per-output polarity bits (OCxCR2.POL) can be used to invert the polarity of output signals as needed so that all are rising-edge aligned or falling-edge aligned or any combination as needed.

5.8.5 Output Clock Start and Stop

Output clocks can be stopped high or low. One use for this behavior is to ensure "glitchless" output clock operation while the output is reconfigured or phase aligned with some other signal.

Each output has an OCxSTOP register with fields to control this behavior. The OCxSTOP.MODE field specifies whether the output clock signal stops high, stops low, or or does not stop. The OCxSTOP.SRC field specifies the source of the stop signal. Options include the OCxSTOP.STOP bit, assertion of one of the GPIO pins, and the arming of a phase adjustment (which is indicate by PASR.ARMED).

When the stop mode is Stop High (OCxSTOP.MODE=01) and the stop signal is asserted, the output clock is stopped after the next rising edge of the output clock. When the stop mode is Stop Low (OCxSTOP.MODE=10) and the stop signal is asserted, the output clock is stopped after the next falling edge of the output clock. Internally the clock signal continues to toggle while the output is stopped. When the stop signal is deasserted, the output

clock resumes on the opposite edge that it stopped on. Low-speed output clocks can take long intervals before being stopped after the stop signal goes active. For example, a 1 Hz output could take up to 1 second to stop.

OCxCR1.MSDIV must be > 0 for this function to operate since MSDIV=0 bypasses the start-stop circuits. Note that when OCxCR3.NEGLSD=1 the start-stop logic is bypassed for the OCxN pin, and OCxN may not start/stop without glitches.

When OCxCR2.POL=1 the output stops on the opposite polarity that is specified by the OCxSTOP.MODE field.

When OCxCR2.STOPDIS=1 the output driver is disabled (high impedance) while the output clock is stopped.

Each output has a status register (OCxSR) with several stop/start status bits. The STOPD bit is a real-time status bit indicating stopped or not stopped. The STOPL bit is a latched status bit that is set when the output clock has stopped. The STARTL bit is a latched status bit that is set when the output clock has started.

5.8.6 A-to-B Phase Offset Measurement

The phase or time offset between two of a channel's signals (A and B) can be measured in units of a timebase clock. This capability can be used to for several purposes, including:

- Keeping output clocks and low-speed output phase/time signals—such as frame sync, multiframe sync, or 1 pulse per second (1PPS) signals—aligned with input phase/time signals. The A-to-B measurement circuitry can detect phase changes in the input signal. Then the output phase adjustment circuitry described in section 5.8.4 can be used to move phase(s) of output(s) to follow the input phase change.

- Keeping output clock signals and/or low-speed output phase/time signals aligned with one another. The A-to-B measurement circuitry can detect relative phase changes, and the phase adjustment circuitry described in section 5.8.4 can be used to move phase(s) of output(s) as needed.

The A and B signals can be any ICx input, any OCx output, or any GPIO, as specified by MABCR2.ASRC and MABCR3.BSRC. The timebase signal can be the external oscillator signal (or the output of the crystal driver circuit, optionally doubled by the clock doubler) or the output clock of any of the three medium-speed dividers (MSDIV1, MSDIV2, MSDIV3). The timebase signal is specified by MABCR1.TBSRC.

A new measurement is started by writing MABCR1.START=1. Any previously started measurement must be completed before a new measurement is started. If a measurement has not finished it can be aborted by writing MABCR1.RST=1 before starting a new measurement. The measurement is complete when MABSR1.RDYL is set.

Example: consider an SDH/SONET application where OC1 is a 19.44MHz output clock and OC2 is an 8kHz frame sync signal. The goal is to measure the phase offset of OC1 vs. OC2. If they are found to have a phase offset then the phase adjustment circuitry in section 5.8.4 can be used to slowly change the phase of OC1 to match the phase of OC2 (or vice versa).

MABCR1.TBSRC=001	(MSDIV1 output clock is 311.04MHz = 3.2 ns period)
MABCR2.ASRC=10001	(OC2 8kHz sync signal)
MABCR3.BSRC=10000	(OC1 19.44MHz clock)
MABCR1.START=1	(Start measurement)
Wait for MABSR1.RDYL=1	(Measurement ready)
Read MABSR1.OVFL	(to see if the measurement is valid)
MABSR1.RDYL=1, MABSR1.OVFL=1	(clear latched status bits)
Read MEAS bits from MABSR1	
and MABSR2	

If, for example, MEAS = 111 1111 1001 (-8) then the rising edge of OC1 (the 'B' signal) precedes the rising edge of OC2 (the 'A' signal) by 8 MSDIV1 ouptut clock periods (25.7ns).

An A-to-B measurement is performed by sampling the A and B signals with the selected timebase clock and detecting the rising or falling edges to measure. The number of timebase clocks between the A and B edges is counted. If the counter doesn't overflow then the phase difference is reported in the MEAS field in MABSR1 and MABSR2. If the counter does overflow then MABSR1.OVFL is set and the value of MEAS is invalid.

While the measurement is in progress the MABSR1.BUSY bit is set to 1. When the measurement is complete MABSR1.BUSY is set to 0 and MABSR1.RDYL is set to 1. Since the A and B signals are sampled by the timebase signal, this measurement tool is only useful when the timebase signal is much higher frequency than the A and B signals (at least 8-10x). Also, when possible, the timebase signal frequency should be less than or equal to 1000 times faster than the the frequencies of the A and B frequencies to avoid measurement counter overflow.

Constraints on A-to-B measurement:

- $f_B = f_A$ x N   where f_A is the frequency of signal A, f_B is the frequency of signal B and N is a positive integer

When measuring from an ICx input or a GPIO (signal A) to an ICx or a GPIO (signal B) and when measuring from an OCx output to an OCx output, the measured value is MEAS * timebase_period. This measurement has a variability of 0 to +1 timebase clock period.

When measuring from an ICx input or a GPIO (signal A) to an OCx output (signal B), the measurement in time units is MEAS * timebase_period + 6 * HSCLK_period, where HSCLK_period is the period of the output of the high-speed divider from which OCx signal is derived. This measurement has a variability of 0 to +1 timebase clock period plus 0 to +1 HSCLK periods.

When measuring from an OCx output (signal A) to an ICx input or a GPIO (signal B), the the measurement in time units is MEAS * timebase_period – 6 * HSCLK_period, where HSCLK_period is the period of the output of the high-speed divider from which OCx signal is derived. This measurement has a variability of 0 to +1 timebase clock period plus 0 to +1 HSCLK periods.

Guidance for Use

When the A and B signals are aligned to within one timebase clock cycle, the measurement hardware does not report 0. Instead it reports a measurement value that is equivalent to +1 cycle of signal B.

If the timebase clock is ≤ 1023 times faster than signal B (so that the MEAS field cannot overflow, unless signal B is grossly too slow or not toggling at all) then system software should check the measured phase value. If the measured value is equal to the period of signal B then the A and B signals are aligned.

If the timebase clock is 1024 to 2047 times faster than signal B (and therefore the measurement counter can overflow) then the measurement hardware reports overflow when the A and B signals are aligned to within one timebase clock cycle. This report of overflow can be distinguished from other overflow cases by setting MABCR3.BINV=1 and then remeasuring from signal A to the opposite edge of signal B. If the new measured value is equal to half the period of signal B then the A and B signals are aligned.

If the timebase clock is > 2047 times faster than signal B then the measurement hardware reports overflow when the A and B signals are aligned to within one timebase clock cycle. This report of overflow is not distinguishable from other overflow cases. One way system software could work around this to determine that A and B are aligned is to use phase adjustment to move one of the signals by 2 or more timebase clocks then remeasure. If the new measured value matches the phase adjustment then the signals were aligned before the phase adjustment. Software can then adjust the phase of the signal back to its original position. Not all applications can tolerate such phase adjustments; for those applications it is recommended that the timebase clock be ≤ 2047 times faster than signal B.

5.9 Microprocessor Interface

Each channel in the device can communicate over a SPI interface or an I^{2}C interface.

In SPI mode the ZL30244 can be configured at reset to be a SPI slave to a processor master or a SPI master to an external EEPROM slave. The ZL30245 can only be configured as a SPI slave to a processor master. Both devices are always slaves on the I^{2}C bus.

Section 5.3 describes reset pin settings required to configure a channel for each of these interfaces.

5.9.1 SPI Slave

A device channel can present a SPI slave port on its CSN, SCLK, MOSI, and MISO pins. SPI is a widely used master/slave bus protocol that allows a master and one or more slaves to communicate over a serial bus. SPI masters are typically microprocessors, ASICs or FPGAs. Data transfers are always initiated by the master, which also generates the SCLK signal. A device channel receives serial data on the MOSI (Master Out Slave In) pin and transmits serial data on the MISO (Master In Slave Out) pin. MISO is high impedance except when the channel is transmitting data to the bus master.

Bit Order. The register address and all data bytes are transmitted most significant bit first on both MOSI and MISO.

Clock Polarity and Phase. The device latches data on MOSI on the rising edge of SCLK and updates data on MISO on the falling edge of SCLK. SCLK does not have to toggle between accesses, i.e., when CSN is high.

Device Selection. Each device channel has its own chip-select line. To select the channel, the bus master drives its CSN pin low.

Command and Address. After driving CSN low, the bus master transmits an 8-bit command followed by a 16-bit register address. The available commands are shown below.

Table 3 – SPI Commands

Command	Hex	Bit Order, Left to Right
Write Enable	0x06	0000 0110
Write	0x02	0000 0010
Read	0x03	0000 0011
Read Status	0x05	0000 0101

Read Transactions. The device registers are accessible when EESEL=0. On a ZL30245 the internal EEPROM memory is accessible when EESEL=1. On a ZL30244 EESEL must be set to 0. After driving CSN low, the bus master transmits the read command followed by the 16-bit address. The device then responds with the requested data byte on MISO, increments its address counter, and prefetches the next data byte. If the bus master continues to demand data, the device continues to provide the data on MISO, increment its address counter, and prefetch the following byte. The read transaction is completed when the bus master drives CSN high. See Figure 7.

Register Write Transactions. The device registers are accessible when EESEL=0. After driving CSN low, the bus master transmits the write command followed by the 16-bit register address followed by the first data byte to be written. The device receives the first data byte on MOSI, writes it to the specified register, increments its internal address register, and prepares to receive the next data byte. If the master continues to transmit, the device continues to write the data received and increment its address counter. The write transaction is completed when the bus master drives CSN high. See Figure 9.

EEPROM Writes (ZL30245 Only). The internal EEPROM memory is accessible when EESEL=1. After driving CSN low, the bus master transmits the write enable command and then drives CSN high to set the internal write enable latch. The bus master then drives CSN low again and transmits the write command followed by the 16-bit address followed by the first data byte to be written. The device first copies the page to be written from EEPROM to

its page buffer. The device then receives the first data byte on MOSI, writes it to its page buffer, increments its internal address register, and prepares to receive the next data byte. If the master continues to transmit, the device continues to write the data received to its page buffer and continues to increment its address counter. The address counter rolls over at the 32-byte page boundary (i.e. when the five least-significant address bits are 11111). When the bus master drives CSN high, the device transfers the data in the page buffer to the appropriate page in the EEPROM memory. See Figure 8 and Figure 9.

EEPROM Read Status (ZL30245 Only). After the bus master drives CSN high to end an EEPROM write command, the EEPROM memory is not accessible for up to 5ms while the data is transferred from the page buffer. To determine when this transfer is complete, the bus master can use the Read Status command. After driving CSN low, the bus master transmits the Read Status command. The device then responds with the status byte on MISO. In this byte, the least significant bit is set to 1 if the transfer is still in progress and 0 if the transfer has completed.

Early Termination of Bus Transactions. The bus master can terminate SPI bus transactions at any time by pulling CSN high. In response to early terminations, the device channel resets its SPI interface logic and waits for the start of the next transaction. If a register write transaction is terminated prior to the SCLK edge that latches the least significant bit of a data byte, the data byte is not written. On ZL30245, if an EEPROM write transaction is terminated prior to the SCLK edge that latches the least significant bit of a data byte, none of the bytes in that write transaction are written.

Design Option: Wiring MOSI and MISO Together. Because communication between the bus master and the device is half-duplex, the MOSI and MISO pins can be wired together externally to reduce wire count. To support this option, the bus master must not drive the MOSI/MISO line when the device is transmitting.

AC Timing. See Table 17 and Figure 20 for AC timing specifications for the SPI interface.
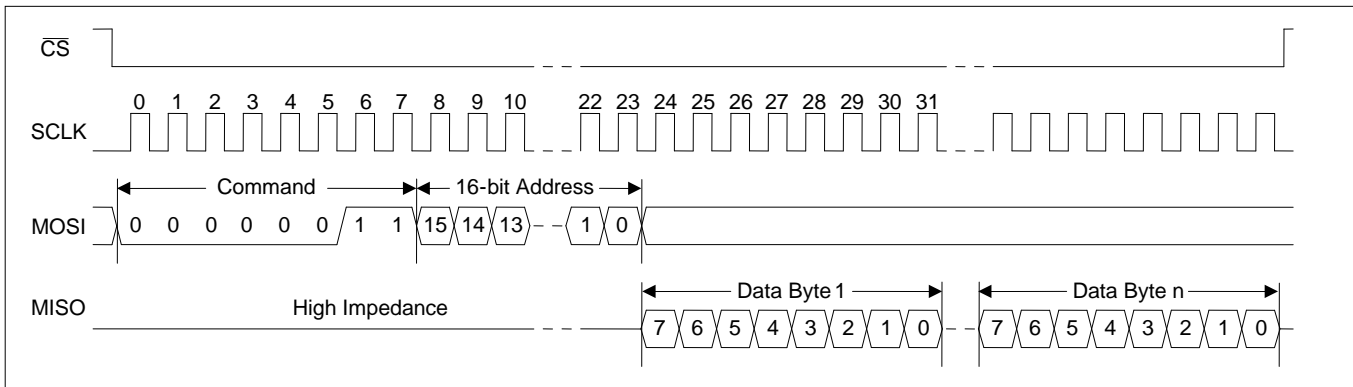
Figure 7 - SPI Read Transaction Functional Timing
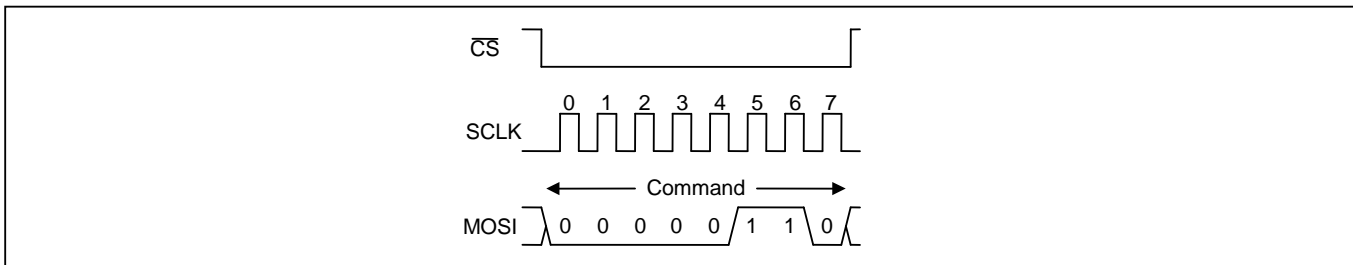
Figure 8 - SPI Write Enable Transaction Functional Timing (ZL30245 Only)
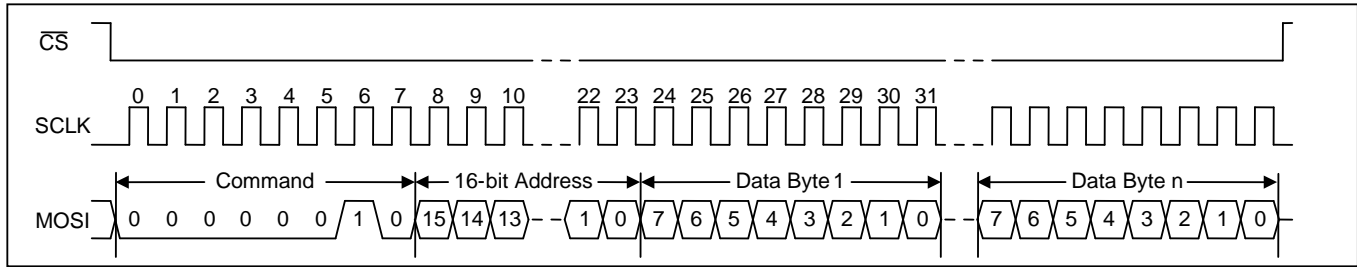
Figure 9 - SPI Write Transaction Functional Timing

5.9.2 SPI Master (ZL30244 Only)

After reset a device channel can present a SPI master port on the CSN, SCLK, MOSI, and MISO pins for auto-configuration using data read from an external SPI EEPROM. During auto-configuration the device channel is always the SPI master and generates the CSN and SCLK signals. The device transmits serial data on the the MOSI (Master Out Slave In) pin and receives serial data on the MISO (Master In Slave Out) pin.

Bit Order. The register address and all data bytes are transmitted most significant bit first on both MOSI and MISO.

Clock Polarity and Phase. The device latches data on MISO on the rising edge of SCLK and updates data on MOSI on the falling edge of SCLK.

Device Selection. Each device channel has its own chip-select line. To select the external EEPROM, the device channel drives the CSN signal low.

Command and Address. After driving CSN low, the device transmits an 8-bit read command followed by a 16-bit register address. The read command is shown below.

Command	Hex	Bit Order, Left to Right
Read	0x03	0000 0011

Read Transactions. After driving CSN low, the device transmits the read command followed by the 16-bit register address. The external EEPROM then responds with the requested data byte on MISO, increments its address counter, and prefetches the next data byte. If the device continues to demand data, the EEPROM continues to provide the data on MISO, increment its address counter, and prefetch the following byte. The read transaction is completed when the device drives CSN high. See Figure 7.

Writing the External EEPROM. Due to the small package size and low pin count of the device, there is no way to use the ZL30244 to write the external EEPROM. The auto-configuration data used by the ZL30244 must be pre-programmed into the EEPROM by some other method, such as:

1. The EEPROM manufacturer can write the data to the EEPROM during production testing.
    This is a service they routinely provide.

2. A contract manufacturer or distributor can write the data to the EEPROM using a production
    EEPROM programmer before the EEPROM is mounted to the board.

5.9.3 I²C Slave

A device channel can present a fast-mode (400kbit/s) I²C slave port on the SCL and SDA pins. I²C is a widely used master/slave bus protocol that allows one or more masters and one or more slaves to communicate over a two-wire serial bus. I²C masters are typically microprocessors, ASICs or FPGAs. Data transfers are always initiated by the master, which also generates the SCL signal. The device is compliant with version 2.1 of the I²C specification.

The SCL and SDA pins of the device's channels can be wired to the same I²C bus because the channels have different I²C slave addresses. Or, if needed for a specific application, the device channels can be connected to separate I²C buses.

The I²C interface on the device is a protocol translator from external I²C transactions to internal SPI transactions. This explains the slightly increased protocol complexity described in the paragraphs that follow.

Read Transactions. The device registers are accessible when EESEL=0. On a ZL30245 the internal EEPROM memory is accessible when EESEL=1. On ZL30244 EESEL must be set to 0. The bus master first does an I²C write to the device. In this transaction three bytes are written: the SPI Read command (see Table 3), the upper byte of the register address, and the lower byte of the register address. The bus master then does an I²C read. During each acknowledge (A) bit the device fetches data from the read address and then increments the read address. The device then transmits the data to the bus master during the next 8 SCL cycles. The bus master terminates the read with a not-acknowledge (NA) followed by a STOP condition (P). See Figure 10. Note: If the I²C write is separated from the I²C read by other I²C transactions then the device only outputs the data value from the first address and repeats that same data value after each acknowledge (A) generated by the bus master.

Register Write Transactions. The device registers are accessible when EESEL=0. The bus master does an I²C write to the device. The first three bytes of this transaction are the SPI Write command (see Table 3), the upper byte of the register address, and the lower byte of the register address. Subsequent bytes are data bytes to be written. After each data byte is received, the device writes the byte to the write address and then increments the write address. The bus master terminates the write with a STOP condition (P). See Figure 11.

EEPROM Writes (ZL30245 Only). The EEPROM memory is accessible when EESEL=1. The bus master first does an I²C write to transmit the SPI Write Enable command (see Table 3) to the device. The bus master then does an I²C write to transmit data to the device as described in the Register Write Transactions paragraph above. See Figure 12.

EEPROM Read Status (ZL30245 Only). The bus master first does an I²C write to transmit the SPI Read Status command (see Table 3) to the device. The bus master then does an I²C read to get the status byte. In this byte, the least significant bit is set to 1 if the transfer is still in progress and 0 if the transfer has completed. See Figure 13.

I²C Features Not Supported by the Device. The I²C specification has several optional features that are not supported by the device. These are: 3.4Mbit/s high-speed mode (Hs-mode), 10-bit device addressing, general call address, software reset, and device ID. The device does not hold SCL low to force the master to wait.

I²C Slave Address. Each channel's 7-bit slave address can be pin-configured for any of three values. These values are shown in the table in section 5.3.

Bit Order. The I²C specification requires device address, register address and all data bytes to be transmitted most significant bit first on the SDA signal.

Note: as required by the I²C specification, when power is removed from the device, the SDA and SCL pins are left floating so they don't obstruct the bus lines.
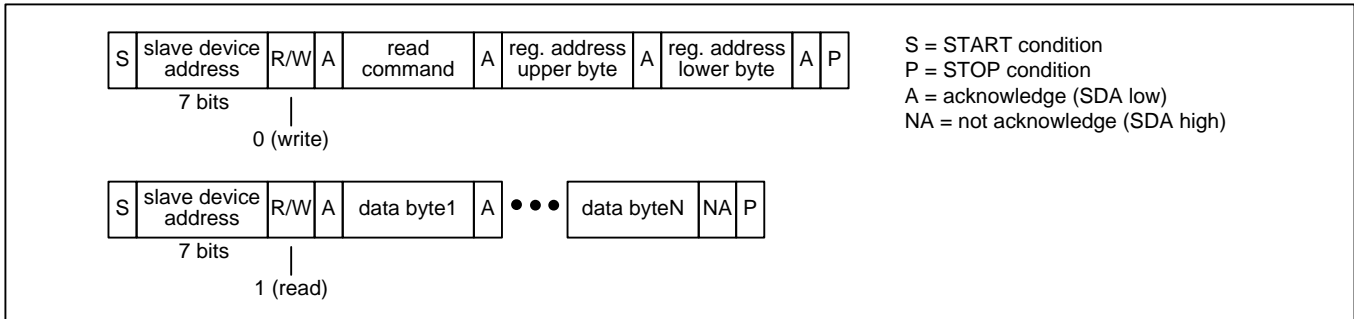
Figure 10 – I²C Read Transaction Functional Timing
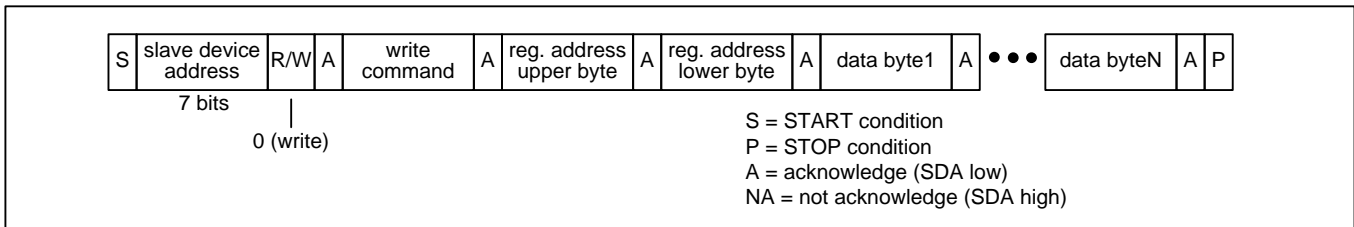
Figure 11 – I²C Register Write Transaction Functional Timing
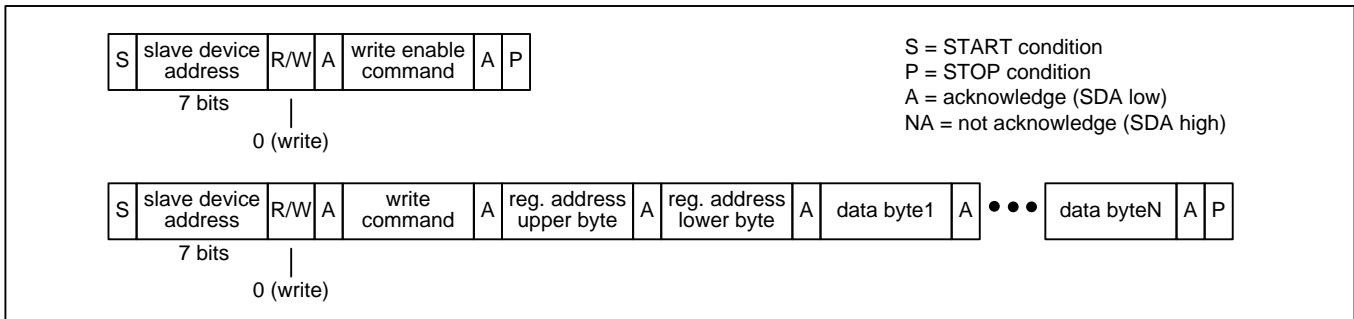
Figure 12 – I²C EEPROM Write Transaction Functional Timing (ZL30245 Only)
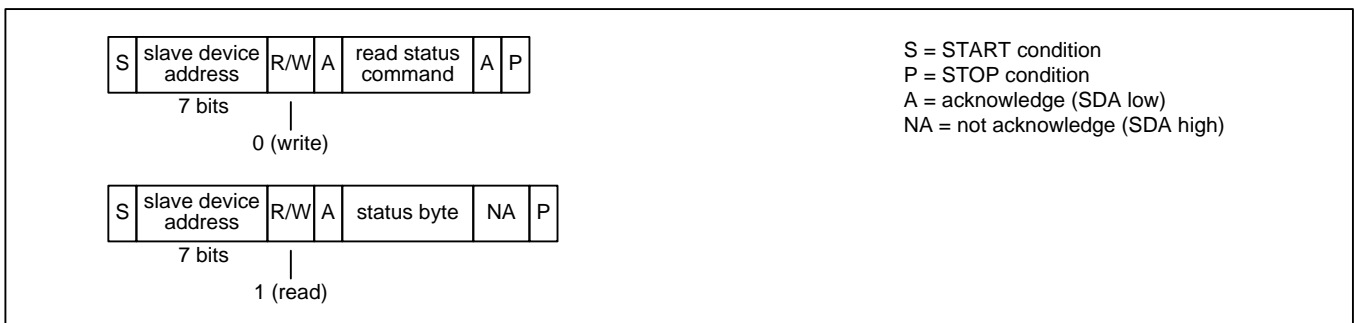
Figure 13 – I²C EEPROM Read Status Transaction Functional Timing (ZL30245 Only)

Note: In Figure 10 through Figure 13, a STOP condition (P) immediately followed by a START condition (S) can be replaced by a repeated START condition (Sr) as described in the I²C specification.

5.10 Interrupt Logic

Any of a channel's GPIO pins can be configured as an interrupt-request output by setting the appropriate GPIOxC field in the GPIOCR registers to one of the status output options (01xx) and configuring the appropriate GPIOxSS register to follow the INTSR.INT bit. If system software is written to poll rather than receive interrupt requests, then software can read the INTSR.INT bit first to determine if any interrupt requests are active in the channel.

Many of the latched status bits in the device can be the source of an interrupt request if their corresponding interrupt enable bits are set. Each channel's interrupt logic is shown in Figure 14. See the register map (Table 4) and the status register descriptions in section 6.3.2 for descriptions of the register bits shown in the figure.
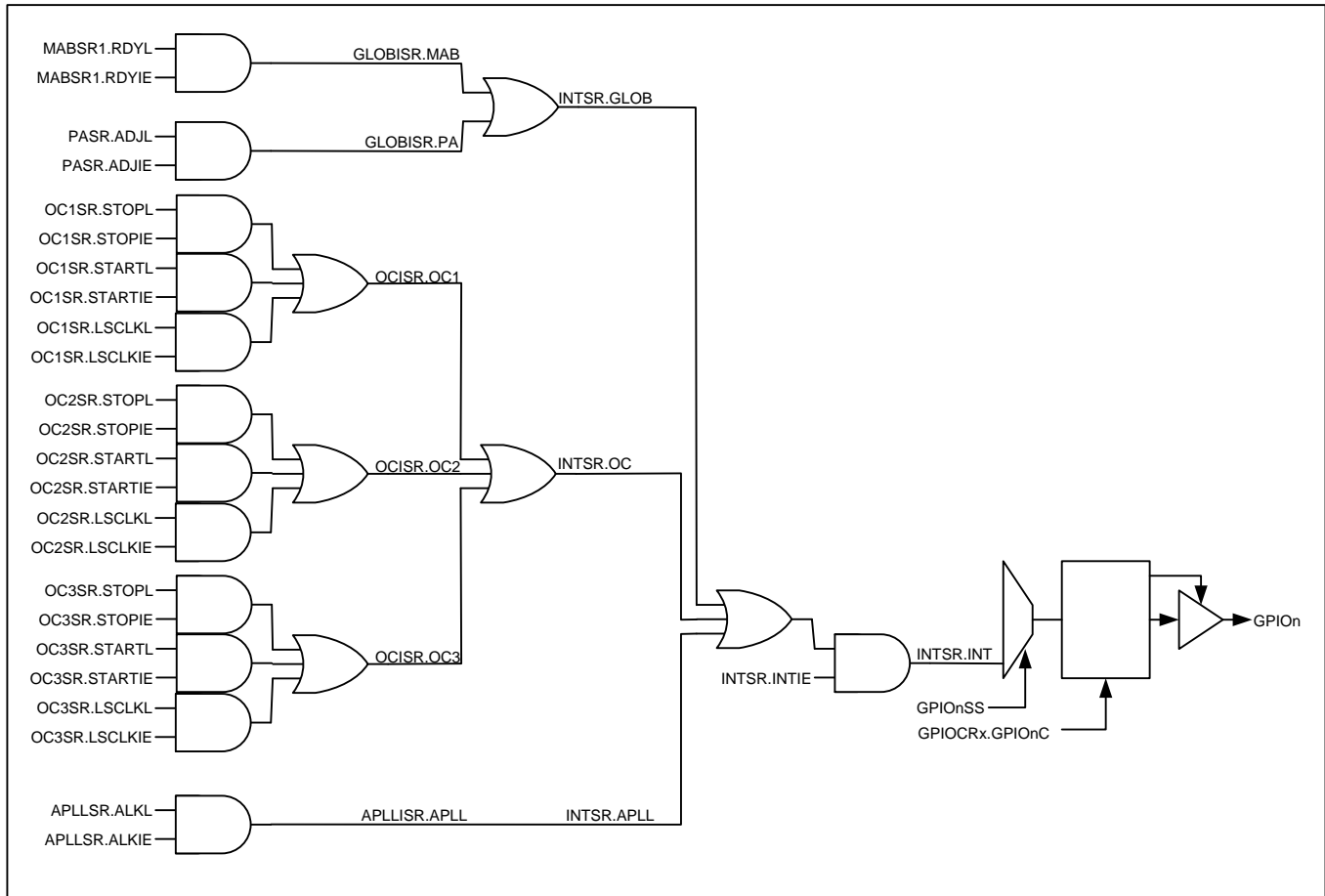
Figure 14 – Interrupt Structure

5.11 Reset Logic

The device has two reset controls: the RSTN pin and the RST bit in MCR1. The RSTN pin asynchronously resets the entire device. When the RSTN pin is low all internal registers are reset to their default values. **The RSTN pin must have one rising edge after power-up.** At initial power-up reset should be asserted for at least 1µs. During operation, the RSTN assertion time can be as short as 1µs with one important exception:

> Consider each of these four pins: AC0/GPIO0, AC1/GPIO1, TEST/GPIO2 and IF1/MISO. If (1) the pin could be an output driving high when RSTN is asserted, and (2) an external pulldown resistor is used to set the at-reset value of the pin, then RSTN should be asserted for 100 milliseconds.

The MCR1.RST bit resets the entire device (except for the microprocessor interface and the RST bit itself), but when the RST bit is active, the register fields with pin-programmed defaults do not latch their values from, or based on, the corresponding input pins. Instead these fields are reset to the default values that were latched when the RSTN pin was last active.

Microsemi recommends holding RSTN low while the internal ring oscillator starts up and stabilizes. An incorrect reset condition could result if RSTN is released before the oscillator has started up completely. After the external oscillator or internal crystal driver circuit has been enabled and stabilized, the master clock can be switched from the ring oscillator to the external oscillator using the MCR1.MCSEL bit.

Important: System software must wait at least 100µs after RSTN is deasserted and wait for GLOBISR.BCDONE=1 before configuring the device.

5.12 Power-Supply Considerations

Due to the multi-power-supply nature of the device, some I/Os have parasitic diodes between a <3.3V supply and a 3.3V supply. When ramping power supplies up or down, care must be taken to avoid forward-biasing these diodes because it could cause latchup. Two methods are available to prevent this. The first method is to place a Schottky diode external to the device between the <3.3V supply and the 3.3V supply to force the 3.3V supply to be within one parasitic diode drop of the <3.3V supply. The second method is to ramp up the 3.3V supply first and then ramp up the <3.3V supply. In some applications VDDOx power supply pins can be at other voltages, such as 2.5V or 1.5V. In these applications the general solution is to ramp up the supplies in order from highest nominal to lowest nominal voltage.

5.13   Auto-Configuration from EEPROM

For the ZL30244, each channel in the device can, optionally, configure itself at reset from an external EEPROM connected to its SPI interface. The EEPROM can store up to three channel configurations, known as configurations 1, 2 and 3. As described in section 5.3.1, IF[1:0] must be 11 at reset, and the configuration to be used is specified by the values of the AC[1:0] pins at reset (1, 2 or 3).

For the ZL30245, each channel's internal EEPROM memory can store up to four channel configurations, known as configurations 0, 1, 2 and 3. As described in section 5.3.2, the configuration to be used is specified by the values of the AC[1:0] pins at reset.

5.13.1 Generating Device Configurations

Device configurations must be generated using the evaluation software. This is true for auto-configurations stored in internal or external EEPROM and for configurations that are written to the device by a system processor. The reason for this requirement is that writes to undocumented registers must be done to tune analog circuitry for optimal performance. The writes to be done depend on integer vs. fractional multiplication, device mode and other factors. The registers involved control very low-level device parameters that are difficult to describe and difficult to understand how to use. Instead the evaluation software has all of the expert knowledge built-in to keep configuration easy for the user.

5.13.2 Direct EEPROM Write Mode (ZL30245 Only)

To simplify writing a channel's internal EEPROM during manufacturing, the device has a test mode known as direct EEPROM write mode. A channel enters this mode when TEST=1 and AC[1:0]=00 on the rising edge of RSTN. In this mode the EEPROM memory is mapped into the channel address map and can be written as needed to store configuration scripts in the device. Channel registers are not accessible in this mode. The channel exits this mode when TEST=0 on the rising edge of RSTN. Note: the device drives the MISO pin continually during this mode. Therefore this mode cannot be used (a) when MOSI and MISO are tied together (as described in the *Design Option: Wiring MOSI and MISO Together* paragraph in section 5.9.1) and/or (b) when the MISO pins of the two channels are tied together.

5.13.3 Holding Other Devices in Reset During Auto-Configuration

Using the appropriate GPIOCR and GPIO0SS registers, a GPIO pin can be configured to follow the GLOBISR.BCDONE status bit. This GPIO can then be used as a reset signal to hold other devices (that use clocks from this device) in reset while a channel configures itself. As an example, to configure GPIO0 to follow BCDONE with 0=reset add the following writes at the beginning of the configuration file: write 0x1F to GPIO0SS and write 0x04 to GPIOCR1.

If needed, GPIOs from the two channels can be wire-ORed together with an external pullup resistor to make a signal that only goes high when both channels are done with auto-configuration. To do this on GPIO0, for example, add the following writes at the beginning of each channel's configuration file: write 0x1F to GPIO0SS and write 0x06 to GPIOCR1. In configuration files, channel B's registers are address offset 0x4000.

5.14 Power Supply Decoupling and Layout Recommendations

Application Note ZLAN-524 describes recommended power supply decoupling and layout practices.

6. Register Descriptions

Each channel has an overall address range from 000h to 1FFh. Table 4 shows the register map. In each register, bit 7 is the MSb and bit 0 is the LSb. Register addresses not listed and bits marked "—" are reserved and must be written with 0. Writing other values to these registers may put the channel in a factory test mode resulting in undefined operation. Bits labeled "0" or "1" must be written with that value for proper operation. Register fields with underlined names are read-only fields; writes to these fields have no effect. All other fields are read-write. Register fields are described in detail in the register descriptions that follow Table 4.

6.1 Register Types

6.1.1 Status Bits

The device has two types of status bits. Real-time status bits are read-only and indicate the state of a signal at the time it is read. Latched status bits are set when a signal changes state (low-to-high, high-to-low, or both, depending on the bit) and cleared when written with a logic 1 value. Writing a 0 has no effect. When set, some latched status bits can cause an interrupt request if enabled to do so by corresponding interrupt enable bits. Status bits marked "—" are reserved and must be ignored.

6.1.2 Configuration Fields

Configuration fields are read-write. During reset, each configuration field reverts to the default value shown in the register definition. Configuration register bits marked "—" are reserved and must be written with 0.

6.1.3 Multiregister Fields

Multiregister fields—such as FREQZ[39:0] in registers DFREQZ1 through DFREQZ5—must be handled carefully to ensure that the bytes of the field remain consistent. A write access to a multiregister field is accomplished by writing all the registers of the field in order from smallest address to largest. Writes to registers other than the last register in the field (i.e. the register with the largest address) are stored in a transfer register. When the last register of the field is written, the entire multiregister field is updated simultaneously from the transfer register. If the last

register of the field is not written, the field is not updated. Any reads from the multiregister field that occur during the middle of the multiregister write will read the existing value of the field not the new value in the transfer register.

A read access from a multiregister field is accomplished by reading the registers of the field in order from smallest address to largest. When the first register in the field (i.e. the register with the lowest address) is read, the entire multiregister field is copied to the transfer register. During subsequent reads from the other registers in the multiregister field, the data comes from the transfer register. Any writes to the multiregister field that occur during the middle of the multiregister read will overwrite values in the transfer register.

Each channel has one write transfer register and one read transfer register that it reuses for all multiregister fields. For proper operation system software should be organized such that only one software process accesses the channel's registers. If two or more processes are allowed to make uncoordinated accesses to the channel's registers, their accesses to multiregister fields could interrupt one another leading to incorrect writes and reads of the multiregister fields.

The multiregister fields are:

Field	Registers	Type
FREQZ[39:0]	DFREQZ1 to DFREQZ5	Read/Write

6.1.4 Bank-Switched Registers (ZL30245 Only)

The EESEL register is a bank-select control field that maps the channel's registers into the memory map at address 0x1 and above when EESEL=0 and maps the EEPROM memory into the memory map at address 0x1 and above when EESEL=1. The EESEL register itself is always in the memory map at address 0x0 for both EESEL=0 and EESEL=1.

6.2 Register Map

Each channel has the following register map. Each channel has its own SPI/I^{2}C interface through which its registers are accessed.

Table 4 - Register Map

ADDR	REGISTER	BIT 7	BIT 6	BIT 5	BIT 4	BIT 3	BIT 2	BIT 1	BIT 0
Global Configuration Registers									
00h	EESEL	—	—	—	—	—	—	—	EESEL
09	MCR1	RST	—	MCSEL1	MCSEL	ROSCD	DBL	XAB[1:0]	
0A	MCR2	—	EXTSS[1:0]		—	—	—	—	—
0B	PLLEN	—	—	—	NCSSEN	—	—	—	APLLEN
0C	ICEN	—	—	—	—	—	IC3EN	IC2EN	IC1EN
0D	OCEN	—	—	—	—	—	OC3EN	OC2EN	OC1EN
0E	GPIOCR1	GPIO1C[3:0]				GPIO0C[3:0]			
0F	GPIOCR2	GPIO3C[3:0]				GPIO2C[3:0]			
12	GPIO0SS	REG[4:0]					BIT[2:0]		
13	GPIO1SS	REG[4:0]					BIT[2:0]		
14	GPIO2SS	REG[4:0]					BIT[2:0]		
15	GPIO3SS	REG[4:0]					BIT[2:0]		
1B	PACR1	RST	TRIG	ARM	—	—	—	TINV	MODE
1C	PACR2	ARMSRC[3:0]				TRGSRC[3:0]			
1D	MABCR1	RST	START	—	—	—	TBSRC[2:0]		
1E	MABCR2	AINV	—	—	ASRC[4:0]				
1F	MABCR3	BINV	—	—	BSRC[4:0]				

ADDR	REGISTER	BIT 7	BIT 6	BIT 5	BIT 4	BIT 3	BIT 2	BIT 1	BIT 0
Status Registers									
30	ID1	IDU[7:0]							
31	ID2	IDL[3:0]				REV[3:0]			
40	CFGSR	TEST	XOFAIL	—	—	IF[1:0]		AC[1:0]	
41	GPIOSR	—	—	—	—	GPIO3	GPIO2	GPIO1	GPIO0
42	INTSR	—	GLOB	OC	—	—	APLL	INTIE	INT
43	GLOBISR	BCDONE	—	—	—	—	—	PA	MAB
45	OCISR	—	—	—	—	—	OC3	OC2	OC1
46	APLLISR	—	—	—	—	—	—	—	APLL
48	APLLSR	—	ALK2IE	ALK2L	ALK2	—	ALKIE	ALKL	ALK
4B	MABSR1	—	OVFL	RDYIE	RDYL	BUSY	MEAS[10:8]		
4C	MABSR2	MEAS[7:0]							
4D	PASR	—	—	—	—	ADJIE	ADJL	BUSY	ARMED
53	OC1SR	LSCLKIE	LSCLKL	LSCLK	STARTIE	STARTL	STOPIE	STOPL	STOPD
54	OC2SR	LSCLKIE	LSCLKL	LSCLK	STARTIE	STARTL	STOPIE	STOPL	STOPD
55	OC3SR	LSCLKIE	LSCLKL	LSCLK	STARTIE	STARTL	STOPIE	STOPL	STOPD
APLL Configuration Registers									
100	APLLCR1	—	—	—	—	—	ENHS2	BYPHS2	—
101	APLLCR2	HSDIV2[3:0]				HSDIV1[3:0]			
102	APLLCR3	—	EXTSW	ALTMUX[2:0]			APLLMUX[2:0]		
103	APLLCR4	DECPH	PDSS[2:0]			INCPH	PISS[2:0]		
106	AFBDIV1	AFBDIV[7:0]							
107	AFBDIV2	AFBDIV[15:8]							
108	AFBDIV3	AFBDIV[23:16]							
109	AFBDIV4	AFBDIV[31:24]							
10A	AFBDIV5	AFBDIV[39:32]							
10B	AFBDIV6	—	—	—	—	—	—	AFBDIV[41:40]	
10C	AFBDEN1	AFBDEN[7:0]							
10D	AFBDEN2	AFBDEN[15:8]							
10E	AFBDEN3	AFBDEN[23:16]							
10F	AFBDEN4	AFBDEN[31:24]							
110	AFBREM1	AFBREM[7:0]							
111	AFBREM2	AFBREM[15:8]							
112	AFBREM3	AFBREM[23:16]							
113	AFBREM4	AFBREM[31:24]							
114	AFBBP	AFBBP[7:0]							
Output Clock Configuration Registers									
	OC1 Registers								
200	OC1CR1	PHEN	MSDIV[6:0]						
201	OC1CR2	—	POL	DRIVE[1:0]		STOPDIS	OCSF[2:0]		
202	OC1CR3	SRLSEN	DIVSEL	NEGLSD	LSSEL	—	—	—	LSDIV[24]
203	OC1DIV1	LSDIV[7:0]							
204	OC1DIV2	LSDIV[15:8]							
205	OC1DIV3	LSDIV[23:16]							
206	OC1DC	OCDC[7:0]							
207	OC1PH	PHADJ[7:0]							
208	OC1STOP	STOP	—	SRC[3:0]				MODE[1:0]	

ADDR	REGISTER	BIT 7	BIT 6	BIT 5	BIT 4	BIT 3	BIT 2	BIT 1	BIT 0
	OC2 Registers								
210	OC2CR1								
…	…				same as OC1 registers				
218	OC2STOP								
	OC3 Registers								
220	OC3CR1								
…	…				same as OC1 registers				
228	OC3STOP								
Input Clock Configuration									
300	IC1CR1	—	POL	—	—	—	—	HSDIV[1:0]	
320	IC2CR1	—	POL	—	—	—	—	HSDIV[1:0]	
340	IC3CR1	—	POL	—	—	—	—	HSDIV[1:0]	
NCO/SS Configuration Registers									
40B	NCSSCR1	—	—	—	—	MODE[3:0]			
420	DFREQZ1	FREQZ[7:0]							
421	DFREQZ2	FREQZ[15:8]							
422	DFREQZ3	FREQZ[23:16]							
423	DFREQZ4	FREQZ[31:24]							
424	DFREQZ5	FREQZ[39:32]							

6.3 Register Definitions

6.3.1 Global Configuration Registers

Register Name: EESEL
Register Description: EEPROM Memory Selection Register
Register Address: 00h

	Bit 7	Bit 6	Bit 5	Bit 4	Bit 3	Bit 2	Bit 1	Bit 0
Name	—	—	—	—	—	—	—	EESEL
Default	0	0	0	0	0	0	0	0

Bit 0: EEPROM Memory Select (EESEL). This bit is a bank-select that specfies whether channel register space or EEPROM memory is mapped into addresses 0x1 and above. This applies only to the ZL30245. The ZL30244 does not have internal EEPROM memory. See sections 5.9 and 6.1.4.
    0 = Channel registers
    1 = Channel EEPROM memory

Register Name: MCR1
Register Description: Master Configuration Register 1
Register Address: 09h

	Bit 7	Bit 6	Bit 5	Bit 4	Bit 3	Bit 2	Bit 1	Bit 0
Name	RST	—	MCSEL1	MCSEL	ROSCD	DBL	XAB[1:0]	
Default	0	0	0	0	0	0	0	0

Bit 7: Channel Reset (RST). When this bit is high the entire channel is held in reset, and all register fields, except the RST bit itself, are reset to their default states. When RST is high, the register fields with pin-programmed defaults do not latch their values from the corresponding input pins. Instead these fields are reset to the default values that were latched from the pins when the channel's RSTN pin was last active. See section 5.11.

      0 = Normal operation
      1 = Reset

Note: For proper sequencing of internal logic, write MCR1 to clear the MCSEL1, MCSEL and ROSCD bits first (without changing the value of the RST bit) then perform a second write to set the RST bit.

Bit 5: NCO/SS Master Clock Select IC1 (MCSEL1). This bit overrides the MCSEL bit to specify IC1 as the source of the NCO/SS block's master clock.
      0 = Master clock selected by MCSEL bit
      1 = Master clock sourced from IC1, which has a divider and a polarity control bit

Bit 4: NCO/SS Master Clock Select (MCSEL). This bit selects the source of the NCO/SS block's master clock. At reset the internal ring oscillator is enabled and selected. When operating the channel in NCO mode or spread spectrum mode, this bit must be set to 1 after the external oscillator connected to the XA pin has stabilized and is ready to use. See section 5.4.4.
      0 = Master clock sourced from internal ring oscillator
      1 = Master clock sourced from the XA pin (optionally through the clock doubler)

Bit 3: Ring Oscillator Disable (ROSCD). This bit disables the ring oscillator. It can be set to 1 when either MCSEL or MCSEL1 is set 1 so that the ring oscillator does not cause unwanted phase noise spurs in output clock signals. See section 5.4.4.
      0 = Enable
      1 = Disable (power-down)

Bit 2: Clock Doubler Enable (DBL). This bit enables the clock doubler for the output of the crystal driver circuitry or the signal on the XA pin. During power-up, system software must wait at least 5ms for the crystal driver circuit to stabilize before enabling the clock doubler. See section 5.4.3.
      0 = Disable (power down)
      1 = Enable

Bits 1 to 0: XA/XB Pin Mode (XAB[1:0]). This field specifies the behavior of the XA and XB pins. See section 5.4.
      00 = Crystal driver and input disabled / powered down
      01 = Crystal driver and input enabled on XA/XB
      10 = XA enabled as single-ended input for external oscillator signal; XB must be left floating
      11 = {unused value}

Register Name: MCR2
Register Description: Master Configuration Register 2
Register Address: 0Ah

	Bit 7	Bit 6	Bit 5	Bit 4	Bit 3	Bit 2	Bit 1	Bit 0
Name	—	EXTSS[1:0]		—	—	—	—	—
Default	0	0	0	0	0	0	0	0

Bits 6 to 5: External Switch Source Select (EXTSS[1:0]). This field selects the GPIO source for the external switch control signal. It is only valid when APLLCR3.EXTSW=1. See section 5.7.1.
      00 = GPIO0
      01 = GPIO1
      10 = GPIO2
      11 = GPIO3

Register Name: PLLEN
Register Description: APLL Enable Register
Register Address: 0Bh

	Bit 7	Bit 6	Bit 5	Bit 4	Bit 3	Bit 2	Bit 1	Bit 0
Name	—	—	—	NCSSEN	—	—	—	APLLEN
Default	0	0	0	0	0	0	0	0

Bit 4: NCO/SS Block Enable (NCSSEN). This field enables or disables the NCO/SS block. See section 5.6. Note that the XA clock source must be properly configured and selected to operate the NCO/SS block.

    0 = Disable (powered down)
    1 = Enable

Bit 0: APLL Enable (APLLEN). This bit enables or disables the APLL. For normal operation the APLL must be enabled. See section 5.7.2.

    0 = Disabled
    1 = Enabled

Register Name: ICEN
Register Description: Input Clock Enable Register
Register Address: 0Ch

	Bit 7	Bit 6	Bit 5	Bit 4	Bit 3	Bit 2	Bit 1	Bit 0
Name	—	—	—	—	—	IC3EN	IC2EN	IC1EN
Default	0	0	0	0	0	0	0	0

Bit 2: Input Clock 3 Enable (IC3EN). This bit enables and disables the input clock 3 differential receiver and input dividers. See section 5.5.

    0 = Disabled
    1 = Enabled

Bit 1: Input Clock 2 Enable (IC2EN). This bit enables and disables the input clock 2 differential receiver and input dividers. See section 5.5.

    0 = Disabled
    1 = Enabled

Bit 0: Input Clock 1 Enable (IC1EN). This bit enables and disables the input clock 1 differential receiver and input dividers. See section 5.5.

    0 = Disabled
    1 = Enabled

Register Name:	OCEN
Register Description:	Output Clock Enable Register
Register Address:	0Dh

	Bit 7	**Bit 6**	**Bit 5**	**Bit 4**	**Bit 3**	**Bit 2**	**Bit 1**	**Bit 0**
Name	—	—	—	—	—	OC3EN	OC2EN	OC1EN
Default	0	0	0	0	0	0	0	0

Bit 2: Output Clock 3 Enable (OC3EN). This bit enables and disables the output clock 3 drivers, output dividers, phase adjustment/alignment circuitry and start/stop circuitry. See section 5.8.1.

    0 = Disabled
    1 = Enabled

Bit 1: Output Clock 2 Enable (OC2EN). This bit enables and disables the output clock 2 drivers, output dividers, phase adjustment/alignment circuitry and start/stop circuitry. See section 5.8.1.

    0 = Disabled
    1 = Enabled

Bit 0: Output Clock 1 Enable (OC1EN). This bit enables and disables the output clock 1 drivers, output dividers, phase adjustment/alignment circuitry and start/stop circuitry. See section 5.8.1.

    0 = Disabled
    1 = Enabled

Register Name: GPIOCR1
Register Description: GPIO Configuration Register 1
Register Address: 0Eh

	Bit 7	Bit 6	Bit 5	Bit 4	Bit 3	Bit 2	Bit 1	Bit 0
Name	GPIO1C[3:0]				GPIO0C[3:0]			
Default	0	0	0	0	0	0	0	0

Bits 7 to 4: GPIO1 Configuration (GPIO1C[3:0]). This field configures the GPIO1 pin as a general-purpose input, a general-purpose output driving low or high, or a status output. The current state of the pin can be read from GPIOSR.GPIO1. When GPIO1 is a status output, the GPIO1SS register specifies which status bit is output.

     0000 = General-purpose input
     0001 = General-purpose input - inverted polarity
     0010 = General-purpose output driving low
     0011 = General-purpose output driving high
     0100 = Status output – non-inverted polarity
     0101 = Status output - inverted polarity of the status bit it follows
     0110 = Status output – 0 drives low, 1 high impedance
     0111 = Status output – 0 high impedance, 1 drives low
     1000 to 1111 = {unused values}

Bits 3 to 0: GPIO0 Configuration (GPIO0C[3:0]). This field configures the GPIO0 pin as a general-purpose input, a general-purpose output driving low or high, or a status output. The current state of the pin can be read from GPIOSR.GPIO0. When GPIO0 is a status output, the GPIO0SS register specifies which status bit is output.

     0000 = General-purpose input
     0001 = General-purpose input - inverted polarity
     0010 = General-purpose output driving low
     0011 = General-purpose output driving high
     0100 = Status output – non-inverted polarity
     0101 = Status output - inverted polarity of the status bit it follows
     0110 = Status output – 0 drives low, 1 high impedance
     0111 = Status output – 0 high impedance, 1 drives low
     1000 to 1111 = {unused values}

Register Name: GPIOCR2
Register Description: GPIO Configuration Register 2
Register Address: 0Fh

	Bit 7	Bit 6	Bit 5	Bit 4	Bit 3	Bit 2	Bit 1	Bit 0
Name	GPIO3C[3:0]				GPIO2C[3:0]			
Default	0	0	0	0	0	0	0	0

These fields are identical to those in GPIOCR1 except they control GPIO2 and GPIO3.

Register Name: GPIO0SS
Register Description: GPIO0 Status Select Register
Register Address: 12h

	Bit 7	Bit 6	Bit 5	Bit 4	Bit 3	Bit 2	Bit 1	Bit 0
Name			REG[4:0]				BIT[2:0]	
Default	0	0	0	0	0	0	0	0

Bits 7 to 3: Status Register (REG[4:0]). When GPIOCR1.GPIO0C=01xx, this field specifies the register of the status bit that GPIO0 will follow while the BIT field below specifies the status bit within the register. Setting the combination of this field and the BIT field below to follow a bit that isn't implemented as a real-time or latched status register bit results in GPIO0 being driven low. The address of the status bit that GPIO0 follows is 0x40 + REG[4:0]

Bits 2 to 0: Status Bit (BIT[2:0]). When GPIOCR1.GPIO0C=01xx, the REG field above specifies the register of the status bit that GPIO0 will follow while this field specifies the status bit within the register. Setting the combination of the REG field and this field to follow a bit that isn't implemented as a real-time or latched status register bit results in GPIO1 being driven low. 000=bit 0 of the register. 111=bit 7 of the register.

Note: The device does not allow the GPIO status register bits in GPIOSR to be followed by a GPIO.

Register Name: GPIO1SS
Register Description: GPIO1 Status Select Register
Register Address: 13h

	Bit 7	Bit 6	Bit 5	Bit 4	Bit 3	Bit 2	Bit 1	Bit 0
Name			REG[4:0]				BIT[2:0]	
Default	0	0	0	0	0	0	0	0

These fields are identical to those in GPIO0SS except they control GPIO1.

Register Name: GPIO2SS
Register Description: GPIO2 Status Select Register
Register Address: 14h

	Bit 7	Bit 6	Bit 5	Bit 4	Bit 3	Bit 2	Bit 1	Bit 0
Name			REG[4:0]				BIT[2:0]	
Default	0	0	0	0	0	0	0	0

These fields are identical to those in GPIO0SS except they control GPIO2.

Register Name: GPIO3SS
Register Description: GPIO3 Status Select Register
Register Address: 15h

	Bit 7	Bit 6	Bit 5	Bit 4	Bit 3	Bit 2	Bit 1	Bit 0
Name			REG[4:0]				BIT[2:0]	
Default	0	0	0	0	0	0	0	0

These fields are identical to those in GPIO0SS except they control GPIO3.

Register Name: PACR1
Register Description: Phase Adjust Configuration Register 1
Register Address: 1Bh

	Bit 7	Bit 6	Bit 5	Bit 4	Bit 3	Bit 2	Bit 1	Bit 0
Name	RST	TRIG	ARM	—	—	—	TINV	MODE
Default	0	0	0	0	0	0	0	0

Bit 7: Phase Adjustment Reset Bit (RST). This bit is used to reset the phase adjustment state machine. This is used to abort the phase adjustment after arming but before the trigger occurs. Resetting puts the state machine back to waiting for an arm signal. This bit is self-clearing. See section 5.8.4.
    1 = Reset a phase adjustment event in progress, self clearing

Bit 6: Phase Adjustment Trigger Bit (TRIG). This bit is used to trigger the phase adjustment event when PACR2.TRGSRC=0000 and the phase adjustment has been armed. This bit is self-clearing and must be written again to cause another trigger. When the ARM bit and TRIG bit are selected as the sources for arming and triggering, respectively, the ARM bit must be set first then the TRIG bit can be set in a subsequent register write to initiate a trigger event. See section 5.8.4.
    1 = Trigger a phase adjustment, self clearing

    Note: For (1) phase adjustment when any OCx output's MSDIV period is less than master clock period, or (2) phase alignment when the channel is in APLL-only mode and any OCx output has MSDIV period + 7 x HSDIV period < 15.38ns, this bit may or may not self-clear depending on exact channel configuration and therefore must be cleared by system software for proper operation.

Bit 5: Phase Adjustment Arm Bit (ARM). When PACR2.ARMSRC=0001, setting this bit to 1 while PASR.ARMED=0 arms the phase adjustment. Writing a 0 to this bit has no effect. Changing the value of this bit from 0 to 1 while PASR.ARMED=1 has no effect. TSee section 5.8.4.
    1 = Arm the phase adjustment, self clearing

Bit 1: Phase Adjustment Trigger Invert (TINV). This bit specifies the polarity of the trigger signal. See section 5.8.4.
    0 = Trigger signal normal polarity
    1 = Trigger signal inverted

Bit 0: Phase Adjust/Alignment Mode (MODE). This field sets the mode of the phase change. In output phase *alignment* mode, the channel resets the MSDIV and LSDIV dividers for all participating outputs so that they are all aligned and then adjusts the phase of each participating output as specified in the OCxPH register. In output phase *adjustment* mode the channel does not reset the MSDIV and LSDIV dividers and therefore causes each participating output to have the phase adjustment specified in the OCxPH register relative to that output's previous phase. See section 5.8.4.
    0 = Phase alignment mode
    1 = Phase adjustment mode

Register Name: PACR2
Register Description: Phase Adjust Configuration Register 2
Register Address: 1Ch

	Bit 7	Bit 6	Bit 5	Bit 4	Bit 3	Bit 2	Bit 1	Bit 0
Name	ARMSRC[3:0]				TRGSRC[3:0]			
Default	0	0	0	0	0	0	0	0

Bits 7 to 4: Output Phase Adjustment Arm Source (ARMSRC[3:0]). This field selects the source of the phase adjustment arming signal. See section 5.8.4.

      0000 = Always armed (see Note)
      0001 = PACR1.ARM bit (one-shot)
      0010 = APLL transition from unlocked to locked
      0011 to 0111 = {unused values}
      1000 = GPIO0 transition (see note below)
      1001 = GPIO1 transition
      1010 = GPIO2 transition
      1011 = GPIO3 transition
      1100 to 1111 = {unused values}

      Note: When using always armed, any change to the PACR1 or PACR2 registers or any change to the OCxCR1.PHEN bits must be followed by a reset of the phase adjustment state machine (set PACR1.RST=1).

Bits 3 to 0: Output Phase Adjustment Trigger Source (TRGSRC[3:0]). This field selects the source of the phase adjustment trigger signal. The phase adjustment must be armed or the trigger signal is ignored. The trigger source transition initiates the phase adjustment event. See section 5.8.4.

      0000 = PACR1.TRIG bit
      0001 = APLL transition from unlocked to locked
      0010 to 0111 = {unused values}
      1000 = GPIO0 transition (see note below)
      1001 = GPIO1 transition
      1010 = GPIO2 transition
      1011 = GPIO3 transition
      1100 to 1111 = {unused values}

Note: In both fields above the GPIO transitions are 0-to-1 when GPIOCR1.GPIOxC=0000 and 1-to-0 when GPIOCR1.GPIOxC=0001.

Register Name: MABCR1
Register Description: Measure A-to-B Configuration Register 1
Register Address: 1Dh

	Bit 7	Bit 6	Bit 5	Bit 4	Bit 3	Bit 2	Bit 1	Bit 0
Name	RST	START	—	—	—	TBSRC[2:0]		
Default	0	0	0	0	0	0	0	0

Bit 7: Measurement Reset (RST). This field stops the current A-to-B phase measurement. This bit is self clearing. See section 5.8.6.
      1 = Stop measurement (self-clearing)

Bit 6: Measurement Start (START). This field starts a new A-to-B phase measurement. This bit is self clearing. See section 5.8.6.
      1= Start new measurement (self-clearing)

Bits 2 to 0: Measurement Time Base Source (TBSRC[2:0]). This field selects the source of the measurement time base. See section 5.8.6.
      000 = {reserved value, do not use}
      001 = Medium-speed divider 1 (MSDIV1) output clock
      010 = Medium-speed divider 2 (MSDIV2) output clock
      011 = Medium-speed divider 3 (MSDIV3) output clock

Register Name: MABCR2
Register Description: Measure A-to-B Configuration Register 2
Register Address: 1Eh

	Bit 7	Bit 6	Bit 5	Bit 4	Bit 3	Bit 2	Bit 1	Bit 0
Name	AINV	—	—	ASRC[4:0]				
Default	0	0	0	0	0	0	0	0

Bit 7: Measurement Input A Invert (AINV). This field inverts the signal of measurement input A. See section 5.8.6.
      0 = Measure to and from rising edge of input A
      1 = Measure to and from falling edge of input A

Bits 4 to 0: Measurement Input A Source (ASRC[4:0]). This field selects the source of measurement input A. See section 5.8.6.
      00000 = IC1
      00001 = IC2
      00010 = IC3
      01000 = GPIO0
      01001 = GPIO1
      01010 = GPIO2
      01011 = GPIO3
      10000 = OC1
      10001 =OC2
      10010 = OC3

Register Name: MABCR3
Register Description: Measure A to B Configuration Register 3
Register Address: 1Fh

	Bit 7	Bit 6	Bit 5	Bit 4	Bit 3	Bit 2	Bit 1	Bit 0
Name	BINV	—	—			BSRC[4:0]		
Default	0	0	0	0	0	0	0	0

Bit 7: Measurement Input B Invert (BINV). This field inverts the signal of measurement input B. See section 5.8.6.

    0 = Measure to and from rising edge of input B
    1 = Measure to and from falling edge of input B

Bits 4 to 0: Measurement Input B Source (BSRC[4:0]). This field selects the source of measurement input B. See section 5.8.6.

    00000 = IC1
    00001 = IC2
    00010 = IC3
    01000 = GPIO0
    01001 = GPIO1
    01010 = GPIO2
    01011 = GPIO3
    10000 = OC1
    10001 = OC2
    10010 = OC3

6.3.2 Status Registers

Register Name: ID1
Register Description: Device Identification Register, MSB
Register Address: 30h

	Bit 7	Bit 6	Bit 5	Bit 4	Bit 3	Bit 2	Bit 1	Bit 0
Name				IDU[7:0]				
Default	0	0	0	1	1	0	0	1

Bits 7 to 0: Device ID Upper (IDU[7:0]). This field is the upper eight bits of the device ID. Each channel has the same value.

Register Name: ID2
Register Description: Device Identification Register, LSB and Revision
Register Address: 31h

	Bit 7	Bit 6	Bit 5	Bit 4	Bit 3	Bit 2	Bit 1	Bit 0
Name		IDL[3:0]				REV[3:0]		
Default		See below			0	0	0	1

Bits 7 to 4: Device ID Lower (IDL[3:0]). This field is the lower four bits of the device ID. Each channel has the same value.

    ZL30244 = 0100
    ZL30245 = 0110

Bits 3 to 0: Device Revision (REV[3:0]). These bits are the device hardware revision starting at 0.

Register Name: CFGSR
Register Description: Configuration Status Register
Register Address: 40h

	Bit 7	Bit 6	Bit 5	Bit 4	Bit 3	Bit 2	Bit 1	Bit 0
Name	TEST	XOFAIL	—	—	IF[1:0]		AC[1:0]	
Default	see below	0	0	0	see below	see below	see below	see below

Bit 7: Test Mode (TEST). This read-only bit is the latched state of the TEST/GPIO2 pin when the RSTN pin transitions high. For proper operation it should be 0. See section 5.3.

Bit 6: XO Fail (XOFAIL). This read-only bit is set when the external oscillator signal on the XA pin fails or when the crystal connected to the XA/XB pins fails to oscillate.

Bits 3 to 2: Interface Mode (IF[1:0]). These read-only bits are the latched state of the IF1/MISO and IF0/CSN pins when the RSTN pin transitions high. See section 5.3.

Bits 1 to 0: Auto-Configuration (AC[1:0]). These read-only bits are the latched state of the AC1/GPIO1 and AC0/GPIO0 pins when the RSTN pin transitions high. See section 5.3.

Register Name: GPIOSR
Register Description: GPIO Status Register
Register Address: 41h

	Bit 7	Bit 6	Bit 5	Bit 4	Bit 3	Bit 2	Bit 1	Bit 0
Name	—	—	—	—	GPIO3	GPIO2	GPIO1	GPIO0
Default	0	0	0	0	0	0	0	0

Bit 3: GPIO3 State (GPIO3). This real-time status bit indicates the current state of the GPIO3 pin, not influenced by any inversion that may be specified by GPIOCR2.GPIO3C.
    0 = low
    1 = high

Bit 2: GPIO2 State (GPIO2). This real-time status bit indicates the current state of the GPIO2 pin, not influenced by inversion that may be specified by GPIOCR2.GPIO2C.
    0 = low
    1 = high

Bit 1: GPIO1 State (GPIO1). This real-time status bit indicates the current state of the GPIO1 pin, not influenced by inversion that may be specified by GPIOCR1.GPIO1C.
    0 = low
    1 = high

Bit 0: GPIO0 State (GPIO0). This real-time status bit indicates the current state of the GPIO0 pin, not influenced by inversion that may be specified by GPIOCR1.GPIO0C.
    0 = low
    1 = high

Register Name: INTSR
Register Description: Interrupt Status Register
Register Address: 42h

	Bit 7	Bit 6	Bit 5	Bit 4	Bit 3	Bit 2	Bit 1	Bit 0
Name	—	GLOB	OC	—	—	APLL	INTIE	INT
Default	0	0	0	0	0	0	0	0

Bit 6: Global Interrupt Status (GLOB). This read-only bit is set if any of the global interrupt status bits are set in the GLOBISR register. See section 5.10.

Bit 5: Output Clock Interrupt Status (OC). This read-only bit is set if any of the output clock interrupt status bits are set in the OCISR register. See section 5.10.

Bit 2: APLL Interrupt Status (APLL). This read-only bit is set if any of the APLL interrupt status bits are set in the APLLISR register. See section 5.10.

Bit 1: Interrupt Enable Bit (INTIE). This is the global interrupt enable bit. When this bit is 0 all interrupt sources are prevented from setting the INT global interrupt status bit (below). See section 5.10.
       0 = Interrupts are disabled at the global level
       1 = Interrupts are enabled at the global level

Bit 0: Interrupt Status (INT). This read-only bit is set when any of the GLOB, OC or APLL bits in this INTSR register are set and the INTIE bit is set. This bit can cause an interrupt request when set by configuring one of the GPIO pins to follow it. See section 5.10.
       0 = No interrupt
       1 = An unmasked interrupt source is active

Register Name: GLOBISR
Register Description: Global Functions Interrupt Status Register
Register Address: 43h

	Bit 7	Bit 6	Bit 5	Bit 4	Bit 3	Bit 2	Bit 1	Bit 0
Name	BCDONE	—	—	—	—	—	PA	MAB
Default	see below	0	0	0	0	0	0	0

Bit 7: Boot Controller Done (BCDONE). This bit indicates the status of the channel's boot controller, which performs auto-configuration from EEPROM. It is cleared when the channel is reset and set after the boot controller finishes auto-configuration of the channel. See section 5.13.

Bit 1: Phase Adjust Interrupt Status (PA). This bit indicates the current status of the interrupt sources from the phase adjust function (see section 5.8.4). It is set when any latched status bit in the PASR register is set and the associated interrupt enable bit is also set. See section 5.10.

Bit 0: Measure AB Interrupt Status (MAB). This bit indicates the current status of the interrupt sources from the A-to-B phase offset measurement function (see section 5.8.6). It is set when any latched status bit in the MABSR1 register is set and the associated interrupt enable bit is also set. See section 5.10.

Register Name: OCISR
Register Description: Output Clock Interrupt Status Register
Register Address: 45h

	Bit 7	Bit 6	Bit 5	Bit 4	Bit 3	Bit 2	Bit 1	Bit 0
Name	—	—	—	—	—	OC3	OC2	OC1
Default	0	0	0	0	0	0	0	0

Bit 2: Output Clock 3 Interrupt Status (OC3). This bit indicates the current status of the interrupt sources for OC3. It is set when any latched status bit in the OC3SR register is set and the associated interrupt enable bit is also set. See section 5.10.

Bit 1: Output Clock 2 Interrupt Status (OC2). This bit indicates the current status of the interrupt sources for OC2. It is set when any latched status bit in the OC2SR register is set and the associated interrupt enable bit is also set. See section 5.10.

Bit 0: Output Clock 1 Interrupt Status (OC1). This bit indicates the current status of the interrupt sources for OC1. It is set when any latched status bit in the OC1SR register is set and the associated interrupt enable bit is also set. See section 5.10.

Register Name: APLLISR
Register Description: APLL Interrupt Status Register
Register Address: 46h

	Bit 7	Bit 6	Bit 5	Bit 4	Bit 3	Bit 2	Bit 1	Bit 0
Name	—	—	—	—	—	—	—	APLL
Default	0	0	0	0	0	0	0	0

Bit 0: APLL Interrupt Status (APLL). This bit indicates the current status of the interrupt sources for the APLL. It is set when any latched status bit in the APLLSR register is set and the associated interrupt enable bit is also set. See section 5.10.

Register Name: APLLSR
Register Description: APLL Status Register
Register Address: 48h

	Bit 7	Bit 6	Bit 5	Bit 4	Bit 3	Bit 2	Bit 1	Bit 0
Name	—	ALK2IE	ALK2L	ALK2	—	ALKIE	ALKL	ALK
Default	0	0	0	0	0	0	0	0

Bit 6: APLL Lock 2 Interrupt Enable (ALK2IE). This bit enables the ALK2L latched status bit to send an interrupt request into the channel's interrupt logic.

     0 = Interrupt is disabled
     1 = Interrupt is enabled

Bit 5: APLL Lock 2 Latched Status (ALK2L). This latched status bit is set to 1 when the ALK2 status bit changes state (set or cleared). ALK2L is cleared when written with a 1. When ALK2L is set it can cause an interrupt request if the ALK2IE interrupt enable bit is set.

Bit 4: APLL Lock Status 2 (ALK2). This real-time status bit provides one type of APLL lock status. System software should consider the APLL locked when ALK (bit 0) is set to 1 AND ALK2=1. See section 5.7.

Bit 2: APLL Lock Interrupt Enable (ALKIE). This bit enables the ALKL latched status bit to send an interrupt request into the channel's interrupt logic.

     0 = Interrupt is disabled
     1 = Interrupt is enabled

Bit 1: APLL Lock Latched Status (ALKL). This latched status bit is set to 1 when the ALK status bit changes state (set or cleared). ALKL is cleared when written with a 1. When ALKL is set it can cause an interrupt request if the ALKIE interrupt enable bit is set.

Bit 0: APLL Lock Status (ALK). This real-time status bit indicates one type of APLL lock status. System software should consider the APLL locked when ALK=1 AND ALK2 (bit 4) is set to 1. See section 5.7.

     0 = Not locked
     1 = Locked

Register Name: MABSR1
Register Description: Measure A to B Status Register 1
Register Address: 4Bh

	Bit 7	Bit 6	Bit 5	Bit 4	Bit 3	Bit 2	Bit 1	Bit 0
Name	—	OVFL	RDYIE	RDYL	BUSY	MEAS[10:8]		
Default	0	0	0	0	0	0	0	0

Bit 6: Measurement Overflow (OVFL). This latched status bit is set when the phase measurement is ready and an overflow has occurred. See section 5.8.6.

     0 = No measurement overflow, MEAS is a valid value
     1 = A measurement overflow occured, MEAS is not a valid value

Bit 5: Measurement Ready Interrupt Enable (RDYIE). This bit enables the RDYL latched status bit to send an interrupt request into the channel's interrupt logic.

     0 = Interrupt is disabled
     1 = Interrupt is enabled

Bit 4: Measurement Ready (RDYL). This latched status bit is set when a new phase measurement is ready. See section 5.8.6.

     0 = New measurement not ready
     1 = A new measurement in MEAS is ready

Bit 3: Measurement Busy (BUSY). This real-time status bit is set when a new phase measurement is being performed. See section 5.8.6.

     0 = A measurement is not being performed
     1 = A measurement is being performed

Bits 2 to 0: Measurement Value (MEAS[10:8]). See the MABSR2 register description.

Register Name: MABSR2
Register Description: Measure A to B Status Register 2
Register Address: 4Ch

	Bit 7	Bit 6	Bit 5	Bit 4	Bit 3	Bit 2	Bit 1	Bit 0
Name	MEAS[7:0]							
Default	0	0	0	0	0	0	0	0

Bits 7 to 0: Measurement Value (MEAS[7:0]). The full 11-bit MEAS[10:0] field spans this register and the lower bits of MABSR1. The format is two's-complement. This field indicates the result of the A-to-B measurement when BUSY=0, RDYL=1 and OVFL=0. Its value is in units of the selected timebase period and has a range of +1023 to -1024 periods. See section 5.8.6.

Register Name: PASR
Register Description: Phase Adjust Status Register
Register Address: 4Dh

	Bit 7	Bit 6	Bit 5	Bit 4	Bit 3	Bit 2	Bit 1	Bit 0
Name	—	—	—	—	ADJIE	ADJL	BUSY	ARMED
Default	1	0	0	0	0	1	0	0

Bit 3: Phase Adjustment Finished Interrupt Enable (ADJIE). This bit enables the ADJL latched status bit to send an interrupt request into the channel's interrupt logic.

    0 = Interrupt is disabled
    1 = Interrupt is enabled

Bit 2: Phase Adjustment Finished (ADJL). This latched status bit is set when the output phase adjustment is completed for all participating outputs. Writing a 1 to this bit clears it. See section 5.8.4.

    0 = Output phase adjustment has not completed
    1 = Output phase adjustment has completed

    Note: For (1) phase adjustment when any OCx output's MSDIV period is less than master clock period, or (2) phase alignment when the channel is in APLL-only mode and any OCx output has MSDIV period + 7 x HSDIV period < 15.38ns, this bit may or may not be set depending on exact channel configuration and therefore should not be checked by system software. Instead the state of the BUSY real-time bit (bit 1) should be checked.

Bit 1: Phase Adjustment Busy (BUSY). This bit is a real-time status that indicates that the output phase adjustment has been triggered and is in progress on the participating outputs. See section 5.8.4.

    0 = Output phase adjustment is not in progress
    1 = Output phase adjustment is in progress

Bit 0: Phase Adjustment Armed (ARMED). This bit is a real-time status that indicates that the output phase adjustment is armed and waiting for a trigger. It is cleared when the trigger event occurs. See section 5.8.4.

    0 = Output phase adjustment is not armed
    1 = Output phase adjustment is armed

Register Name: OCxSR
Register Description: Output Clock x Status Register
Register Address: OC1: 53h, OC2: 54h, OC3: 55h

	Bit 7	Bit 6	Bit 5	Bit 4	Bit 3	Bit 2	Bit 1	Bit 0
Name	LSCLKIE	LSCLKL	LSCLK	STARTIE	STARTL	STOPIE	STOPL	STOPD
Default	0	0	0	0	see note	0	see note	see note

Bit 7: (LSCLKIE). This bit enables the LSCLKL latched status bit to send an interrupt request into the channel's interrupt logic.
> 0 = Interrupt is disabled
> 1 = Interrupt is enabled

Bit 6: (LSCLKL). This latched status bit is set when the low-speed divider output clock transitions low-to-high. Writing a 1 to this bit clears it.
> 0 = Low speed output clock has not transitioned low to high
> 1 = Low speed output clock has transitioned low to high

Bit 5: (LSCLK). This real-time status bit follows the level of the low-speed divider output clock when the OCxCR3.SRLSEN bit is set.
> 0 = LSCLK is high
> 1 = LSCLK is low

Bit 4: (STARTIE). This bit enables the STARTL latched status bit to send an interrupt request into the channel's interrupt logic.
> 0 = Interrupt is disabled
> 1 = Interrupt is enabled

Bit 3: (STARTL). This latched status bit is set when the output clock signal has been started after being stopped. Writing a 1 to this bit clears it. See section 5.8.5.
> 0 = Output clock signal has not resumed from being stopped
> 1 = Output clock signal has resumed from being stopped

Bit 2: (STOPIE). This bit enables the STOPL latched status bit to send an interrupt request into the channel's interrupt logic.
> 0 = Interrupt is disabled
> 1 = Interrupt is enabled

Bit 1: (STOPL). This latched status bit is set when the output clock signal has been stopped. Writing a 1 to this bit clears it. See section 5.8.5.
> 0 = Output clock signal has not stopped
> 1 = Output clock signal has stopped

Bit 0: (STOPD). This real-time status bit is high when the output clock signal is stopped and low when the output clock is not stopped. See section 5.8.5.
> 0 = Output clock signal is not stopped
> 1 = Output clock signal is stopped

Note: STARTL,STOPL and STOPD are controlled by logic that does not have a clock at reset. Therefore their reset values are indeterminate. They will become 0 when the output clock path is configured and one of the high-speed clocks from the APLL is connected to the logic.

6.3.3 APLL Configuration Registers

Register Name: APLLCR1
Register Description: APLL Configuration Register 1
Register Address: 100h

	Bit 7	Bit 6	Bit 5	Bit 4	Bit 3	Bit 2	Bit 1	Bit 0
Name	—	—	—	—	—	ENHS2	BYPHS2	—
Default	0	0	0	0	0	0	0	0

Bit 2: Enable High-Speed Divider 2 (ENHS2). This bit is an enable/disable control for HSDIV2. When HSDIV2 is disabled, power consumption is reduced as shown in Table 6. HSDIV2 is enabled when PLLEN.APLLEN=1, ENHS2=1 and APLLCR1.BYPHS2=0.
     0 = Disable
     1 = Enable

Bit 1: Bypass APLL and High-Speed Divider 2 (BYPHS2). This bit controls the mux immediately to the right of HSDIV2 in Figure 1. The mux that provides the bypass signal to this mux is controlled by APLLMUX and related fields in APLLCR3.
     0 = No bypass
     1 = Bypass

Register Name: APLLCR2
Register Description: APLL Configuration Register 2
Register Address: 101h

	Bit 7	Bit 6	Bit 5	Bit 4	Bit 3	Bit 2	Bit 1	Bit 0
Name	HSDIV2[3:0]				HSDIV1[3:0]			
Default	0	0	0	0	0	0	0	0

Bits 7 to 4: APLL High-Speed Divider 2 (HSDIV2[3:0]). This field controls the APLL's high-speed divider 2 block (see Figure 6). See section 5.7.2.
     0000 = Divide by 4   1000 = Divide by 8
     0001 = Divide by 4.5   1001 = Divide by 9
     0010 = Divide by 5   1010 = Divide by 10
     0011 = Divide by 5.5   1011 = Divide by 11
     0100 = Divide by 6   1100 = Divide by 12
     0101 = Divide by 6.5   1101 = Divide by 13
     0110 = Divide by 7   1110 = Divide by 14
     0111 = Divide by 7.5   1111 = Divide by 15

Bits 3 to 0: APLL High-Speed Divider 1 (HSDIV1[3:0]). This field controls the APLL's high-speed divider 1 block (see Figure 6). See section 5.7.2.
     0000 = Divide by 4   1000 = Divide by 8
     0001 = Divide by 4.5   1001 = Divide by 9
     0010 = Divide by 5   1010 = Divide by 10
     0011 = Divide by 5.5   1011 = Divide by 11
     0100 = Divide by 6   1100 = Divide by 12
     0101 = Divide by 6.5   1101 = Divide by 13
     0110 = Divide by 7   1110 = Divide by 14
     0111 = Divide by 7.5   1111 = Divide by 15

Register Name: APLLCR3
Register Description: APLL Configuration Register 3
Register Address: 102h

	Bit 7	Bit 6	Bit 5	Bit 4	Bit 3	Bit 2	Bit 1	Bit 0
Name	—	EXTSW	ALTMUX[2:0]			APLLMUX[2:0]		
Default	0	0	0	0	0	0	0	0

Bit 6: APLL External Switching Mode (EXTSW). This bit enables APLL external reference switching mode. In this mode, if the selected GPIO signal is low the APLL input mux is controlled by APLLCR3.APLLMUX. If the selected GPIO signal is high the APLL input mux is controlled by APLLCR3.ALTMUX. MCR2.EXTSS specifies which GPIO pin controls this behavior. See section 5.7.1

Bits 5 to 3: APLL Alternate Mux Control (ALTMUX[2:0]). When APLLCR3.EXTSW=0 this field is ignored. When APLLCR3.EXTSW=1 and the selected GPIO signal is high, this field controls the APLL input muxes. See section 5.7.1.
>   000 = Crystal driver circuit if crystal is connected, otherwise XA input
>   (clock frequency can be 2x if clock doubler enabled by MCR1.DBL=1)
>   001 = IC1 input
>   010 = IC2 input
>   011 = IC3 input
>   100-111 = {unused values}

Bits 2 to 0: APLL Mux Control (APLLMUX[2:0]). By default this field controls the APLL input muxes. When APLLCR3.EXTSW=1 and the selected GPIO signal is high, this field is ignored, and the APLL's clock source is specified by APLLCR3.ALTMUX. See section 5.7.1.
>   000 = Crystal driver circuit if crystal is connected, otherwise XA input
>   (clock frequency can be 2x if clock doubler enabled by MCR1.DBL=1)
>   001 = IC1 input
>   010 = IC2 input
>   011 = IC3 input
>   110 = NCO/SS output to the APLL, XA (optionally doubled) sent to the bypass mux
>   111 = NCO/SS output to the APLL, no signal sent to the bypass mux (set APLLCR1.BYPHS2=0)
>
>   The following decodes are for applications where the NCO/SS master clock comes from IC1 rather than XA (MCR1.MCSEL1=1).
>   100 = NCO/SS output to the APLL, IC1 sent to the bypass mux
>   101 = NCO/SS output to the APLL, no signal sent to the bypass mux (set APLLCR1.BYPHS2=0)

Register Name: APLLCR4
Register Description: APLL Configuration Register 4
Register Address: 103h

	Bit 7	Bit 6	Bit 5	Bit 4	Bit 3	Bit 2	Bit 1	Bit 0
Name	DECPH		PDSS[2:0]		INCPH		PISS[2:0]	
Default	0	0	0	0	0	0	0	0

Bit 7: Decrement Phase (DECPH). When PDSS=000, this bit is the APLL phase decrement control signal. See section 5.7.3.

Bits 6 to 4: Phase Decrement Source Select (PDSS[2:0]). This field specifies the APLL phase decrement control signal. Every low-to-high transition and every high-to-low transition of the signal decrements the APLL's output phase. See section 5.7.3.

    000 = DECPH bit
    001 = GPIO0
    010 = GPIO1
    011 = GPIO2
    100 = GPIO3
    101 to 111 = {unused values}

Bit 3: Increment Phase (INCPH). When PISS=000, this bit is the APLL phase increment control signal. See section 5.7.3.

Bits 2 to 0: Phase Increment Source Select (PISS[2:0]). This field specifies the APLL phase increment control signal. Every low-to-high transition and every high-to-low transition of the signal increments the APLL's output phase. See section 5.7.3.

    000 = INCPH bit
    001 = GPIO0
    010 = GPIO1
    011 = GPIO2
    100 = GPIO3
    101 to 111 = {unused values}

Register Name: AFBDIV1
Register Description: APLL Feedback Divider Register 1
Register Address: 106h

	Bit 7	Bit 6	Bit 5	Bit 4	Bit 3	Bit 2	Bit 1	Bit 0
Name	AFBDIV[7:0]							
Default	0	0	0	0	0	0	0	0

Bits 7 to 0: APLL Feedback Divider Register (AFBDIV[7:0]). The full 42-bit AFBDIV[41:0] field spans the AFBDIV1 through AFBDIV6 registers. AFBDIV is an unsigned number with 9 integer bits (AFBDIV[41:33]) and up to 33 fractional bits. AFBDIV specifies the fixed-point term of the APLL's fractional feedback divide value. The value AFBDIV=0 is undefined. Unused least significant bits must be written with 0. See section 5.7.2.

Register Name: AFBDIV2
Register Description: APLL Feedback Divider Register 2
Register Address: 107h

	Bit 7	Bit 6	Bit 5	Bit 4	Bit 3	Bit 2	Bit 1	Bit 0
Name				AFBDIV[15:8]				
Default	0	0	0	0	0	0	0	0

Bits 7 to 0: APLL Feedback Divider Register (AFBDIV[15:8]). See the AFBDIV1 register description.

Register Name: AFBDIV3
Register Description: APLL Feedback Divider Register 3
Register Address: 108h

	Bit 7	Bit 6	Bit 5	Bit 4	Bit 3	Bit 2	Bit 1	Bit 0
Name				AFBDIV[23:16]				
Default	0	0	0	0	0	0	0	0

Bits 7 to 0: APLL Feedback Divider Register (AFBDIV[23:16]). See the AFBDIV1 register description.

Register Name: AFBDIV4
Register Description: APLL Feedback Divider Register 4
Register Address: 109h

	Bit 7	Bit 6	Bit 5	Bit 4	Bit 3	Bit 2	Bit 1	Bit 0
Name				AFBDIV[31:24]				
Default	0	0	0	0	0	0	0	0

Bits 7 to 0: APLL Feedback Divider Register (AFBDIV[31:24]). See the AFBDIV1 register description.

Register Name: AFBDIV5
Register Description: APLL Feedback Divider Register 5
Register Address: 10Ah

	Bit 7	Bit 6	Bit 5	Bit 4	Bit 3	Bit 2	Bit 1	Bit 0
Name				AFBDIV[39:32]				
Default	0	0	0	0	0	0	0	0

Bits 7 to 0: APLL Feedback Divider Register (AFBDIV[39:32]). See the AFBDIV1 register description.

Register Name: AFBDIV6
Register Description: APLL Feedback Divider Register 6
Register Address: 10Bh

	Bit 7	Bit 6	Bit 5	Bit 4	Bit 3	Bit 2	Bit 1	Bit 0
Name	—	—	—	—	—	—	AFBDIV[41:40]	
Default	0	0	0	0	0	0	0	0

Bits 7 to 0: APLL Feedback Divider Register (AFBDIV[41:40]). See the AFBDIV1 register description.

Register Name: AFBDEN1
Register Description: APLL Feedback Divider Denominator Register 1
Register Address: 10Ch

	Bit 7	Bit 6	Bit 5	Bit 4	Bit 3	Bit 2	Bit 1	Bit 0
Name				AFBDEN[7:0]				
Default	0	0	0	0	0	0	0	1

Bits 7 to 0: APLL Feedback Divider Denominator Register (AFBDEN[7:0]). The full 32-bit AFBDEN[31:0] field spans AFBDEN1 through AFBDEN4 registers. AFBDEN is an unsigned integer that specifies the denominator of the APLL's fractional feedback divide value. The value AFBDEN=0 is undefined. When AFBBP=0, AFBDEN must be set to 1. See section 5.7.2.

Register Name: AFBDEN2
Register Description: APLL Feedback Divider Denominator Register 2
Register Address: 10Dh

	Bit 7	Bit 6	Bit 5	Bit 4	Bit 3	Bit 2	Bit 1	Bit 0
Name				AFBDEN[15:8]				
Default	0	0	0	0	0	0	0	0

Bits 7 to 0: APLL Feedback Divider Denominator Register (AFBDEN[15:8]). See the AFBDEN1 register description.

Register Name: AFBDEN3
Register Description: APLL Feedback Divider Denominator Register 3
Register Address: 10Eh

	Bit 7	Bit 6	Bit 5	Bit 4	Bit 3	Bit 2	Bit 1	Bit 0
Name				AFBDEN[23:16]				
Default	0	0	0	0	0	0	0	0

Bits 7 to 0: APLL Feedback Divider Denominator Register (AFBDEN[23:16]). See the AFBDEN1 register description.

Register Name: AFBDEN4
Register Description: APLL Feedback Divider Denominator Register 4
Register Address: 10Fh

	Bit 7	Bit 6	Bit 5	Bit 4	Bit 3	Bit 2	Bit 1	Bit 0
Name				AFBDEN[31:24]				
Default	0	0	0	0	0	0	0	0

Bits 7 to 0: APLL Feedback Divider Denominator Register (AFBDEN[31:24]). See the AFBDEN1 register description.

Register Name: AFBREM1
Register Description: APLL Feedback Divider Remainder Register 1
Register Address: 110h

	Bit 7	Bit 6	Bit 5	Bit 4	Bit 3	Bit 2	Bit 1	Bit 0
Name				AFBREM[7:0]				
Default	0	0	0	0	0	0	0	0

Bits 7 to 0: APLL Feedback Divider Remainder Register (AFBREM[7:0]). The full 32-bit AFBDEN[31:0] field spans AFBREM1 through AFBREM4 registers. AFBREM is an unsigned integer that specifies the remainder of the APLL's fractional feedback divider value. When AFBBP=0, AFBREM must be set to 0. See section 5.7.2.

Register Name: AFBREM2
Register Description: APLL Feedback Divider Remainder Register 2
Register Address: 111h

	Bit 7	Bit 6	Bit 5	Bit 4	Bit 3	Bit 2	Bit 1	Bit 0
Name				AFBREM[15:8]				
Default	0	0	0	0	0	0	0	0

Bits 7 to 0: APLL Feedback Divider Remainder Register (AFBREM[15:8]). See the AFBREM1 register description.

Register Name: AFBREM3
Register Description: APLL Feedback Divider Remainder Register 3
Register Address: 112h

	Bit 7	Bit 6	Bit 5	Bit 4	Bit 3	Bit 2	Bit 1	Bit 0
Name				AFBREM[23:16]				
Default	0	0	0	0	0	0	0	0

Bits 7 to 0: APLL Feedback Divider Remainder Register (AFBREM[23:16]). See the AFBREM1 register description.

Register Name: AFBREM4
Register Description: APLL Feedback Divider Remainder Register 4
Register Address: 113h

	Bit 7	Bit 6	Bit 5	Bit 4	Bit 3	Bit 2	Bit 1	Bit 0
Name				AFBREM[31:24]				
Default	0	0	0	0	0	0	0	0

Bits 7 to 0: APLL Feedback Divider Remainder Register (AFBREM[31:24]). See the AFBREM1 register description.

Register Name:	AFBBP
Register Description:	APLL Feedback Divider Truncate Bit Position
Register Address:	114h

	Bit 7	Bit 6	Bit 5	Bit 4	Bit 3	Bit 2	Bit 1	Bit 0
Name	AFBBP[7:0]							
Default	0	0	0	0	0	0	0	0

Bits 7 to 0: APLL Feedback Divider Truncate Bit Position (AFBBP[7:0]). This unsigned integer specifies the number of fractional bits that are valid in the AFBDIV value. There are 33 fractional bits in AFBDIV. The value in this AFBBP field specifies 33 – number_of_valid_AFBDIV_fractional_bits. When AFBBP=0 all 33 AFBDIV fractional bits are valid. When AFBBP=9, the most significant 24 AFBDIV fractional bits are valid and the least significant 9 bits must be set to 0. This register field is only used when the feedback divider value is expressed in the form AFBDIV + AFBREM / AFBDEN. AFBBP values greater than 33 are invalid. When AFBBP=0, AFBREM must be set to 0 and AFBDEN must be set to 1. See section 5.7.2.

6.3.4 Output Clock Configuration Registers

Register Name:	OCxCR1
Register Description:	Output Clock x Configuration Register 1
Register Address:	OC1: 200h, OC2: 210h, OC3: 220h

	Bit 7	Bit 6	Bit 5	Bit 4	Bit 3	Bit 2	Bit 1	Bit 0
Name	PHEN	MSDIV[6:0]						
Default	0	0	0	0	0	0	0	0

Bit 7: Phase Adjust Enable (PHEN). This bit enables this output to participate in phase adjustment/alignment. See section 5.8.4.

     0 = Phase adjustment/alignment disabled for this output
     1 = Phase adjustment/alignment enabled for this output

Bits 6 to 0: Medium-Speed Divider Value (MSDIV[6:0]). This field specifies the setting for the output clock's medium-speed divider. The divisor is MSDIV+1. Note that if MSDIV is not set to 0 (bypass) then MSDIV must be set to a value that causes the output clock of the medium-speed divider to be 425MHz or less. When MSDIV=0, the medium-speed divider, phase adjust, low-speed divider, start/stop and output duty cycle adjustment circuits are bypassed and the high-frequency clock signal is sent directly to the output driver. See section 5.8.2.

Register Name: OCxCR2
Register Description: Output Clock x Configuration Register 2
Register Address: OC1: 201h, OC2: 211h, OC3: 221h

	Bit 7	Bit 6	Bit 5	Bit 4	Bit 3	Bit 2	Bit 1	Bit 0
Name	—	POL	DRIVE[1:0]		STOPDIS	OCSF[2:0]		
Default	0	0	0	0	0	0	0	0

Bit 6: Clock Path Polarity (POL). The clock path to the CML, HSTL and CMOS outputs is inverted when this bit set. This does not invert the LSDIV path to the CMOS OCxN pin if that path is enabled. See section 5.8.1.

Bits 5 to 4: CMOS/HSTL Output Drive Strength (DRIVE[1:0]). The CMOS/HSTL output drivers have four equal sections that can be enabled or disabled to achieve four different drive strengths from 1x to 4x. When the output power supply VDDOx is 3.3V or 2.5V, the user should start with 1x and only increase drive strength if the output is highly loaded and signal transition time is unacceptable. When VDDOx is 1.8V or 1.5V the user should start with 4x and only decrease drive strength if the output signal has unacceptable overshoot. See section 5.8.1.
      00 = 1x
      01 = 2x
      10 = 3x
      11 = 4x

Bit 3: Stop Disable (STOPDIS). This bit causes the output to become disabled (high impedance) while the output clock is stopped. See section 5.8.5.
      0 = Do not disable the output while stopped
      1 = Disable the output while stopped

Bits 2 to 0: Output Clock Signal Format (OCSF[2:0]). Note that OCEN.OCxEN=0 forces the output driver to be high-impedance regardless of the value of the OCSF register field. See section 5.8.1.
      000 = Disabled (high-impedance, low power mode)
      001 = CML, standard swing (V_{OD} =800mV$_{P-P}$ typical)
      010 = CML, narrow swing (V_{OD} =400mV$_{P-P}$ typical)
      011 = HSTL (Set OCxCR2.DRIVE=11 (4x) to meet JESD8-6)
      100 = Two CMOS: OCxP in phase with OCxN
      101 = One CMOS: OCxP high impedance, OCxN enabled
      110 = One CMOS: OCxP enabled, OCxN high impedance
      111 = Two CMOS: OCxP inverted vs. OCxN

Register Name: OCxCR3
Register Description: Output Clock x Configuration Register 3
Register Address: OC1: 202h, OC2: 212h, OC3: 222h

	Bit 7	Bit 6	Bit 5	Bit 4	Bit 3	Bit 2	Bit 1	Bit 0
Name	SRLSEN	DIVSEL	NEGLSD	LSSEL	—	—	—	LSDIV[24]
Default	0	0	0	0	0	0	0	0

Bit 7 Enable LSDIV Statuses (SRLSEN). This bit enables the OCxSR.LSCLK real-time status bit and its associated latched status bit OCxSR.LSCLKL.

    0 = LSCLK status bit is not enabled (low)
    1 = LSCLK status bit is enabled

Bit 6: High Speed Divider Select (DIVSEL). This bit selects which high-speed divider is the source of the clock for the output. See section 5.8.2.

    0 = HSDIV1
    1 = HSDIV2

Bit 5: OCxN Low Speed Divider (NEGLSD). This bit selects the source of the clock on the OCxN pin in CMOS mode. See section 5.8.2.

    0 = Same as OCxP
    1 = Output of the LSDIV divider

    Note: NEGLSD should only be set to one in two-CMOS mode (OCxCR2.OCSF=100 or 111) and when OCxCR2.POL=0.

Bit 4: LSDIV Select (LSSEL). This bit selects the source of the output clock. When the MSDIV divider is selected (LSSEL=0) the LSDIV divider output can be independently selected as the source for the OCxN pin (in CMOS output mode) or monitored by the OCxSR.LSCLK status bit. This bit is only valid when OCxCR1.MSDIV > 0. See section 5.8.2.

    0 = The output clock is sourced from the MSDIV divider.
    1 = The output clock is sourced from the LSDIV divider.

Bit 0: Low-Speed Divider Value (LSDIV[24]). See the OCxDIV1 register description.

Register Name: OCxDIV1
Register Description: Output Clock x Divider Register 1
Register Address: OC1: 203h, OC2: 213h, OC3: 223h

	Bit 7	Bit 6	Bit 5	Bit 4	Bit 3	Bit 2	Bit 1	Bit 0
Name				LSDIV[7:0]				
Default	0	0	0	0	0	0	0	0

Bits 7 to 0: Low-Speed Divider Value (LSDIV[7:0]). The full 25-bit LSDIV[24:0] field spans this register, OCxDIV2, OCxDIV3. and bit 0 of OCxCR3. LSDIV is an unsigned integer. The frequency of the clock from the medium-speed divider is divided by LSDIV+1. The OCxCR3.LSSEL and NEGLSD bits control when the output of the low-speed divider is present on the OCxP and OCxN output pins. OCxCR1.MSDIV must be > 0 for the low-speed divider to operate. See section 5.8.2.

Register Name: OCxDIV2
Register Description: Output Clock x Divider Register 2
Register Address: OC1: 204h, OC2: 214h, OC3: 224h

	Bit 7	Bit 6	Bit 5	Bit 4	Bit 3	Bit 2	Bit 1	Bit 0
Name				LSDIV[15:8]				
Default	0	0	0	0	0	0	0	0

Bits 7 to 0: Low-Speed Divider Value (LSDIV[15:8]). See the OCxDIV1 register description.

Register Name: OCxDIV3
Register Description: Output Clock x Divider Register 3
Register Address: OC1: 205h, OC2: 215h, OC3: 225h

	Bit 7	Bit 6	Bit 5	Bit 4	Bit 3	Bit 2	Bit 1	Bit 0
Name				LSDIV[23:16]				
Default	0	0	0	0	0	0	0	0

Bits 7 to 0: Low-Speed Divider Value (LSDIV[23:16]). See the OCxDIV1 register description.

Register Name: OCxDC
Register Description: Output Clock x Duty Cycle Register
Register Address: OC1: 206h, OC2: 216h, OC3: 226h

	Bit 7	Bit 6	Bit 5	Bit 4	Bit 3	Bit 2	Bit 1	Bit 0
Name				OCDC[7:0]				
Default	0	0	0	0	0	0	0	0

Bits 7 to 0: Output Clock Duty Cycle (OCDC[7:0]). This field controls the output clock signal duty cycle when MSDIV>0 and LSDIV>1. When OCDC = 0 the output clock is 50%. Otherwise the clock signal is a pulse with a width of OCDC number of MSDIV output clock periods. The range of OCDC can create pulse widths from 1 to 255 MSDIV output clock periods. When OCxCR2.POL=0, the pulse is high and the signal is low the remainder of the cycle. When POL=1, the pulse is low and the signal is high the remainder of the cycle. See section 5.8.3.

Note: Rev A devices require MSDIV>5.

Register Name:	OCxPH
Register Description:	Output Clock x Phase Adjust Register
Register Address:	OC1: 207h, OC2: 217h, OC3: 227h

	Bit 7	Bit 6	Bit 5	Bit 4	Bit 3	Bit 2	Bit 1	Bit 0
Name				PHADJ[7:0]				
Default	0	0	0	0	0	0	0	0

Bits 7 to 0: Phase Adjust Value (PHADJ[7:0]). When OCxCR1.PHEN=1, this field specifies the phase adjustment of the output clock during a phase adjustment event. When OCxCR1.PHEN=0, this field is ignored. The specified phase adjustment occurs once during a phase adjustment event. The format of the field is 2's-complement with the LSB being one half of an HSDIV output clock period. See section 5.8.4.

00000000 = 0.0 UI
00000001 = +0.5 UI
00000010 = +1.0 UI
00000011 = +1.5 UI
…
01111110 = +63.0 UI
01111111 = +63.5 UI
10000000 = -64.0 UI
10000001 = -63.5 UI
…
11111101 = -1.5 UI
11111110 = -1.0 UI
11111111 = -0.5 UI

Register Name:	OCxSTOP
Register Description:	Output Clock x Start Stop Register
Register Address:	OC1: 208h, OC2: 218h, OC3: 228h

	Bit 7	Bit 6	Bit 5	Bit 4	Bit 3	Bit 2	Bit 1	Bit 0
Name	STOP	—		SRC[3:0]				MODE[1:0]
Default	0	0	0	0	0	0	0	0

Bit 7: Output Clock Stop (STOP). When SRC=0000, this bit is used to stop the output clock high or low. The output stays stopped while this bit is high. See section 5.8.5.
0 = Do not stop the output clock
1 = Stop the output clock

Bits 5 to 2: Output Clock Stop Source (SRC[3:0]). This field specifies the source of the stop signal. See section 5.8.5.
0000 = STOP bit
0001 = The arming of a phase adjustment (signal stopped when PASR.ARMED is asserted; signal started when PASR.ADJL is asserted)
0010 to 0111 = {unused values}
1000 = GPIO0
1001 = GPIO1
1010 = GPIO2
1011 = GPIO3
1100 to 1111 = {unused values}

Bits 1 to 0: Output Clock Stop Mode (MODE[1:0]). This field selects the mode of the start-stop function. See section 5.8.5.

  00 = Never stop
  01 = Stop High: stop after rising edge of output clock, start after falling edge of output clock
  10 = Stop Low: stop after falling edge of output clock, start after rising edge of output clock
  11 = {unused value}

The following table shows which pin(s) stop high or low as specified above for each output signal format:

Signal Format	OCxCR2.OCSF	Pin that Stops As Specified
CML	001 or 010	OCxP
HSTL	011	OCxN
Two CMOS, OCxP in phase with OCxN	100	OCxP and OCxN
One CMOS, OCxN enabled	101	OCxN
One CMOS, OCxP enabled	110	OCxP
Two CMOS, OCxP inverted vs. OCxN	111	OCxN

Notes:
1. The highest priority condition for an output is when it is stopped and OCxCR2.STOPDIS=1. When this condition occurs both OCxP and OCxN become high-impedance regardless of the state of the control bits mentioned below.
2. When the output is not stopped or when OCxCR2.STOPDIS=0, OCxCR3.NEGLSD=1 causes the OCxN pin to follow the output clock of the low-speed divider uninverted regardless of the signal format, regardless of the state of OCxCR2.POL, and regardless of whether the output is stopped.
3. When the above situations do not apply, OCxCR2.POL=1 changes Stop High to Stop Low and vice versa.

6.3.5 Input Clock Configuration Registers

Register Name: ICxCR1
Register Description: Input Clock x Configuration Register 1
Register Address: IC1: 300h, IC2: 320h, IC3: 340h

	Bit 7	Bit 6	Bit 5	Bit 4	Bit 3	Bit 2	Bit 1	Bit 0
Name	—	POL	—	—	—	—	HSDIV[1:0]	
Default	0	0	0	0	0	0	0	0

Bit 6: Locking Polarity (POL). This field specifies which input clock signal edge the APLL will lock to. See section 5.7.1.
> 0 = Rising edge
> 1 = Falling edge

Bits 1 to 0: Input Clock High-Speed Divider (HSDIV[1:0]). This field specifies the divide value for the input clock high-speed divider. See section 5.7.1.
> 00 = Divide by 1
> 01 = Divide by 2
> 10 = Divide by 4
> 11 = Divide by 8

6.3.6 NCO/Spread-Spectrum Configuration Registers

Register Name: NCSSCR1
Register Description: NCO/SS Configuration Register 1
Register Address: 40Bh

	Bit 7	Bit 6	Bit 5	Bit 4	Bit 3	Bit 2	Bit 1	Bit 0
Name	—	—	—	—	MODE[3:0]			
Default	0	0	0	0	0	0	0	0

Bits 3 to 0: NCO/SS Mode (MODE[3:0]). This field selects the operational mode of the NCO/SS block. See section 5.6.
> 0000: Reset
> 0001: NCO
> 0010: Spread-spectrum
> all other values are invalid

Register Name: DFREQZ1
Register Description: Digital Frequency Tuning Word Register 1
Register Address: 420h

	Bit 7	Bit 6	Bit 5	Bit 4	Bit 3	Bit 2	Bit 1	Bit 0
Name				FREQZ[7:0]				
Default	0	0	0	0	0	0	0	0

Bits 7 to 0: Digital Frequency Tuning Word (FREQZ[7:0]). The full 40-bit DFREQZ[39:0] field spans this register and the DFREQZ2 to DFREQZ5 registers and is a multi-register field (see section 6.1.3). This unsigned coefficient is the frequency tuning word value that sets the frequency the NCO/SS block generates in NCO mode. It is also the base frequency to which the NCO/SS adds a dynamic offset during spread spectrum mode. The nominal value of this field is set by the evaluation software. In NCO mode, system software can change this value by any fraction (less than 1 ppb to multiple ppm) to cause a fractional change in the channel's output frequency. See section 5.6.1.

Register Name: DFREQZ2
Register Description: Digital Frequency Tuning Word Register 2
Register Address: 421h

	Bit 7	Bit 6	Bit 5	Bit 4	Bit 3	Bit 2	Bit 1	Bit 0
Name				FREQZ[15:8]				
Default	0	0	0	0	0	0	0	0

Bits 7 to 0: Digital Frequency Tuning Word (FREQZ[15:8]). See the DFREQZ1 register description.

Register Name: DFREQZ3
Register Description: Digital Frequency Tuning Word Register 3
Register Address: 422h

	Bit 7	Bit 6	Bit 5	Bit 4	Bit 3	Bit 2	Bit 1	Bit 0
Name				FREQZ[23:16]				
Default	0	0	0	0	0	0	0	0

Bits 7 to 0: Digital Frequency Tuning Word (FREQZ[23:16]). See the DFREQZ1 register description.

Register Name: DFREQZ4
Register Description: Digital Frequency Tuning Word Register 4
Register Address: 423h

	Bit 7	Bit 6	Bit 5	Bit 4	Bit 3	Bit 2	Bit 1	Bit 0
Name				FREQZ[31:24]				
Default	0	0	0	0	0	0	0	0

Bits 7 to 0: Digital Frequency Tuning Word (FREQZ[31:24]). See the DFREQZ1 register description.

Register Name: DFREQZ5
Register Description: Digital Frequency Tuning Word Register 5
Register Address: 424h

	Bit 7	Bit 6	Bit 5	Bit 4	Bit 3	Bit 2	Bit 1	Bit 0
Name				FREQZ[39:32]				
Default	0	0	0	0	0	0	0	0

Bits 7 to 0: Digital Frequency Tuning Word (FREQZ[39:32]). See the DFREQZ1 register description.

7. Electrical Characteristics

Absolute Maximum Ratings

Parameter	Symbol	Min.	Max.	Units
Supply voltage, nominal 1.8V	VDD18	-0.3	1.98	V
Supply voltage, nominal 3.3V	VDD33	-0.3	3.63	V
Supply voltage, VDDOx (x=1,2,3)	VDDOx	-0.3	3.63	V
Voltage on XA, any ICxP/N, any OCxP/N pin	VANAPIN	-0.3	3.63	V
Voltage on any digital I/O pin	VDIGPIN	-0.3	5.5	V
Storage Temperature Range	T_{ST}	-55	+125	°C

* Exceeding these values may cause permanent damage. Functional operation under these conditions is not implied.
* Voltages are with respect to ground (VSS) unless otherwise stated.

Note 1: The typical values listed in the tables of Section 7 are not production tested.
Note 2: Specifications to -40°C and 85°C are guaranteed by design or characterization and not production tested.

Table 5 - Recommended DC Operating Conditions

Parameter	Symbol	Min.	Typ.	Max.	Units
Supply voltage, nominal 1.8V	VDD18	1.71	1.8	1.89	V
Supply voltage, nominal 3.3V	VDD33	3.135	3.3	3.465	V
Supply voltage, VDDOx (x=1,2,3)	VDDOx	1.425 1.71 2.375 3.135	1.5 1.8 2.5 3.3	1.575 1.89 2.625 3.465	V
Operating temperature	T_A	-40		+85	°C

Table 6 - Electrical Characteristics: Supply Currents

Characteristics	Symbol	Min.	Typ.[1]	Max	Units	Notes
Total power, one channel, one input and one nomal-swing CML output enabled, XA/XB disabled	P_{DISS}		0.57		W	
Total current **per channel**, all 1.8V supply pins, NCO and SSM modes	I_{DD18}		242	297	mA	Note 2
Total current **per channel**, all 3.3V supply pins, NCO and SSM modes	I_{DD33}		184	225	mA	Note 2
Total current **per channel**, all 1.8V supply pins, APLL-only mode	I_{DD18}		208	251	mA	Note 2
Total current **per channel**, all 3.3V supply pins, APLL-only mode	I_{DD33}		168	206	mA	Note 2
3.3V supply current change from enabling or disabling a crystal driver circuit	$\Delta I_{DD33XTAL}$		16		mA	
3.3V supply current change from enabling or disabling a high-speed divider 2	$\Delta I_{DD33HSD}$		20		mA	
1.8V supply current from enabling/disabling one output's mux and dividers using OCEN.OCxEN	$\Delta I_{DD18ODIV}$		28		mA	
1.8V supply current change from enabling or disabling a CML output, standard swing	$\Delta I_{DD18CML}$		10		mA	
3.3V supply current change from enabling or disabling a CML output, standard swing	$\Delta I_{DD33CML}$		17		mA	
1.8V supply current change from enabling or disabling a CML output, narrow swing	$\Delta I_{DD18CMLN}$		10		mA	
3.3V supply current change from enabling or disabling a CML output, narrow swing	$\Delta I_{DD33CMLN}$		9		mA	
1.8V supply current change from enabling or disabling a pair of single-ended outputs	$\Delta I_{DD18CMOS}$		2		mA	
VDDOx supply current change from enabling or disabling a pair of single-ended outputs	$\Delta I_{DD33CMOS}$		16		mA	Note 3

Characteristics	Symbol	Min.	Typ.[1]	Max	Units	Notes
1.8V supply current change from enabling or disabling an input clock	ΔI_{DD18IN}		13		mA	

Note 1: Typical values measured at 1.80V and 3.30V supply voltages and 25°C ambient temperature.

Note 2: Max I_{DD} measurements made with all blocks in the channel enabled, 650MHz signals on IC1 and IC2 inputs, 187.5MHz signal on IC3, VCO frequency of 3750MHz, both HSDIV enabled and dividing by 6, all 3 MSDIV dividing by 2, all 3 LSDIV dividing by 2, and all 3 outputs enabled as full-swing CML outputs driving 156.25MHz signals. NCO or SSM modes: 114.285M XO master clock on XA. APLL-only mode: Crystal driver and doubler off, guaranteed by design.

Note 3: VDDOx=3.3V, 1x drive strength, f_O=250MHz, 2pF load

Table 7 - Electrical Characteristics: Non-clock CMOS Pins

Characteristics	Symbol	Min.	Typ.	Max.	Units	Notes
Input high voltage, SCL and SDA	V_{IH}	0.7 x VDD33			V	
Input low voltage, SCL and SDA	V_{IL}			0.3 x VDD33	V	
Input high voltage, all other digital inputs	V_{IH}	2.0			V	
Input low voltage, all other digital inputs	V_{IL}			0.8	V	
Input leakage current, RSTN pin	I_{ILPU}	-85		10	µA	Note 1
Input leakage current, GPIO3/IC3P pin	I_{ILGP3}	-20		20	µA	Note 1
Input leakage current, all other digital inputs	I_{IL}	-10		10	µA	Note 1
Input capacitance	C_{IN}		3	10	pF	
Input capacitance, SCL/SCLK, SDA/MOSI	C_{IN}		3	11	pF	
Input hysteresis, SCL and SDA in I²C Bus Mode		0.05* VDD33			mV	
Output leakage (when high impedance)	I_{LO}	-10		10	µA	Note 1
Output high voltage	V_{OH}	2.4			V	I_O = -3.0mA
Output low voltage	V_{OL}			0.4	V	I_O = 3.0mA

Note 1: 0V < V_{IN} < VDD33 for all of the channel's other digital inputs.

Note 2: V_{OH} does not apply for SCL and SDA in I²C interface mode since they are open drain.

Table 8 - Electrical Characteristics: XA Clock Input

This table covers the case when there is no external crystal connected and an external oscillator or clock signal is connected to the XA pin.

Characteristics	Symbol	Min.	Typ.	Max.	Units	Notes
Input high voltage, XA	V_{IH}	1.2			V	
Input low voltage, XA	V_{IL}			0.8	V	
Input frequency on XA pin, master clock for NCO mode, clock doubler disabled	f_{IN}	80		130	MHz	
Input frequency on XA pin, internally doubled to make master clock for NCO mode	f_{IN}	40		65	MHz	
Input frequency on XA pin, master clock for Spread Spectrum mode, clock doubler disabled	f_{IN}	80		130	MHz	
Input frequency on XA pin, internally doubled to make master clock for Spread Spectrum mode	f_{IN}	55		65	MHz	
Input frequency, XA pin to APLL mux	f_{IN}	9.72		156.25	MHz	
Input frequency, XA pin to HSDIV2 bypass mux	f_{IN}			156.25	MHz	
Input leakage current	IIL	-10		10	µA	
Input duty cycle		40		60	%	

Table 9 - Electrical Characteristics: Clock Inputs, ICxP/N

Characteristics	Symbol	Min.	Typ.	Max.	Units	Notes
Input voltage tolerance (each pin, single-ended)	V_{TOL}	0		VDD33	V	Note 1
Input differential voltage	$|V_{ID}|$	0.1		1.4	V	Note 2
Input DC bias voltage (internally biased)	V_{CMI}		1.3		V	
Input frequency, ICx pins	f_{IN}	9.72		1250	MHz	Differential
		9.72		300	MHz	Single-ended
Minimum input clock high, low time, $f_{IN} \leq 250MHz$	t_H, t_L		smaller of 3ns or 0.3 x 1 / f_{IN}		ns	Note 5
Minimum input clock high, low time, $f_{IN} > 250MHz$	t_H, t_L	0.4			ns	Note 6
Input resistance, single-ended to VDD18, ICxP or ICxN	$R_{INVDD18}$		50		kΩ	
Input resistance, single-ended to VSS, ICxP or ICxN	R_{INVSS}		80		kΩ	

Note 1: The device can tolerate voltages as specified in V_{TOL} w.r.t. VSS on its ICxP and ICxN pins without being damaged. For differential input signals, proper operation of the input circuitry is only guaranteed when the other specifications in this table, including $|V_{ID}|$, are met.

Note 2: For inputs IC1P/N and IC2P/N $V_{ID}=V_{ICxP} - V_{ICxN}$. For input IC3P, $V_{ID}=V_{IC3P} - V_{CMI}$. The max V_{ID} spec only applies when a differential signal is applied on ICxP/N; it does not apply when a single-ended signal is applied on ICxP.

Note 3: **Differential signals.** The differential inputs can easily be interfaced to neighboring ICs driving LVDS, LVPECL, CML, HCSL, HSTL or other differential signal formats using a few external passive components. In general, Microsemi recommends terminating the signal with the termination/load recommended in the neighboring component's data sheet and then AC-coupling the signal into the ICxP/ICxN pins. See Figure 16 for details. To connect a differential signal to IC3, AC-couple one side of the signal to IC3P and AC-couple the other side to VSS. For DC-coupling, treat the input as 1.8V CML.

Note 4: **Single-ended signals** can be connected to ICxP pins. Signals with amplitude greater than 2.5V must be DC-coupled. For signals with amplitudes less than 2.5V Microsemi recommends AC-coupling but DC-coupling can also be used. When a single-ended signal is connected to ICxP, ICxN should be connected to a capacitor (0.1μF or 0.01μF) to VSS.

Note 5: If MCR1.MCSEL1=1 then IC1 is the NCO/SS block's master clock source and therefore the duty cycle spec in Table 8 applies to IC1 rather than the t_H, t_L spec in this table.

Note 6: The input high-speed divider must be used to divide the frequency by 2 or more.
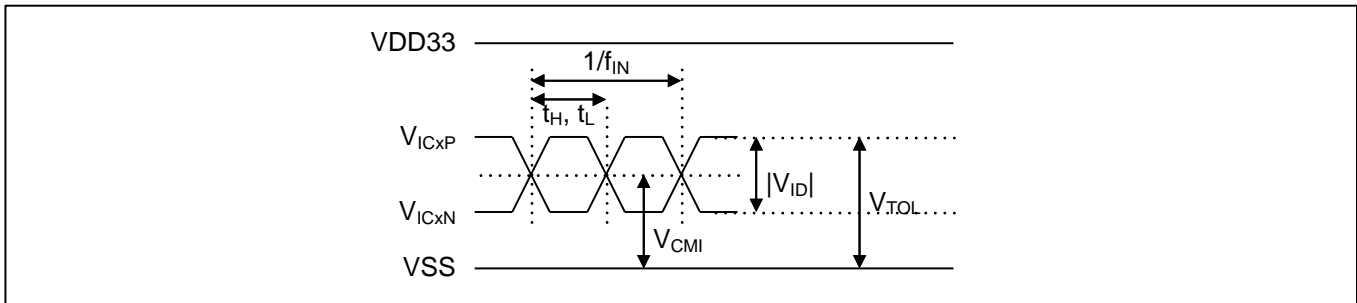

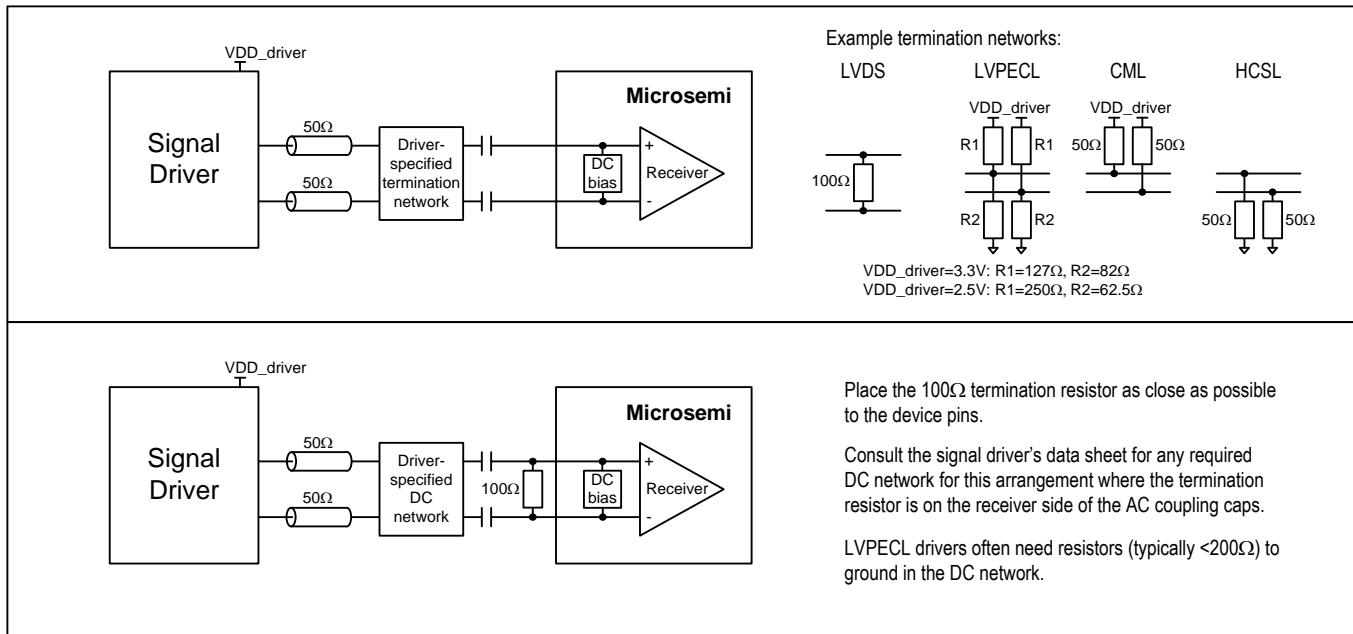**Figure 15 - Electrical Characteristics: Clock Inputs**

Figure 16 - Example External Components for Differential Input Signals

Table 10 - Electrical Characteristics: CML Clock Outputs

VODDx = 3.3V±5% for CML operation.

Characteristics	Symbol	Min.	Typ.	Max.	Units	Notes
Output frequency	f_{OCML}			1035	MHz	
Output frequency from medium-speed divider	$f_{OCML,MSDIV}$			425	MHz	
Output high voltage, single-ended, OCxP or OCxN	$V_{OH,S}$		VDDOx − 0.2		V	Standard Swing (OCxCR2.OCSF=1), AC coupled to 50Ω termination
Output low voltage, single-ended, OCxP or OCxN	$V_{OL,S}$		VDDOx − 0.6		V	
Output common mode voltage	$V_{CM,S}$		VDDOx − 0.4		V	
Output differential voltage	$|V_{OD,S}|$	320	400	500	mV	
Output differential voltage, peak-to-peak	$|V_{OD,S,PP}|$	640	800	1000	mV$_{P-P}$	
Output high voltage, single-ended, OCxP or OCxN	$V_{OH,N}$		VDDOx − 0.1		V	Narrow Swing (half the power) (OCxCR2.OCSF=2), AC coupled to 50Ω termination
Output low voltage, single-ended, OCxP or OCxN	$V_{OL,N}$		VDDOx − 0.3		V	
Output common mode voltage	$V_{CM,N}$		VDDOx − 0.2		V	
Output differential voltage	$|V_{OD,N}|$	160	200	250	mV	
Output differential voltage, peak-to-peak	$|V_{OD,N,PP}|$	320	400	500	mV$_{P-P}$	
Difference in Magnitude of Differential Voltage for Complementary States	V_{DOS}			50	mV	
Output Rise/Fall Time	t_R, t_F		150		ps	20%-80%
Output Duty Cycle		45	50	55	%	Notes 2
Output Duty Cycle		40		60	%	Notes 3
Output Impedance	R_{OUT}		50		Ω	Single Ended, to VDDOx
Mismatch in a pair	ΔR_{OUT}			10	%	

Note 1: The differential CML outputs can easily be interfaced to LVDS, LVPECL, CML and other differential inputs on neighboring ICs using a few external passive components. See Figure 18 for details.
Note 2: For all HSDIV, MSDIV and LSDIV combinations other than those specified in Note 3.

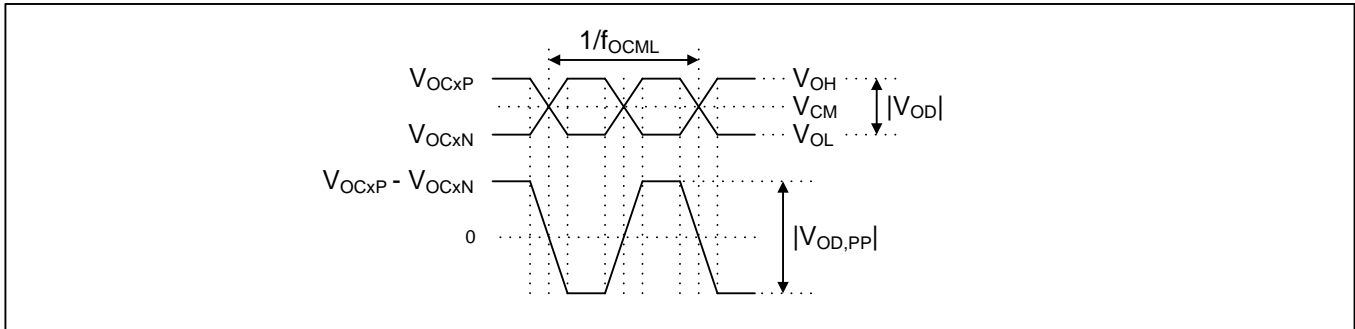**Note 3:** For the case when APLLCR1.HSDIV specifies a half divide and OCxCR1.MSDIV=0 and OCxDIV=0.

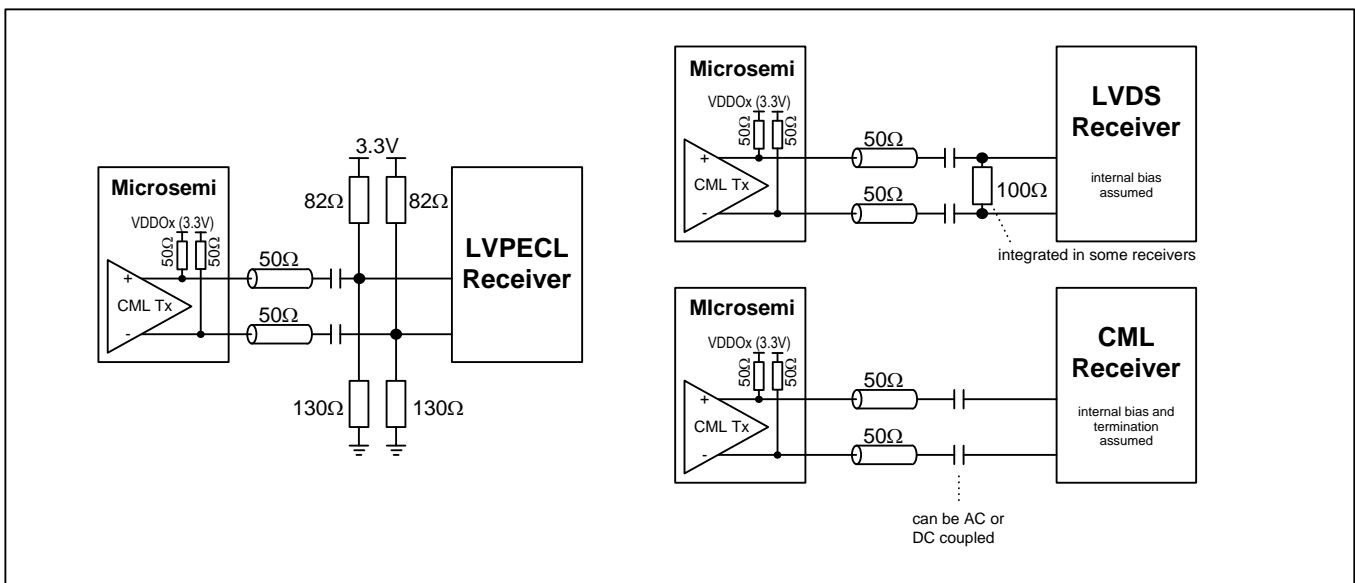**Figure 17 - Electrical Characteristics: CML Clock Outputs**

Figure 18 – Example External Components for CML Output Signals

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Table 11 - Electrical Characteristics: CMOS and HSTL (Class I) Clock Outputs

Characteristics	Symbol	Min.	Typ.	Max.	Units	Notes
Output frequency	f_{OCMOS}	<<1Hz		250	MHz	Note 1
Output high voltage	V_{OH}	VDDOx −0.4		VDDOx	V	Notes 2, 3
Output low voltage	V_{OL}	0		0.4	V	Notes 2, 3
Output rise/fall time, VCCOx=1.8V, OCxCR2.DRIVE=4x			0.4		ns	2pF load
Output rise/fall time, VCCOx=1.8V, OCxCR2.DRIVE=4x			1.2		ns	15pF load
Output rise/fall time, VCCOx=3.3V, OCxCR2.DRIVE=1x	t_R, t_F		0.7		ns	2pF load
Output rise/fall time, VCCOx=3.3V, OCxCR2.DRIVE=1x			2.2		ns	15pF load
Output duty cycle		45	50	55	%	Note 4
Output duty cycle		42	50	58	%	Notes 5, 6
Output duty cycle, OCxNEG single-ended			50		%	Note 5
Output duty cycle, OCxPOS single-ended			46		%	Note 5
Output current when output disabled			10		µA	OCxCR2.OCSF=0

Note 1: Minimum output frequency is a function of VCO frequency and output divider values and is guaranteed by design.

Note 2: For HSTL Class I, V_{OH} and V_{OL} apply for both unterminated loads and for symmetrically terminated loads, i.e. 50Ω to VDDOx/2.

Note 3: For VDDOx=3.3V and OCxCR2.DRIVE=1x, I_O=4mA. For VDDOx=1.5V and OCxCR2.DRIVE=4x, I_O=8mA.

Note 4: Output clock frequency ≤ 160MHz or VDDOx ≥ 1.8V.

Note 5: Output clock frequency > 160MHz and VDDOx < 1.8V.

Note 6: Measured differentially.

Interfacing to HCSL Components

Outputs in HSTL mode with VDDOx=1.5V or VDDOx=1.8V can provide an HCSL signal (V_{OH} typ. 0.75V) to a neighboring component when configured as shown in Figure 19 below. For VDDOx=1.5V the value of R_S should be set to 30Ω and OCxCR2.DRIVE should be set to 4x. For VDDOx=1.8V the value of R_S should be set to 20Ω and OCxCR2.DRIVE should be set to 2x.
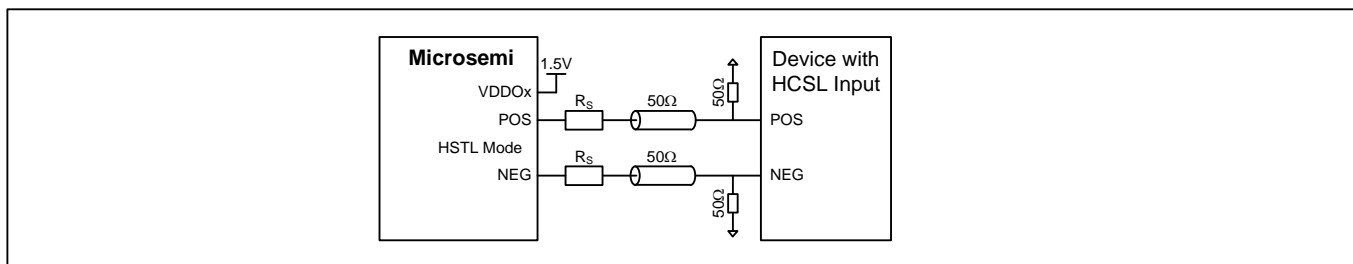

Figure 19 – Example External Components for HCSL Output Signals

Table 12 - Electrical Characteristics: APLL Frequencies

Characteristics	Symbol	Min.	Typ.	Max.	Units	Notes
APLL VCO frequency range	f_{VCO}	3715		4180	MHz	
APLL PFD input frequency	t_{PFD}	9.72		156.25	MHz	

Table 13 - Electrical Characteristics: Jitter Specifications

Characteristics	Min.	Typ.	Max.	Units	Notes
Output Phase Jitter, 622.08MHz		0.16	0.225	ps RMS	Notes 1, 2
Output Phase Jitter, 625MHz, (1.875MHz-20MHz)		0.06		ps RMS	Note 4
Output Period Jitter		8		ps pk-pk	N=10000, Note 5
Output Half-Period Jitter		14		ps pk-pk	N=10000, Note 5
Output Cycle-to-Cycle Jitter		7.5		ps pk	N=10000, Note 5
Jitter Transfer Bandwidth		600		kHz	Note 3
Bypass Path Additive Jitter, 100MHz in/out		0.18		ps RMS	12kHz-20MHz

Note 1: Jitter calculated from integrated phase noise from 12kHz to 20MHz.

Note 2: Tested with 155.52MHz XO (Vectron VCC1) connected to IC1, APLL VCO frequency 3732.48MHz, HSDIV1=6, OC1 frequency 622.08MHz, other channel in reset.

Note 3: APLL bandwidth and damping factor can be field configured over a limited range. Contact the factory for details.

Note 4: With 50MHz crystal doubled as APLL input. Jitter calculated from integrated phase noise from 1.875MHz to 20MHz.

Note 5: Outputs from a half-divide (e.g. 4.5) in the high-speed divider followed by only an odd divide in the medium-speed divider can have higher jitter values. Example: 100MHz from VCO=3750MHz, HSDIV1=7.5, MSDIV=5 has typical period jitter of 16ps, typical cycle-to-cycle jitter of 15ps and typical half-period jitter of 58ps.

Table 14 - Electrical Characteristics: Typical Output Jitter Performance

Output Frequency	Output Jitter, ps RMS 125MHz XO Reference[1]	Output Jitter, ps RMS 50MHz Crystal Reference[2]
625MHz	0.155	0.185
156.25MHz	0.18	0.21
125MHz	0.19	0.21
25MHz CMOS	0.26	0.28
622.08MHz	0.25	0.27
155.52MHz	0.27	0.315
622.08MHz * 255/237	0.26	0.29
155.52MHz * 255/237	0.275	0.30
614.4MHz	0.25	0.28
153.6MHz	0.28	0.32

Note 1: APLL locked to external 125MHz XO (Vectron VCC1-1535-125M000).

Note 2: APLL locked to external 50MHz crystal (TXC 7M50070021), internal doubler enabled when multiplication is fractional.

Note 3: All signals are differential unless otherwise stated. Jitter is integrated 12kHz to 5MHz for 25MHz output frequency and 12kHz to 20MHz for all other output frequencies. Other channel in reset.

Table 15 - Electrical Characteristics: Typical Input-to-Output Clock Delay

Mode	Delay, Input Clock Edge to Output Clock Edge
All Modes	Non-deterministic but constant as long as the APLL remains locked and output clock phases are not adjusted as described in section 5.8.4.1.

Table 16 - Electrical Characteristics: Typical Output-to-Output Clock Delay

Mode	Delay, Output Clock Edge to Output Clock Edge
All Modes	<100ps Requires phase adjustment and phase alignment capability described in section 5.8.4.

Table 17 - Electrical Characteristics: SPI Slave Interface Timing, Device Registers

Characteristics (Notes 1 to 3)	Symbol	Min.	Typ.	Max.	Units	Notes
SCLK frequency	f_{BUS}			10	MHz	
SCLK cycle time	t_{CYC}	100			ns	
CSN setup to first SCLK edge	t_{SUC}	50			ns	
CSN hold time after last SCLK edge	t_{HDC}	50			ns	
CSN high time	t_{CSH}	50			ns	
SCLK high time	t_{CLKH}	40			ns	
SCLK low time	t_{CLKL}	40			ns	
MOSI data setup time	t_{SUI}	10			ns	
MOSI data hold time	t_{HDI}	10			ns	
MISO enable time from SCLK edge	t_{EN}	0			ns	
MISO disable time from CSN high	t_{DIS}			80	ns	
MISO data valid time	t_{DV}			40	ns	
MISO data hold time from SCLK edge	t_{HDO}	0			ns	
CSN, MOSI input rise time, fall time	t_R, t_F			10	ns	

Note 1: All timing is specified with 100pF load on all SPI pins.

Note 2: All parameters in this table are guaranteed by design or characterization.
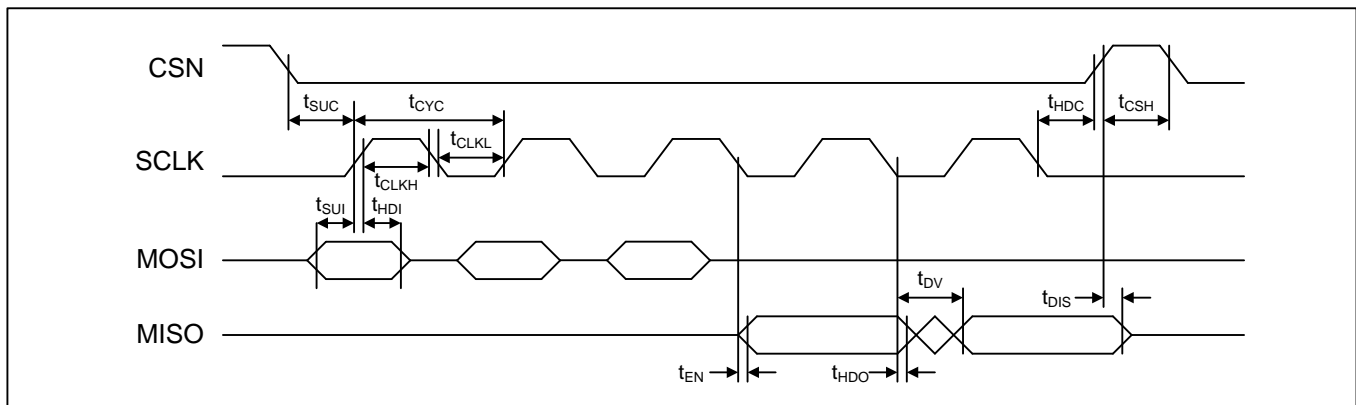
Note 3: See timing diagram in Figure 20.

Figure 20 - SPI Slave Interface Timing

Table 18 - Electrical Characteristics: SPI Slave Interface Timing, Internal EEPROM (ZL30245 Only)

Characteristics (Notes 1 to 4)	Symbol	Min.	Typ.	Max.	Units	Notes
SCLK frequency	f_{BUS}			10	MHz	
SCLK cycle time	t_{CYC}	100			ns	
CSN setup to first SCLK edge	t_{SUC}	50			ns	
CSN hold time after last SCLK edge	t_{HDC}	51			ns	
CSN high time	t_{CSH}	51			ns	
SCLK high time	t_{CLKH}	41			ns	
SCLK low time	t_{CLKL}	41			ns	
MOSI data setup time	t_{SUI}	11			ns	
MOSI data hold time	t_{HDI}	11			ns	
MISO enable time from SCLK edge	t_{EN}	0			ns	
MISO disable time from CSN high	t_{DIS}			90	ns	
MISO data valid time	t_{DV}			60	ns	
MISO data hold time from SCLK edge	t_{HDO}	0			ns	
CSN, MOSI input rise time, fall time	t_R, t_F			10	ns	

Note 1: This timing applies (a) when EESEL=1 and (b) in direct EEPROM write mode (see section 5.13.2).

Note 2: All timing is specified with 100pF load on all SPI pins.

Note 3: All parameters in this table are guaranteed by design or characterization.

Note 4: See timing diagram in Figure 20.

Table 19 - Electrical Characteristics: SPI Master Interface Timing (ZL30244 Only)

Characteristics (Notes 1 to 3)	Symbol	Min.	Typ.	Max.	Units	Notes
SCLK output frequency	f_{BUS}			5	MHz	
SCLK output cycle time	t_{CYC}	200			ns	
SCLK output duty cycle	t_{CLKH}/ t_{CYC}	45	50	55	%	
CSN output setup to first SCLK rising edge	t_{SUC}	200			ns	
CSN output hold after last SCLK falling edge	t_{HDC}	200			ns	
CSN output high time	t_{CSH}	200			ns	
MISO input setup time to SCLK rising edge	t_{SU}	15			ns	
MISO input hold time from SCLK rising edge	t_{HD}	5			ns	
MOSI output valid from SCLK falling edge	t_{DV}			10	ns	
SCLK, CSN, MOSI output rise time, fall time	t_R, t_F			15	ns	
MISO input rise time, fall time	t_R, t_F			10	ns	

Note 1: All timing is specified with 100pF load on all SPI pins.

Note 2: All parameters in this table are guaranteed by design or characterization.
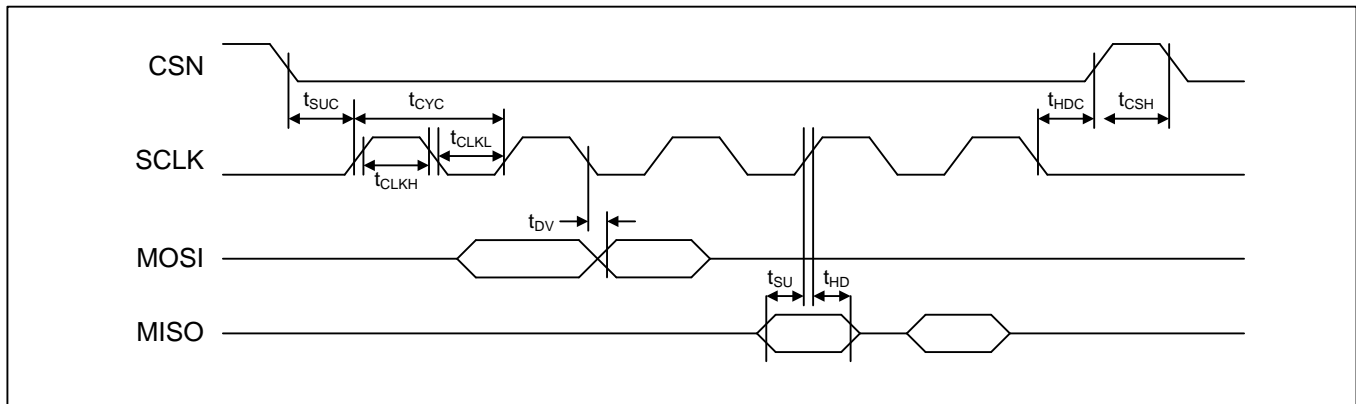
Note 3: See timing diagram in Figure 21.

Figure 21 - SPI Master Interface Timing

Table 20 - Electrical Characteristics: I^{2}C Slave Interface Timing

Characteristics	Symbol	Min.	Typ.	Max.	Units	Notes
SCL clock frequency	f_{SCL}			400	kHz	Note 1
Hold time, START condition	$t_{HD:STA}$	0.6			µs	
Low time, SCL	t_{LOW}	1.3			µs	
High time, SCL	t_{HIGH}	0.6			µs	
Setup time, START condition	$t_{SU:STA}$	0.6			µs	
Data hold time	$t_{HD:DAT}$	0		0.9	µs	Notes 2 and 3
Data setup time	$t_{SU:DAT}$	100			ns	
Rise time	t_R				ns	Note 4
Fall time	t_F	20 + 0.1C_b		300	ns	C_b is cap. of one bus line
Setup time, STOP condition	$t_{SU:STO}$	0.6			µs	
Bus free time between STOP/START	t_{BUF}	1.3			µs	
Pulse width of spikes which must be suppressed by the input filter	t_{SP}	0		50	ns	

Note 1: The timing parameters in this table are specifically for 400kbps Fast Mode. Fast Mode devices are downward-compatible with 100kbps Standard Mode I^{2}C bus timing. All parameters in this table are guaranteed by design or characterization. All values referred to V_{IHmin} and V_{ILmax} levels (see Table 7).

Note 2: The device internally provides a hold time of at least 300ns for the SDA signal (referred to the V_{IHmin} of the SCL signal) to bridge the undefined region of the falling edge of SCL. Other devices must provide this hold time as well per the I^{2}C specification.

Note 3: The I^{2}C specification indicates that the maximum $t_{HD:DAT}$ spec only has to be met if the device does not stretch the low period (t_{LOW}) of the SCL signal. The device does not stretch the low period of the SCL signal.

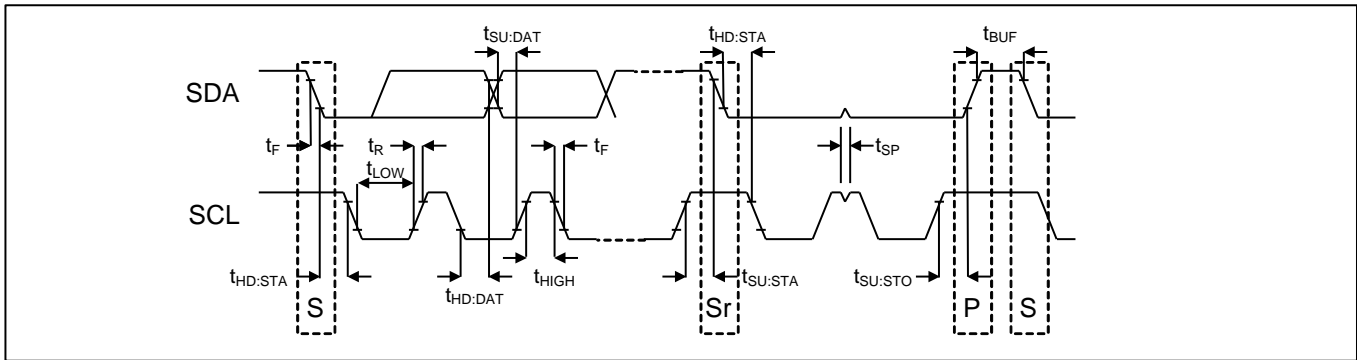**Note 4:** Determined by choice of pull-up resistor.

Figure 22 - I^{2}C Slave Interface Timing

8. Package and Thermal Information

8.1   Package Top Mark Format

Figure 23 - Non-customized Device Top Mark

Table 21 – Package Top Mark Legend

Line	Characters	Description
2	$X_1 - X_{14}$	Part Number
3	YY	Last Two Digits of the Year of Encapsulation
3	WW	Work Week of Assembly
3	A	Assembly Location Code
3	ZZ	Assembly Lot Sequence
3	F	Fab Code
3	R	Product Revision Code
3	e4	Denotes RoHS Level of Package
4	CCID	Custom Programming Identification Code only present for devices with EEPROM memory custom-programmed by Microsemi
4	WW	Work Week of Custom Programming only present for devices with EEPROM memory custom-programmed by Microsemi

8.2 Thermal Specifications

Table 22 - 5x10mm LGA Package Thermal Properties

PARAMETER	SYMBOL	CONDITIONS	VALUE	UNITS
Maximum Ambient Temperature	T_A		85	°C
Maximum Junction Temperature	T_{JMAX}		125	°C
Junction to Ambient Thermal Resistance (Note 1)	θ_{JA}	still air	15.68	°C/W
		1m/s airflow	13.22	
		2.5m/s airflow	12.32	
Junction to Board Thermal Resistance	θ_{JB}		6.87	°C/W
Junction to Case Thermal Resistance	θ_{JC}		4.28	°C/W
Junction to Pad Thermal Resistance (Note 2)	θ_{JP}	still air	3.99	°C/W
Junction to Top-Center Thermal Characterization Parameter	ψ_{JT}	still air	1.18	°C/W
		1m/s airflow	1.29	°C/W
		2.5m/s airflow	1.38	°C/W

Note 1: Theta-JA (θ_{JA}) is the thermal resistance from junction to ambient when the package is mounted on an 8-layer standard test board and dissipating maximum power.

Note 2: Theta-JP (θ_{JP}) is the thermal resistance from junction to the exposed pads on the bottom of the package.

Note 3: For all numbers in the table, each exposed pad is connected to the ground plane with a 3x3 array of thermal vias; via diameter 0.2mm.

Thermal aspects must be carefully considered when all of the following are true:
- The device does not receive any airflow.
- The estimated worst-case ambient temperature at the device is 85°C or more.
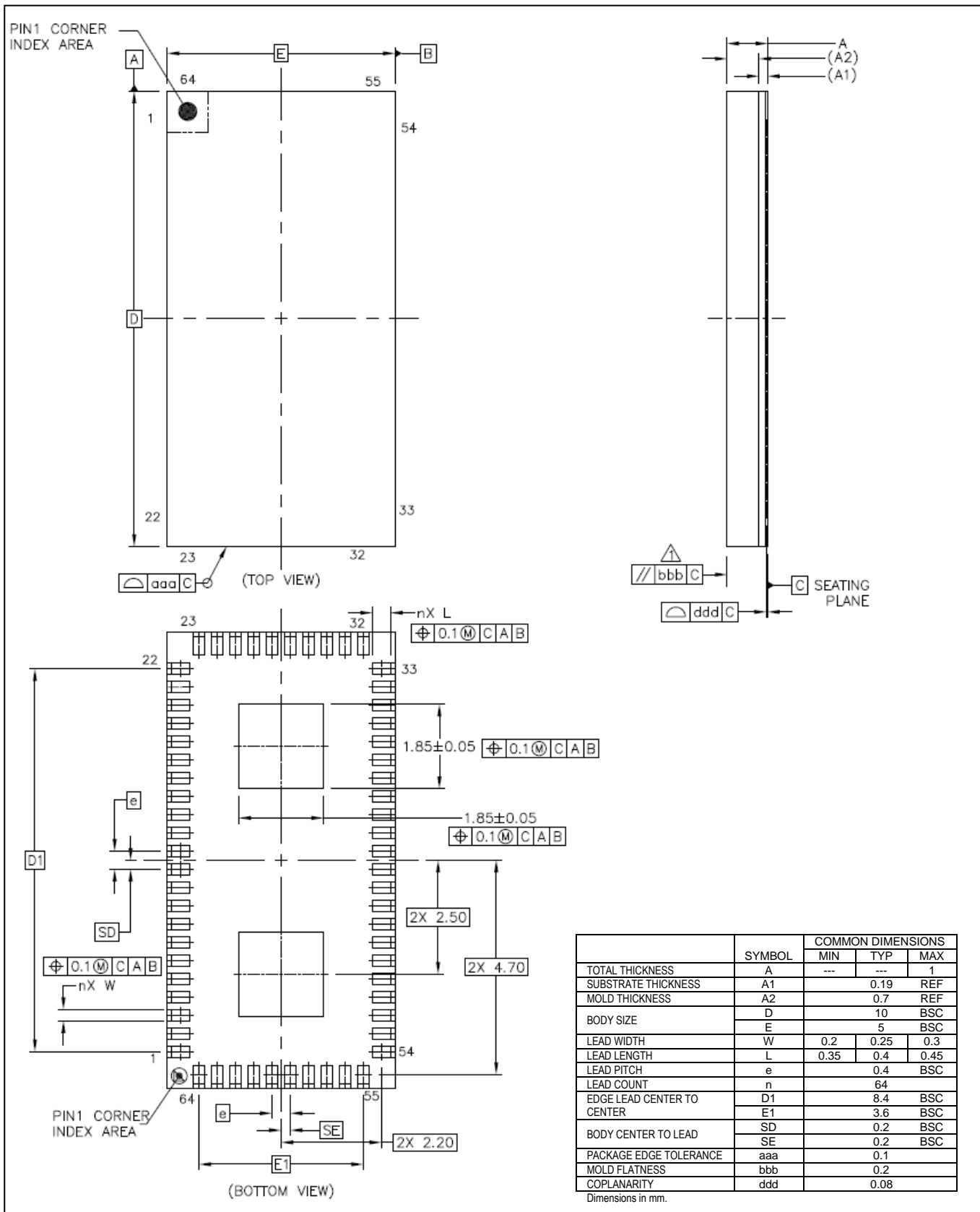- All or nearly all blocks in both channels are enabled.

When all blocks in both channels are enabled the worst-case power consumption over process and voltage is 1.338W per channel or 2.676W total. However, the still-air θ_{JA} spec in Table 22 indicates that to maintain a junction temperature of less than 125°C, given an 85°C ambient temperature, power dissipation must be kept below 2.551W. The calculation is (125°C - 85°C) / 15.68°C/W = 2.551W.

In many applications this difference can easily be addressed. For example, changing four of the six outputs from normal-swing CML to half-swing CML reduces power consumption below the 2.551W limit set by the package.

In addition, it should be kept in mind that the foregoing discussion is based on the θ_{JA} spec, which is the simplest of all thermal models and has the built-in assumption that the device is mounted on an 8-layer standard test board. Most customer applications have PCBs that have more layers and are much larger than the standard test board. Thus calculations using θ_{JA} are often too conservative for customer applications. Thermal modeling of the actual system board using the other thermal parameters in the table is encouraged.

The evaluation software displays typical and maximum power consumption for any device configuration.

9. Mechanical Drawing

		COMMON DIMENSIONS		
	SYMBOL	MIN	TYP	MAX
TOTAL THICKNESS	A	---	---	1
SUBSTRATE THICKNESS	A1		0.19	REF
MOLD THICKNESS	A2		0.7	REF
BODY SIZE	D		10	BSC
	E		5	BSC
LEAD WIDTH	W	0.2	0.25	0.3
LEAD LENGTH	L	0.35	0.4	0.45
LEAD PITCH	e		0.4	BSC
LEAD COUNT	n		64	
EDGE LEAD CENTER TO CENTER	D1		8.4	BSC
	E1		3.6	BSC
BODY CENTER TO LEAD	SD		0.2	BSC
	SE		0.2	BSC
PACKAGE EDGE TOLERANCE	aaa		0.1	
MOLD FLATNESS	bbb		0.2	
COPLANARITY	ddd		0.08	

Dimensions in mm.

10. Acronyms and Abbreviations

APLL	analog phase locked loop
CML	current mode logic
GbE	gigabit Ethernet
HCSL	high-speed current steering logic
HSTL	high-speed transceiver logic
I/O	input/output
LVDS	low-voltage differential signal
LVPECL	low-voltage positive emitter-coupled logic
PFD	phase/frequency detector
PLL	phase locked loop
ppb	parts per billion
ppm	parts per million
pk-pk	peak-to-peak
RMS	root-mean-square
RO	read-only
R/W	read/write
SS or SSM	spread spectrum modulation
TCXO	temperature-compensated crystal oscillator
UI	unit interval
UI_{PP} or UI_{P-P}	unit interval, peak to peak
XO	crystal oscillator

11. Data Sheet Revision History

Revision	Description
07-Apr-2015	First version released to customers
10-Aug-2015	In Table 1 corrected pin number of XB_A from 56 to 57.
31-Aug-2015	In Table 11 deleted note 2 and renumbered notes 3 to 7 as 2 to 6.
16-Sep-2015	Removed "preliminary" designation.
21-Apr-2016	Added Note 3 to Table 22. In Table 9 changed t_H, t_L specs for f_{IN} > 250MHz from 0.4/ f_{IN} typical to 0.4ns min and added Note 6. Edited section 5.11 to reduce RSTN assertion time for all but one specific situation. Added a note to the MCR1.RST description to indicate the need to clear the MCSEL, MCSEL1 and ROSCD bits before setting the RST bit. In section 5.9.3 in the Read Transactions paragraph added a note describing the case where the I²C write is separated from the I²C read by other transactions. In section 5.4.1 added a sentence about connecting one oscillator to both channels' XA pins.

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